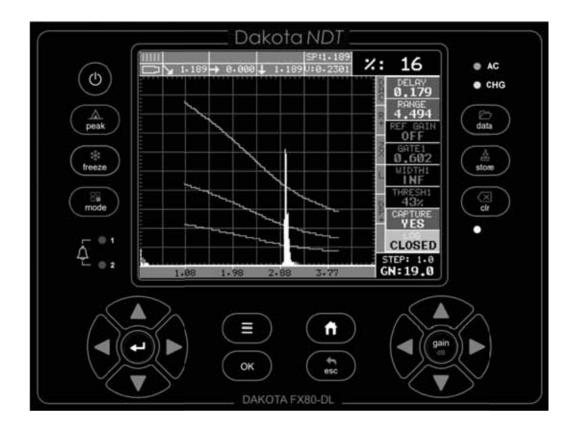
OPERATION MANUAL

Dakota NDT

FX80 Series

Ultrasonic Flaw Detectors (Manual 2 of 2)



P/N P-250-0007

Rev 1.00, January 2024

CONTENTS

CHAPTER ONE INTRODUCTION1	
1.1 GENERAL DISCLAIMER	1
1.2 ELECTRICAL WARNING	
CHAPTER TWO QUICK START GUIDE	
2.1 GAUGE TYPE	3
2.2 BASIC FLAW SETUP REFERENCE	3
2.3 TOP & SUBMENU REFERENCE	4
2.4 LOADING THE DEFAULT SETUP	5
CHAPTER THREE KEYBOARD, MENU, & CONNECTOR REFERENCE7	
3.1 MENU KEY (OPERATION & SUB MENUS)	7
3.2 PROBE – MENU	
3.3 CAL – MENU	
3.4 DISP (DISPLAY) – MENU	10
3.5 TUNE – MENU	
3.6 GT1 – MENU	12
3.7 GT2 – Menu	12
3.8 TRIG – MENU	13
3.9 AWS – MENU	14
3.10 TCG – MENU	14
3.11 DAC – MENU	15
3.12 DGS – MENU	15
3.13 SETUP – MENU	16
3.14 DATA – MENU	17
3.15 UTIL (UTILITIES) – MENU	18
3.16 XFER (TRANSFER) – MENU	18
3.17 CLR (CLEAR) KEY	19
3.18 HOME (MEASUREMENT MODE) KEY	19
3.19 OK KEY	19
3.20 ESC KEY	20
3.21 WHEEL KEYS	20
3.22 ENTER KEY	20
3.23 MULTI MODE KEY	20
3.24 DATA KEY	20
3.25 STORE KEY	20
3.26 PEAK KEY	21
3.27 FREEZE KEY	21

3.28 ON/OFF KEY	21
3.29 FX80 OVERVIEW	21
3.30 NAVIGATING THE HOT MENUS	23
3.31 TOP & BOTTOM END CAPS	24
CHAPTER FOUR SETTING UP FOR MEASUREMENT	:7
4.1 SELECTING DISPLAY VIEW	27
4.2 ADJUSTING THE DISPLAY	28
4.3 GAIN	-
4.4 GATES	
4.5 ACTIVATING AND SETTING UP A GATE	35
CHAPTER FIVE CALIBRATION 4	0
5.1 SETTING UP FOR CALIBRATION	40
5.2 STRAIGHT BEAM CALIBRATION	
5.3 ANGLE BEAM CALIBRATION	53
CHAPTER SIX TRIGONOMETRY MODE5	7
6.1 INTRODUCTION TO TRIG	57
6.2 Additional Comments	57
6.3 SETUP TRIGONOMETRY MODE	58
CHAPTER SEVEN AWS – WELD INSPECTION6	4
7.1 INTRODUCTION TO AWS	64
7.2 Additional Comments	64
7.3 SETUP AWS	64
CHAPTER EIGHT DISTANCE AMPLITUDE CORRECTION (DAC)7	'1
8.1 INTRODUCTION TO DAC	71
8.2 Additional Comments	71
8.3 CREATING A DAC CURVE	72
CHAPTER NINE TIME CORRECTED GAIN (TCG)7	'8
9.1 INTRODUCTION TO TCG	78
9.2 Additional Comments	78
9.3 CREATING A TCG CURVE	78
CHAPTER TEN DISTANCE, GAIN, SIZE (DGS)8	4
10.1 INTRODUCTION TO DGS (AVG)	
10.2 DGS DIAGRAM	
10.3 ESTIMATING EFFECTIVE DIAMETER	85
10.4 PARAMETER DEFINITIONS DGS(AVG)	87
10.5 ATTENUATION PARAMETERS	88

10.6 CREATING A DGS CURVE	89
CHAPTER ELEVEN ADDITIONAL FEATURES OF THE FX8096	
11.1 Pulse Width	96
11.2 PULSE REPETITION FREQUENCY (PRF)	97
11.3 DAMPING	98
11.4 PULSER VOLTAGE	100
11.5 MATERIAL VELOCITY CHARTS	101
11.6 MATERIAL VELOCITY	102
11.7 ZERO	104
11.8 BRIGHTNESS	106
11.9 COLOR SCHEME	107
11.10 DIM	108
11.11 GRAPHICS OPTION (LOOK & FEEL)	109
11.12 DETECT MARK	111
11.13 WAVE AVERAGING	112
11.14 PERSISTENCE	113
11.15 GRATICULE (A-SCAN BACKGROUND)	114
11.16 AUTO INTERFACE GATE – IMMERSION TESTING (IM)	116
11.17 FILTERS (WIDE & NARROW BANDS)	119
11.18 GAIN STEP SIZE	120
11.19 DETECT MODES	121
11.20 POLARITY	123
11.21 COMPARE	125
11.22 ANALOG OUTPUT	127
11.23 SERIAL OUTPUT	128
11.24 DIGITIZER	129
11.25 KEY CLICK	130
11.26 DATE & TIME	131
11.27 Show Date & Time	133
11.28 FREEZE & CAPTURE	134
11.29 CAPTURE VIEWER	135
11.30 PEAK HOLD	137
11.31 FREEZE WAVEFORM	138

CHAPTER TWELVE DATA STORAGE – SETUP, EDIT, & VIEW FILES.....140

12.1 INTRODUCTION TO GRID AND SEQUENTIAL FILE FORMATS	140
12.2 CREATING A NEW GRID OR SEQUENTIAL LOG (FILE)	141
12.3 STORING A WAVEFORM	152
12.4 VIEWING STORED READINGS	153
12.5 DELETING GRIDS (FILES)	155
12.6 Editing a Grid (File)	157

12.7 CHANGING THE ACTIVE FILE - OPEN	
12.8 CLOSING AN ACTIVE FILE - CLOSE	162

CHAPTER THIRTEEN SETUPS – CREATE, STORE, EDIT, & RECALL 164

3.1 INTRODUCTION TO SETUPS1	164
3.2 OPENING A SETUP	164
3.3 SAVING A SETUP1	166
3.4 DELETING A SAVED SETUP	169
3.5 USING THE DEFAULT SETUP1	171
3.6 SELECTING A LANGUAGE1	173

CHAPTER FOURTEEN SOFTWARE, FILE TRANSFER, & UPGRADES.... 174

14.1 COMPUTER SYSTEM REQUIREMENTS	174
USB TYPE1 TO TYPE 2 CABLE	
14.2 INSTALLING DAKVIEW	174
14.3 COMMUNICATING WITH FX80	174
14.4 USING THE XFER MENU (<i>FX80</i>)	
14.5 SELECTING STORAGE DEVICE	175
14.6 COPYING FILES (SETUPS, DATA, & SCREENSHOTS)	
14.7 UPGRADING THE FX80	179
APPENDIX A - VELOCITY TABLE 1	80
APPENDIX B - SETUP LIBRARY 1	82

CHAPTER ONE INTRODUCTION

The Dakota NDT model *FX80* is both, an ultrasonic flaw detector, as well as an ultrasonic A/B Scan thickness scope, in a single unit. It's a combination of both our *CMX Series*, as well as our new *FX80* flaw detector series. Why is this advantageous? Thickness gauge are specifically setup to very accurately measure thickness, locate pits, flaws and blind surface corrosion. All the linearity tables, correction curves for various types of longitudinal transducers and features are built with dimensional thickness as its primary focus. Flaw detectors are designed to detect, size, position, and differentiate between flaw types in various materials and welded joints. A flaw detector must be fast, in terms of its sample and screen refresh rate, as inspectors are generally scanning the surface of a part or test specimen at a relatively high speed, rather than looking for the thickness at a specific point or location. While flaw detectors can also measure material thickness with reasonable accuracy, they are not designed with precision thickness as their primary focus.

The *FX80* combines the two types of gauges into one powerful and full featured instrument, that's equipped with a number of comprehensive toolkits to provide the user the arsenal necessary to address a number of common field applications. In and effort to avoid complexity issues and differential between gauges types, this manual focuses only on the flaw detector portion of the *FX80*.

Dakota NDT maintains a customer support resource in order to assist users with questions or difficulties not covered in this manual. Customer support may be reached at any of the following:

Dakota NDT
1500 Green Hills Road, #107
Scotts Valley, CA 95066 USA
Telephone: (831) 431-9722
Facsimile: (831) 431-9723
www.dakotandt.com

1.1 General Disclaimer

The manual should be read and understood prior to using the *FX80*. This operating manual provides the user with all the general information necessary to use and operate the features of the *FX80*. However, this manual is not a certified NDT training course, nor is it intended to be one. Ultrasonic training for sound wave theory, flaw detection and interpretation of defects is highly recommended, and will be required by most companies and contract services. Contact the local NDT society in your area to inquire about training available in your locality.

1.2 Electrical Warning

The *FX80* series gauges contain high voltage pulsers. It's recommended that the gauge be powered off prior to connecting or disconnecting your transducer, to avoid damaging the instrument.

CHAPTER TWO QUICK START GUIDE

This section will cover a basic quick start guide to initially get up and running with the *FX80* for demonstration purposes only. However, in order to use the gauge and features for actual applications, a thorough review of this manual is recommended.

2.1 Gauge Type

GAUGE TYPE	
THICKNESS GAUGE	
FLAW DETECTOR	
SELECT GAUGE FUNCTION	
OK ESC	

Power up the *FX80*, by pressing the on/off key located in the bottom right corner of the keypad. During initial boot up, a flash screen and lights will be displayed, followed by a **GAUGE TYPE** selection screen. Since this manual will focus on the

flaw detector portion of the *FX80*, use the I arrow keys to select "flaw detector", followed by pressing the K key start the *FX80* in flaw mode. If this is the first time the gauge has been used, a general startup configuration will automatically be loaded and the *FX80* is ready for general inspections. If this is not the first time the gauge has been used, and the user would like to reload the basic default setup parameters, refer to section 13.5 for further info.

Note: The default setup should only be considered as a basic setup. Proper calibration and parameter settings should be done prior to an actual inspection.

2.2 Basic Flaw Setup Reference

PRB	CAL	DISP	TUNE	GT1
Type: Single	Matl: Steel 1020	View: +Rect	Filters: Wide	Alarm: On
Pulse: Thin	Matl 1pt: Uncal	Delay: 0.000	Gain: 65	Gate1: 0.484
Max PRF: 66	Matl 2pt: Uncal	Range: 5.011	Detect Mode: Z-Cross	Thresh1: 40%
Damping: 600	Velocity: .2320	Units: inches		Width1: INF
Pulser Volt: 200	Zero: 0.0	Brightness: 15		Detect: Above

The following table lists all the settings for the basic flaw setup:

Color: Green 1	Polarity: Pos
Dim: Off	
Rect Wave: Filled	
Detect Mark: None	

Note: The following features are set to off: GT2, TRIG, AWS, TCG, DAC, DGS.

2.3 Top & Submenu Reference

The following table is a quick menu reference guide. The *FX80* has 15 top level menu titles, and multiple submenu items as illustrated below. The *FX80* also has 9 'hot menu' subsets of the same menu structure. These are the most commonly adjusted submenu items from each of the top level menus. They can be quickly

accessed from the main measurement screen by pressing the $^{>}$

arrow

and

and

keys multiple times using the left button wheel, and pressing the

arrow keys on the left button wheel to select the appropriate submenu item. Refer to Chapter Three for additional definitions and information on the keypad

1 st Main Hot Menu	
Additional Hot Menus	
FX-81 Only	ľ

Note: Gate1 & Box have been added to multiple Hot Menus for the purpose of quick adjustment.

PRB	CAL	DISP	TUNE	GT1	GT2	TRIG	AWS
TYPE	MAT	VIEW	FILTERS	ALARM	ALARM	TRIG	AWS
PULSE	MATL 1PT	DELAY	GAIN	DETECT	DETECT	THICKNESS	SET REF GAIN
MAX PRF	MATL 2PT	RANGE	GAIN STEP	GATE1	GATE2	ANGLE	SHOW CURVE
DAMPING	VELOCITY	STEP	DETECT MODE	GATE1 WIDTH	GATE2 WIDTH	X-OFFSET	% SCRN HEIGHT
PULSER VOLTAGE	ZERO	UNITS		THRESHOLD1	THRESHOLD2	CSC O.D.	
		BRIGHTNESS		POLARITY1	POLARITY1	LEGS	
		COLORS					
		DIM					
		RECT WAVE					
		DETECT MARK					
		WAVE AVERAGING					
		PERSISTENCE					

Start >>

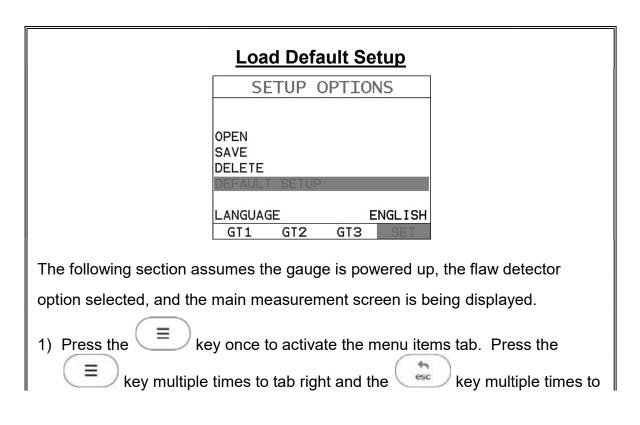
and menu items.

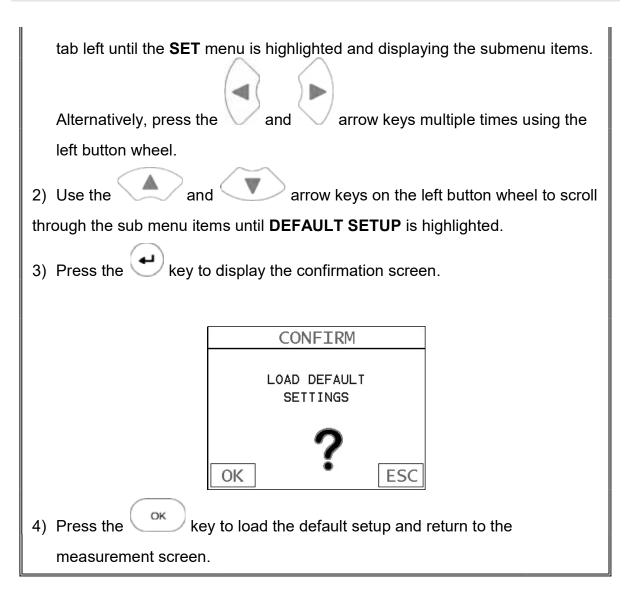
GRATICULE		
GIATICOLL		

>> End						
TCG	DAC	DGS	SET	DATA	UTIL	XFER
TCG	DAC	DGS	OPEN	NEW	COMPARE	BACKUP SETUPS
DRAW	DRAW	REF GAIN	SAVE	EDIT	ANALOG OUTPUT	COPY DATA
CURVE	HOME	TRIGGER CURVE	DELETE ONE FILE	OPEN	SERIAL OUTPUT	COPY SCREENS
% SCRN HEIGHT	CURVE	EFF PROBE DIAMETER	DEFAULT SETUP	CLOSE	DIGITIZER	UPGRADE GAUGE
	TRIGGER	PROBE FREQUENCY	LANGUAGE	DELETE ONE FILE	SET DATE	CAPTURE TO FILE
	DPOLARITY	CURVE SIZE (ERS)		DELETE ALL DATA	SHOW DATE	CAPTURE VIEWER
	FIT	ATTENUATION			KEY CLICK	STORAGE
		DELAY VELOCITY			GAUGE	ABOUT
		REFERENCE TYPE				

2.4 Loading the Default Setup

If the *FX80* has previously been used, the basic default settings can be reloaded at any time, as outlined below:





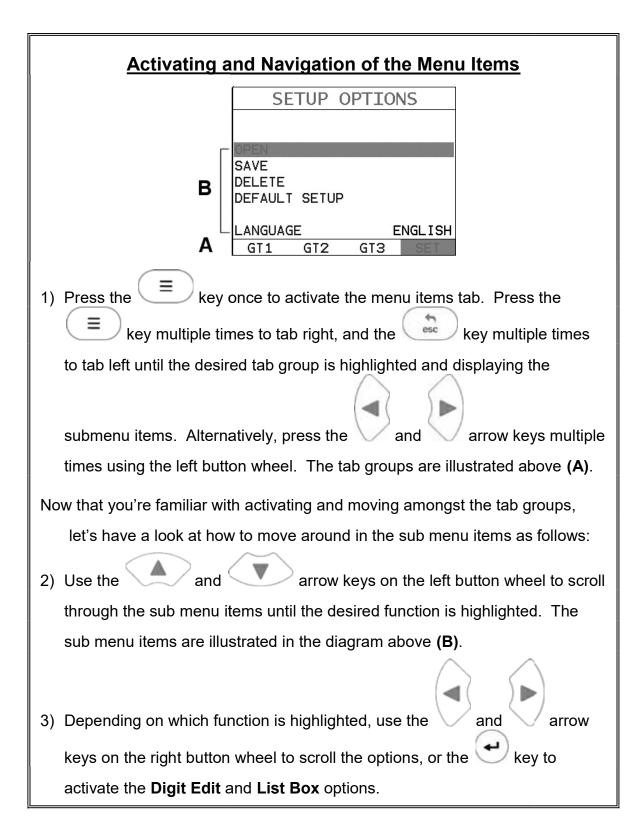
CHAPTER THREE KEYBOARD, MENU, & CONNECTOR REFERENCE



3.1 Menu Key (Operation & Sub Menus)

The **Menu** key activates the primary menu structure containing 15 menu tab groups. These tab groups then contain sub menu items, or functions. The sub menu items have been organized in the tab groups according to how closely they are related to the individual tab group names. Let's first get familiar with how to move around in these tabs before continuing on to the sub menu functions. This procedure is outlined below:

Ξ



The sections to follow will provide the user with an explanation of the sub menu functions:

	SETUP	PROB	E	
TYPE			SINGLE	
PULSE		THIN		
MAX PR	F		250	
DAMPIN	G		600	
PULS VOLT			200	
PRB	CAL	DISP	TUNE	

3.2 Probe – Menu

<u>TYPE:</u> Enables the user to select the type of transducer being used, either Single or Dual.

PULSE: The *FX80* has an adjustable pulse width for both high penetration and resolution applications. The pulse width refers to the duration of time the pulser is on. The options are **Spike**, **Thin**, and **Wide**. Refer to page 96 for a further explanation. *The FX-81* has a special tone burst style pulser with options Spike, Thin, Wide, HV Spike, HV Thin, HV Wide, TB 10MHz, TB 5MHz, TB 2MHz, and TB 1MHz. Refer to page 96 for a further explanation.

MAX PRF: This feature controls the pulse repetition frequency of the *FX80*. The maximum frequency is 333 Hz. However, the *FX80* will automatically adjust the PRF according to what the current delay and range settings have been adjusted to. Larger the range, the slower the repetition frequency will automatically be set for.

DAMPING: The ability to control the amplifiers output impedance to match the impedance of the transducer, and optimize overall transducer performance. Adjustable at: 50, 100, 300, 600, 1500 ohms. Refer to page 98 for further info.

PULSER VOLT: The *FX80* has an adjustable pulser voltage: 100, 150, and 200 volts. Refer to page 100 for a further explanation. The *FX-81* has a special tone burst pulser: 100, 150, 200, 300, 400 volts. Refer to page 100 for a further explanation.

CALI	BRATE	2.
~		
MAT		CUSTOM
MATL 1PT		1.000
MATL 2PT		5.000
VELOCITY		0.2328
ZERO		0.2
PRB CAL	DISP	TUNE

3.3 CAL – Menu

<u>MAT</u>: Select the material velocity from a chart of basic material types when a known sample thickness, or material velocity cannot be obtained.

MATL 1PT: Performs a single point calibration. This calibration option is used in conjunction with the MATL 2PT option for the calibration process. Refer to page 40 for further info.

MATL 2PT: Performs a two-point calibration. This option allows the user to automatically calculate the velocity by entering a second known sample thickness. Refer to page 40 for further info.

VELOCITY: Function to calibrate the *FX80* by setting the velocity to a known material velocity. Refer to page 102 for further info.

<u>ZERO</u>: Used to zero the transducer and calibrate the screen. The **FX80** is zeroed in much the same way that a mechanical micrometer is zeroed. If the **FX80** is not zeroed correctly, all of the measurements made using the *FX80* may be in error by some fixed value. Refer to the section on page 40, for further info.

SET	DISPLAY	SET DISP	'LAY
VIEW	+RECT	BRIGHTNESS	15
DELAY	0.179	COLORS	GREEN 2
RANGE	4.494	DIM	240 SEC
UNITS	IN	RECT WAVE	FILLED
BRIGHTNESS	15	DETECT MARK	DOTS
COLORS	GREEN 2	WAVE AVERGING	0FF
DIM	240 SEC		
	<more></more>	<hore></hore>	
PRB C/	L DISP TUNE	PRB CAL DI	SP TUNE

3.4 DISP (display) – Menu

<u>VIEW:</u> Selectable RF, +RECT, -RECT, RECTFW views. Refer to page 27 for further info.

DELAY: Provides the user the ability to change the start position of the A-SCAN views. Refer to page 28 for further info.

<u>RANGE:</u> Provides the user the ability to change the overall range/depth of the viewable measurement area. It functions a lot like a zoom on a camera. Refer to page 28 for further info.

<u>STEP</u>: When scrolling a range or value using the arrow keys, it can be done using the 'coarse' or 'fine' setting options for large or small adjustments.

<u>UNITS</u>: Toggle between English or Metric units. The readout will change from inches to millimeters.

BRIGHTNESS: TFT high speed color display. An arbitrary scale of 1-20 has been implemented, with the brightest setting at 20. Refer to page 106 for further info.

<u>COLORS</u>: Provides the user with a variety of different color schemes to select from. There are two schemes for each main color option. Refer to page 107 for further info.

<u>DIM</u>: Allows the user to conserve battery life by diming the display after idle for a specific amount of time – OFF, 30, 60, 90, 120 seconds. Once dimmed, a single press of any key will restore the screen brightness. Refer to page 108 for further info.

<u>RECT WAVE:</u> Provides the user an outlined or filled view option when the display setting is in RECT (rectified) wave mode only. Refer to page 109 for further info.

A

DETECT MARK: Selectable graphics option for the point of detection on the waveform: Line, Box, Dots, None. Offers the user a graphics preference on how they prefer to view the detection on the waveform.

WAVE AVERAGING: The *FX-81* is equipped with wave averaging to eliminate noise for a clear waveform image. Not recommended for high speed scanning. Refer to page 112 for further info.

PERSISTENCE: The *FX-81* is equipped with wave averaging to eliminate noise for a clear waveform image. Not recommended for high speed scanning. Refer to page 112 for further info.

<u>GRATICULE</u>: Selectable graphics option for the A-Scan background (grid/segments) used as references to depth/thickness versus amplitude. The options are: Point, Line, Dots, Mix. Offers the user a graphics preference on how they prefer to view the A-Scan waveform area. Refer to page 114 for further info.

TUNE SIGNAL		TUNE	SIGNAL
		MEASURE MOD	E P-E
FILTER	WIDE	FILTER	10MHZ
GAIN	60.0	GAIN	60.0
GAIN STEP	1.0	GAIN STEP	1.0
DETECT	Z-CR0SS	DETECT	PEAK
PRB CAL	DISP TUNE	PRB CAL	DISP TUNE

3.5 TUNE – Menu

MEASURE MODE: This menu item is only included in our *FX-81*. Toggles a variety of measurement modes for different application requirements: Currently pulse echo (P-E) and Immersion (IM) for water path correction. Refer to page 116 for further info.

FILTERS: The *FX80 Series* have both a wide band frequency range of 1.8 to 19 MHz (-3dB), as well as narrow band filter options at; 2, 5 & 10 MHz. The *FX-81* includes two additional filters at 0.5 kHz and 15 MHz. Refer to page 112 for further info.

<u>GAIN</u>: The *FX80* has a 0-110dB gain range with 2dB resolution. This feature is used to increase/decrease the strength or amplitude of the signal. Similar to turning the volume up or down on a stereo receiver. Refer to page 31 for further info.

GAIN STEP: This feature allows the user to control the increment step size of the

gain. Once the step size is set, each time the for button is pressed on the right button wheel, the gain is incremented or decremented by the gain step setting. Refer to page 31 for further info.

DETECT MODE: The *FX80* is equipped with optional detection modes; FLANK, or Z-CROSS (zero crossing). This option allows the user to decide where the detection is acquired on the waveform echo. Refer to page 121 for further info.

	GATE	ONE	
ALARM :	L		ON
DETECT			ABOVE
GATE 1			0.483
GATE1 4	IDTH		INF
THRESHO	DLD 1		40%
POLARI	Y 1	PO	SITIVE
GT1	GT2	TRIG	AWS

3.6 GT1 – Menu

ALARM1: Toggles the alarm function of gate 1; on, off, audible. The audible feature sounds a beeper when the waveform breaks the threshold level either above or below depending on the current DETECT setting. Refer to page 34 for further info.

DETECT: Enables the user to set the alarm detection to occur either above or below the gates threshold level. Refer to page 34 for further info.

<u>GATE1</u>: Gates allow the user to view a specific inspection/measurement range, or specific regions of the waveform, while ignoring others. In order to detect on a waveform echo, and display the amplitude as a percentage of full screen height, the echo must be inside the boundaries of the gate settings. The **GATE1** feature adjusts where the gate begins, according to the depth/thickness. Refer to page 34 for further info.

<u>GATE1 WIDTH</u>: This feature allows the user to set the overall width of the gate, in terms of distance, from the **GATE1** setting. Refer to page 34 for further info.

THRESHOLD1: Enables the user to set the sensitivity level of Gate1 to a calibrated screen height percentage. The threshold level will act as a starting point for the alarm trigger, and is directly associated with the **DETECT** setting outlined above. Refer to page 34 for further info.

POLARITY1: The gates can be set to detect on either the positive or negative polarity, or stroke, of the half or full wave cycle. It should be noted that if the **VIEW** is set to positive, and the gate negative, the *FX80* will not display an amplitude percentage of full screen height. Refer to page 34 for further info.

-		
GATE	TWO	
ALARM 2		ON
DETECT		ABOVE
GATE 2		0.483
GATE2 WIDTH	INF	
THRESHOLD 2	29%	
POLARITY 2	PC	SITIVE
GT1 GT2	TRIG	AWS

3.7 GT2 – Menu

ALARM2: Toggles the alarm function of gate 2; on, off, audible. The audible feature sounds a beeper when the waveform breaks the threshold level, either above or below, depending on the current DETECT setting. Refer to page 34 for further info. **DETECT:** Enables the user to set the alarm detection to occur either above or below the gates threshold level. Refer to page 34 for further info.

GATE2: Gates allow the user to view a specific inspection/measurement range, or specific regions of the waveform, while ignoring others. In order to detect on a waveform echo, and display the amplitude as a percentage of full screen height, the echo must be inside the boundaries of the gate settings. The GATE2 feature adjusts where the gate begins, according to the depth/thickness. Refer to page 34 for further info.

<u>GATE2 WIDTH</u>: This feature allows the user to set the overall width of the gate, in terms of distance, from the GATE2 setting. Refer to page 34 for further info.

THRESHOLD2: Enables the user to set the sensitivity level of Gate2 to a calibrated screen height percentage. The threshold level will act as a starting point for the alarm trigger, and is directly associated with the DETECT setting outlined above. Refer to page 34 for further info.

POLARITY2: The gates can be set to detect on either the positive or negative polarity, or stroke, of the half or full wave cycle. It should be noted that if the VIEW is set to positive, and the gate negative, the *FX80* will not display an amplitude percentage of full screen height. Refer to page 34 for further info.

TRIGONOMETRY				
10 PD 17 /0			011	
IRIG			ON	
THICKN	ESS		4.000	
ANGLE			0.0	
X-0FFS	ET		0.000	
CSC 0.	D.		0.000	
GT1	GT2	TRIG	AWS	

3.8 TRIG – Menu

TRIG: This feature toggles trigonometry feature on/off. This feature is used with angle beam transducers for the inspection of welds, to calculate three measurements: Beam path distance (\forall), Surface distance (\rightarrow), and Depth (ψ) from the index point of the transducer. Refer to page 57 for further info.

THICKNESS: Used to set the thickness of the test material. The thickness will be used to determine which skip/leg the *FX80* is detecting on. Refer to page 57 for further info.

<u>ANGLE:</u> Used to set the angle of the transducer, and used in the calculations above. Refer to page 57 for further info.

<u>X-OFFSET</u>: This feature is used to calculate the surface distance in the trigonometry function, as is a physical measurement from the index point of the probe to the front of the wedge/can/shoe/case. Refer to page 57 for further info.

<u>CSC OD</u>: Curved surface correction to compensate for changing sound path distance and angle. This feature is used in conjunction with 'thickness' in order to calculate a correction factor. Refer to page 57 for further info.

AWS SETTING	S
THIS SETTING	
ALIC	ON
REFERENCE GAIN	OFF
SHOW CURVE	OFF
× SCRN HEIGHT	80
GT1 GT2 TRIG	AWS

3.9 AWS – Menu

<u>AWS:</u> This feature toggles the AWS feature on/off. Used in the analysis of welds according to American Welding Society's structural welding code D1.1-94, to calculate the Indication Rating (IR). Refer to page 64 for further info.

REFERENCE GAIN: The gain (in dB) required to set the indication level to a specific percentage of full screen height (FSH). This value will typically be set somewhere between 20%–90%. Refer to page 64 for further info.

<u>SHOW CURVE</u>: Toggles the AWS correction curve on/off. Refer to page 64 for further info.

<u>*% SCRN HEIGHT:*</u> This feature enables the user to set the reference level of the TCG as a percentage of full screen height (FSH). Refer to page 64 for further info.

Т	CG SE	TTING	S
TCG			ON
DRAW			OFF
CURVE			OFF
% SCRN	HEIGHT		80
TCG	DAC	DGS	SET

3.10 TCG – Menu

TCG: This feature toggles the TCG feature on/off. The Time Corrected Gain (TCG) feature displays reflectors of equal size at equal A-Scan amplitudes, regardless of the reflector's depth in the test material. Refer to page 78 for further info.

<u>REFERENCE GAIN:</u> Toggles the DRAW mode on/off, and used to draw the TCG curve. Refer to page 78 for further info.

<u>CURVE</u>: Toggles the TCG correction curve on/off, and the curve is displayed on the screen. Refer to page 78 for further info.

<u>% SCRN HEIGHT</u>: This feature enables the user to set the reference level of the TCG as a percentage of full screen height (FSH). Refer to page 78 for further info.

DAC SE	TTINGS
DAC	ON
DRAW	OFF
MEAS	%FSH
CURVE	OFF
TRIGGER CURVE	GATE
DPOLARITY	POSITIVE
FIT	SPLINE
TCG DAC	DGS SET

3.11 DAC – Menu

DAC: Toggles the DAC feature on/off/audible. A Distance Amplitude Correction (DAC) curve is used to configure a variable threshold for the gate, using the same size reflector at different distances. Refer to page 71 for further info.

DRAW: Toggles the DRAW mode on/off/audible, and used to draw the DAC curve. **Note:** TCG *curve cannot be drawn in RF view. Refer to page 71 for further info.*

MEAS: Toggles the units displayed as a relationship of either the signal amplitude and DAC curve, or just the signal according to screen height. The units are as: %FSH, %DAC, and dB. Refer to page 71 for further info.

<u>CURVE</u>: Selectable signal or multi DAC curve options. The displayed curve options are: DAC, -2dB, -6dB, -10dB, (-6dB/-12dB), (-6dB/-14dB). Once the DAC curve has been generated, these options can be toggled at any time. Refer to page 71 for further info.

TRIGGER CURVE: Used to set the alarm threshold for the DAC curve. The options are; at DAC, -2dB, -6dB, -10dB, -12dB, -14dB, or using an independent gate. The list of trigger options will change according to which CURVE option has been selected. Refer to page 71 for further info.

DPOLARITY: Used to select the polarity of the DAC curves generated, either positive or negative. Refer to page 71 for further info.

<u>FIT:</u> Creates either a linear (straight line) or spline (nice curve) fit between calibrated reference points. Refer to page 71 for further info.

DISTANCE GA	IN	DISTANCE GAI	N
DGS	ON	EFF PROBE DIAMETER	0.000
REFERENCE GAIN	OFF	PROBE FREQUENCY	0.00
TRIGGER CURVE	DAC	CURVE SIZE (ERS)	0.000
EFF PROBE DIAMETER	0.000	ATTENUATION	OFF
PROBE FREQUENCY	0.00	DELAY VELOCITY	OFF
CURVE SIZE (ERS)	0.000	REFERENCE TYPE BACK	WALL
ATTENUATION	OFF	REFERENCE SIZE	N/A
<more></more>		<hore></hore>	
TCG DAC DGS	SET	TCG DAC DGS	SET

3.12 DGS – Menu

DGS: Toggles the DGS feature on/off. Distance Gain Size (DGS) curve is used to configure a variable threshold for the gate using a single reflector using an empirically derived set of curves. Refer to page 84 for further info.

<u>REFERENCE GAIN</u>: Toggles the DRAW mode on/off, and used to set the reference gain from a given reference standard. Refer to page 87 for further info.

Dakota NDT

TRIGGER CURVE: Used to set the alarm to detect on either the DGS curve, or independent GATE. Refer to page 87 for further info.

<u>EFF PROBE DIAMETER</u>: Used to set the effective probe diameter of either a round or square/rectangular crystal element, and used as a variable to calculate the near field length. Refer to page 85 for further info.

PROBE FREQUENCY: Used to set the center frequency of the probe/transducer. The frequency will either be scribed on the probe itself, and additionally listed on the transducer certificate. Refer to page 87 for further info.

<u>CURVE SIZE (ERS)</u>: Used to select the Effective Reflector Size that will be used from the DGS/AVG chart. Refer to page 87 for further info.

ATTENUATION: Toggles the ATTENUATION on/off. The parameters in the sub menu are used to compensate for additional factors that affect the propagation of sound energy, based on the material, surface condition, and differences between the reference standards versus test material. Refer to page 88 for further info.

DVK: Used to correct for increases in gain based on a curved reference standard, to an actual back wall reflector. Refer to page 88 for further info.

MATERIAL LOSS: Used to correct for the loss of sound in attenuative materials and applications inspections where sound will travel long distances. Refer to page 88 for further info.

REFERENCE LOSS: Used to compensate for the loss of sound in the reference standard. Refer to page 88 for further info.

TRANSFER LOSS: Used to correct for the loss of sound based on the surface of the actual test material. Refer to page 88 for further info.

DELAY VELOCITY: Used to set the longitudinal velocity of the transducer delay line, for both angle & straight beam probes, to account for the proportion of the near field length in the delay line. Refer to page 87 for further info.

<u>REFERENCE TYPE</u>: This option is used to set the type of reflector that will be used during the setup and calibration process. The options are Back Wall, Side Drilled Hole (SDH), or Flat Bottom Hole (FBH). Refer to page 87 for further info.

<u>REFERENCE SIZE</u>: If the reference type was set to SDH or FBH, the size of the reflector must be entered. Refer to page 87 for further info.

SE	ETUP (PTI	ONS
OPEN			
SAVE DELETE			
DEFAUL	SETUP		
LANGUA	ΞE		ENGLISH
TCG	DAC	DGS	SET

3.13 SETUP – Menu

<u>OPEN</u>: Displays a list of factory and user defined setups currently stored in memory. These setups can be recalled and used at any time. Refer to page 164 for further info.

<u>SAVE</u>: Provides the user with the ability to save a custom setup that has been modified or created by the user. Refer to page 166 for further info.

DELETE: Provides the user with the ability to delete specific setups previously save in memory. Refer to page 166 for further info.

DEFAULT SETUP: Loads a basic default setup. Use only as a last resort when the setups in the *FX80* have been corrupted and a computer is not accessible. Refer to page 171 for further info.

LANGUAGE: Provides the user the ability to select different languages for the *FX80*. Refer to page 173 for further info.

	ST0	RE	DA	TA	
NEW				SEO	LOG
EDIT					
OPEN					
CLOSE					
DELETE	ONE	FIL	_E		
DELETE	ALL	DA'	TΑ		
DATA	UTI	L	XFE	R	

3.14 DATA – Menu

NEW: Allows the user the ability to create a new alpha numeric grid, or sequential log file with auto identifiers. It is equipped with custom parameters, rows, and columns depending on the user's application reporting requirements. Refer to page 141 for further info.

EDIT: Gives the user the ability to change parameters of grid or sequential file previously saved. **Note:** *Pre-defined coordinates cannot be changed once they have been created. Refer to page 157 for further info.*

<u>OPEN</u>: This function provides the user with the ability to recall grids or sequential log files that currently exist in memory, from a list of grids. Refer to page 157 for further info.

<u>CLOSE</u>: Provides the user the ability to close a currently opened grid or sequential log file. Refer to page 160 for further info.

DELETE ONE FILE: This function provides the user with the ability to delete one individual grid or sequential log file from a list of multiple grids/files previously saved in memory. Refer to page 154 for further info.

DELETE ALL DATA: This function provides the user with the ability to delete all files currently stored in memory. Refer to page 156 for further info.

UTILITIES		UTILITIES		
AUTO FIND		AUTO FIND COMPARE	ON	
COMPARE	ON	ANALOG OUTPUT	OFF	
SET DATE	05/29/14	SET DATE	05/29/14	
KEY CLICK	QUIET	KEY CLICK	QUIET	
GAUGE	FLAW MODE	GAUGE	FLAW MODE	
DATA UTIL	XFER	DATA UTIL	XFER	

3.15 UTIL (Utilities) - Menu

<u>AUTO FIND:</u> Automatically locates the detection point if the measurement is out of the viewable display area, and automatically sets up the gauges scope settings. Refer to page 106 for further info.

<u>COMPARE</u>: Enables the user to freeze and drop a reference reflector or defect into the background, to compare against a live wave scan in the foreground. Compare is a variation of the peak feature and used in conjunction with the PEAK key when enabled. Refer to page 125 for further info.

<u>ANALOG OUTPUT:</u> *FX-81* only. Proportional outputs (amplitude or distance), 0-10 volts. Speed is determined by the **PRF** setting. Refer to page 127 for further info.

<u>SET DATE</u>: Gives the user the ability to set the internal date and time stamp in the *FX80*. Refer to page 125 for further info.

<u>SHOW DATE</u>: Gives the user the ability to display the date and time in the waveform area of the *FX80*. The options are OFF, DATE, TIME, BOTH. Refer to page 133 for further info.

<u>KEY CLICK</u>: Gives the user the ability to set the level of the key press beeper OFF, QUIET, or LOUD. Refer to page 133 for further info.

<u>GAUGE</u>: Gives the user the ability toggle the *FX80* gauge type to either a flaw detector, or a thickness gauge. Refer to page 3 for further info.

ράτα τ	RANSFER
DATA I	RANJIER
COPY SETUPS	
COPY DATA	
COPY SCREENS	
UPGRADE GAUGE	E
CAPTURE TO F	ILE YES
STORAGE	EXTERNAL
ABOUT	DEV 0.05G
DATA UTIL	XFER

3.16 XFER (transfer) – Menu

<u>COPY SETUPS</u>: Copies setup files from either the internal or external SD memory card to the other memory card, depending on the current internal/external setting of **Storage** (current device being used to store data), located in the XFER menu. Refer to page 176 for further info.

<u>COPY DATA:</u> Enables the user to copy all, or individual grid/log files from either the internal or external SD memory card to the other memory card, depending on the

current internal/external setting of **Storage** (current device being used to store data), located in the XFER menu. Refer to page 176 for further info.

<u>COPY SCREENS</u>: Copies screen capture (.tif's) files from either the internal or external SD memory card to the other memory card, depending on the current internal/external setting of **Storage** (current device being used to store data), located in the XFER menu. Refer to page 176 for further info.

<u>UPGRADE GAUGE</u>: Enables the user the ability to upgrade the *FX80* to the most current firmware revision. Refer to page 179 for further info.

<u>CAPTURE TO FILE</u>: Enables the user the ability to enable screen captures to .tiff files, and used in conjunction with the Multi Mode key. Refer to page 134 for further info.

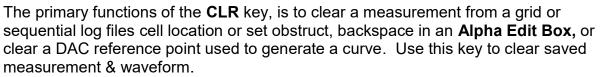
<u>CAPTURE VIEWER</u>: Enables the user the ability to enable screen captures to .tiff files, and used in conjunction with the Multi Mode key. Refer to page 135 for further info.

STORAGE: Enables the user to select which SD memory card to use for storage. **Note:** *if no card exists in the external reader slot, this option will be grayed out and inactive. Refer to page 175 for further info.*

<u>ABOUT</u>: Provides the user with Dakota NDT contact information and the *FX80* firmware & FPGA versions. Refer the Dakota NDT web site for information on the latest firmware versions available for download.

(×) clr

3.17 CLR (clear) Key



3.18 HOME (measurement mode) Key



The **HOME** key puts the *FX80* into its primary mode of operation. In this mode, the user has a complete view of the LCD. When pressed multiple times, navigates the hot menu items.

3.19 OK Key



The primary function of the **OK** key is confirmation of a change or selection. The **OK** key also toggles the Hot Menu area, while in measurement mode, to a large digits display area. If the *FX80* is displaying a grid log, the **OK** key toggles an advance to row number option.

3.20 ESC Key The **ESC** key is used in the (Ξ) , (n), and **EDIT** functions as a back or escape function. If the *FX80* is displaying a grid or sequential log, the ok key toggles the display options: RF, +RECT, -RECT and RECTFW views.



3.21 Wheel Keys

The **Arrow Keys** are used to navigate through the menus, increase/decrease values, and toggle specific function keys.

3.22 ENTER key



The **ENTER** key is used in the overall menu selection process, to activate list and edit boxes, display and save measurements/waveforms to grid or sequential file locations.

3.23 MULTI MODE Key



The MULTI MODE key is only used in the thickness gauge portion of the FX80.

3.24 DATA Key



The **DATA** key opens the tabbed data menu, allowing a user to efficiently create a new log/grid file for storage.

3.25 STORE Key



The **STORE** key displays the current log/grid opened in split screen mode. If no log/grid file is open, the **STORE** key will open the tabbed data menu in order create a new, or open an existing log/grid file for storage.

3.26 PEAK Key



The **PEAK** key is a feature used in the flaw detector portion of the *FX80*, and is not used in the thickness gauge. It is also used to activate the **COMPARE** feature located in the **UTIL** menu

3.27 FREEZE Key



The FREEZE key is used to freeze the display for evaluation/review of what's currently on the display. It is also used in conjunction with the **CAPTURE** feature to save the current display to a .tif (tagged image) graphic file that can be opened using any graphics viewer.

3.28 ON/OFF Key



The **ON/OFF** key simply powers the unit either **ON** or **OFF**. **Note:** *Unit will automatically power off when idle for 5 minutes. All current settings are automatically saved prior to powering off.*

Note: If the **FX80** fails and is in a state where none of the keys are responding, pressing the **ON/OFF** key continuously with repetition will force an auto system shutdown. The user can then power the unit back up.

D H. С G А 74% H: н: 71% B-.222 E K٠ 1.516 .516 OFF OFF 0.436 0.436 F HL. INF INF -NAME: INSP#99 5H1 142 14% YES YES FLAW2 FLAW3 70% CLOSED FLAW4 STEP: 1.0 STEP: GN:26.0 FLAW5 GN:26.0

3.29 FX80 Overview

FX80 Screen Shots

In order to understand how to operate the *FX80*, it's best to start off with an understanding of what we're looking at. The *FX80* has a lot of great features and tools that will prove to be a huge benefit for the variety of applications you're

constantly facing on a continual basis. Let's have a brief look at the screens you'll be looking at most often:

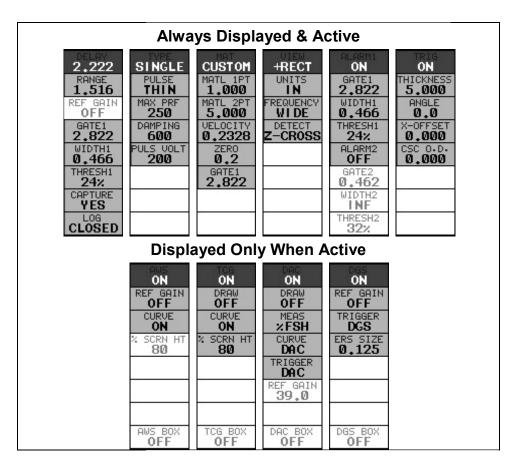
- A. **Repeatability/Stability Indicator** This indicator shows the stability/repeatability of the sound path signal. When all the vertical bars are fully illuminated, the repeatability of the sound path is stable.
- B. **Battery Icon** Indicates the amount of battery life the *FX80* has remaining.
- C. **Height** Shows the signal amplitude height as a percent of 100% full screen height.
- D. **Feature Status Bar** Indicates the features currently enabled and in use in the following order:
 - Feature Toolkits
 - i. Trig Trigonometry w/ Curved Surface Correction
 - ii. AWS American Welding Society
 - iii. TCG Time Corrected Gain
 - iv. DAC Distance Amplitude Correction
 - v. DGS Distance Gain Size
 - View
 - i. RF: Radio Frequency.
 - ii. R+: Rectified positive.
 - iii. R-: Rectified negative
 - iv. FW: Rectified full wave.
 - Detect
 - i. Zero crossing (ZX)
 - ii. Flank (FK)
 - iii. Peak (PK)
 - Leg Skip leg reference, (L1…L4…)
 - High Speed Scan Mode
 - Alarm Mode
 - Gain Setting
- E. Leg (skip leg) Indicates which skip/leg the detection in on. The thickness of the material is used to calculate the leg.
- F. **Hot Menu items** We call this menu section our "hot menu", as these items are the most commonly adjusted features, requiring quick access from the

user. They can be displayed and scrolled by pressing the

anytime. The key is used in conjunction with key to reverse the direction scrolled.

key at

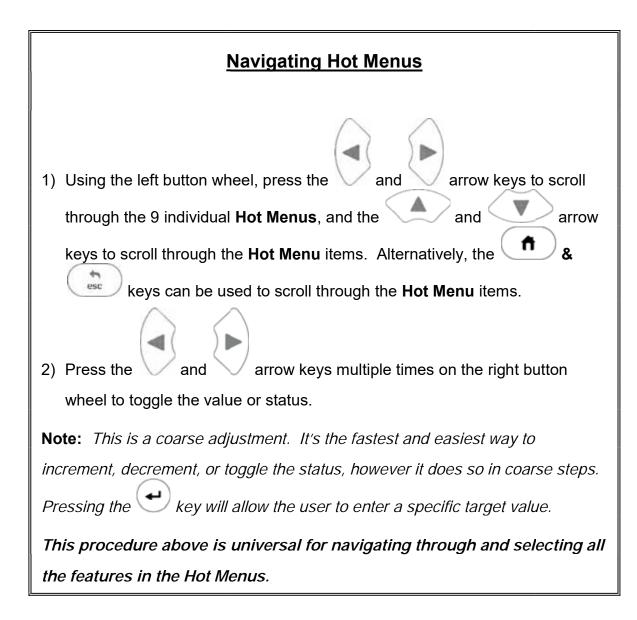
- G. Memory Indicates that the currently displayed measurement screen and values have been previous stored in memory. When MEM is displayed, all measurement functions are disabled until the user advances to an empty storage location, or the current measurement is cleared by pressing the key.
- H. **Height** Displays the amplitude of the signal as a percentage of full screen height. Depending on the quantity selected, this could also be displayed in dB, or D.
- I. **Grid or Seq Log Name** References the name of the log file currently open.
- J. Log File Shows the storage cells of the current log file open. Depending on the quantity currently selected, show either the %height or dB value stored.
- K. **A-Scan Display** The actual echo reflections returned from the backwall or defect.



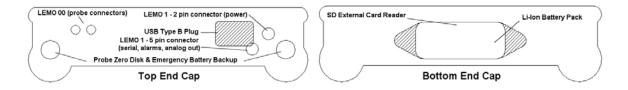
3.30 Navigating the Hot Menus

The diagram above is a screenshot of all 10 "Hot Menus" in the **FX80**. The Hot Menu's contain all the most regularly adjusted features from each tabbed menu, in

the exact order of the tabbed menus themselves. Some of the menus have been combined into a single Hot Menu, in order to reduce the number of Hot Menus (i.e. GT1 & GT2 have been combined into a single Hot Menu). Additionally, the toolboxes (AWS, TCG, DAC, DGS) will only appear as a Hot Menu when activated and only one toolbox can be active at a time. Therefore, a total of 6 Hot Menus will always be active, plus an optional toolbox. The primary purpose of the design was to provide the user with an efficient way to make adjustments on the fly, while continuing to have visibility of the A-Scan display. The following procedure outlines the steps to navigate and make adjustments as follows:



3.31 Top & Bottom End Caps



The top & bottom end panels are where all connections are made to the *FX80*. The diagram above shows the layout and description of the connectors:

Transducer Connectors

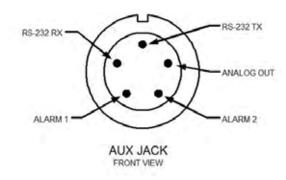
Refer to Diagram: The transducer connectors, emergency battery backup channels/probe zero disks, power connector and auxiliary connector are located on the *FX80's* top end cap. The transducer connectors are of type Lemo "00". **Note:** *There is no polarity associated with connecting the transducer to the FX80.*

Probe Zero Disk & Battery Cover

Refer to Diagram: The emergency battery backup disks are the large round disks shown in the diagram. **Note:** *This same disk is also used as a probe zero disk.* Simply remove the cover when replacing the batteries (3 AA cells) for each. When performing a manual probe zero function, simply place the transducer on disk making firm contact. **Important:** Be sure to follow the polarity label located on the back label of the *FX80*. **Note:** *Rechargeable batteries can be used, however they must be recharged outside of the unit in a standalone battery charger.*

USB Type B Connector

Refer to Diagram: The **USB** connector is a common type B connector found on a variety of electronic devices. This port will be used to transfer stored grid/log files, captured screen shots, etc. This connector will also be used to upgrade the *FX80* with the latest version of firmware (gauge software). The cable supplied with the *FX80* is USB type A to USB type B.



RS-232 Serial Connection (LEMO 1 – 5 pin)

Refer to Diagram: The **RS-232** connector is a 5 pin female Lemo 1 connector. It is designed to connect directly from the *FX-81* to a standard AT serial port on a PC, and works in conjunction with the integrated "remote commander" feature built for system

integration in the *FX-81* "only". A standard terminal software program must be installed and configured, like HyperTerminal from Windows, in order to use this feature. Basic commands can be sent from a PC keyboard to the *FX-81* through the serial portion of the connector to remote control the gauge. An accessory 9 pin female serial to Lemo 1 - 5 pin male cable will be required to use this feature, and is not included in the standard kit.

Terminal settings for serial communication and a list of the current set of commands available in remote commander are shown in the diagrams below. They can be displayed at any time by typing 'help' in the PC terminal window, followed by pressing the enter key. You'll notice that some of the commands have an 'n' next to them. These require either a number to change the value for the given parameter, or a '?' to report back to the user the current value of the parameter.

ort Settings		00000
<u>B</u> its per second:	9600 🔹	ALARMI n ALARMI n DAMPING n DELAY n FPREY n FREQ n
<u>D</u> ata bits:	8 -	GAIN n GAUGE GATEL n GATEL n GATEL n
<u>P</u> arity:	None	HEIGHT HELP LDGETUP m MERSURE FRP. 0
<u>S</u> top bits:	1	PTYPE n PVOLT n PVIDTH n Range n Redraw
Flow control:	None	RPWNUE SAUECFC INRESHI m INRESHI m INRESHI m INICK VIDINI n
	<u>R</u> estore Defaults	UIEU o OK

Analog Output (LEMO 1 – 5 pin)

Refer to Diagram: The *FX-81* is also equipped with analog outputs 0-10volt, and is updated at the same rate as the PRF. There is 100 ohm output impedance which will vary the voltage slightly and should therefore be calibrated to the device connected.

Alarms Connection (LEMO 1 – 5 pin)

Refer to Diagram: This is used for connecting each alarm directly to an external source. The alarm pins are an open collector, 20 MA at 12v. Typically a 4.7K "pull up" resistor is required. An accessory 9 pin female serial to Lemo 1 - 5 pin male cable will be required to use this feature, and is not included in the standard kit.

Power Connector (LEMO 1 – 2 pin)

Refer to Diagram: The Lemo 1 2 pin connector is used for direct line power and charging the Li-lon battery pack.

CHAPTER FOUR SETTING UP FOR MEASUREMENT

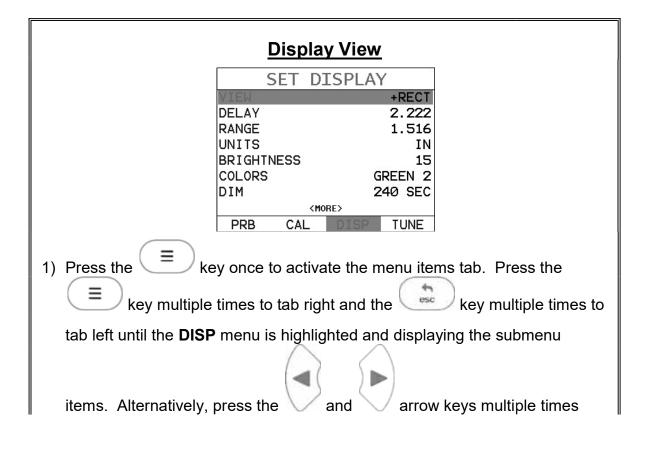
4.1 Selecting Display View

The **FX80** includes a variety of viewing options for the waveform display. There are three primary options waveform options with selectable polarity. These are all outline below as follows:

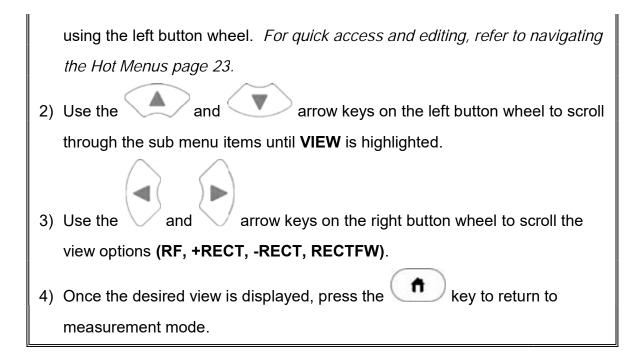
Radio Frequency (RF): Displays the entire sine wave signal, much like an oscilloscope, from a reflector or return echo. This view shows both the positive and negative peaks.

Rectified (RECT): Displays half sine wave signal, either positive or negative, from the reflector or return echo. The user can select the polarity or "phase" displayed. This is typically determined by first using **RF** view to select the most optimal polarity "phase", to fine tune the scopes settings. The **RECT** view is commonly used as the primary "flaw detection" view.

Full Wave (RECTFW): Display entire sine wave signal in a rectified view. There is no polarity.



The following procedure outlines the steps to select the view:



4.2 Adjusting the display

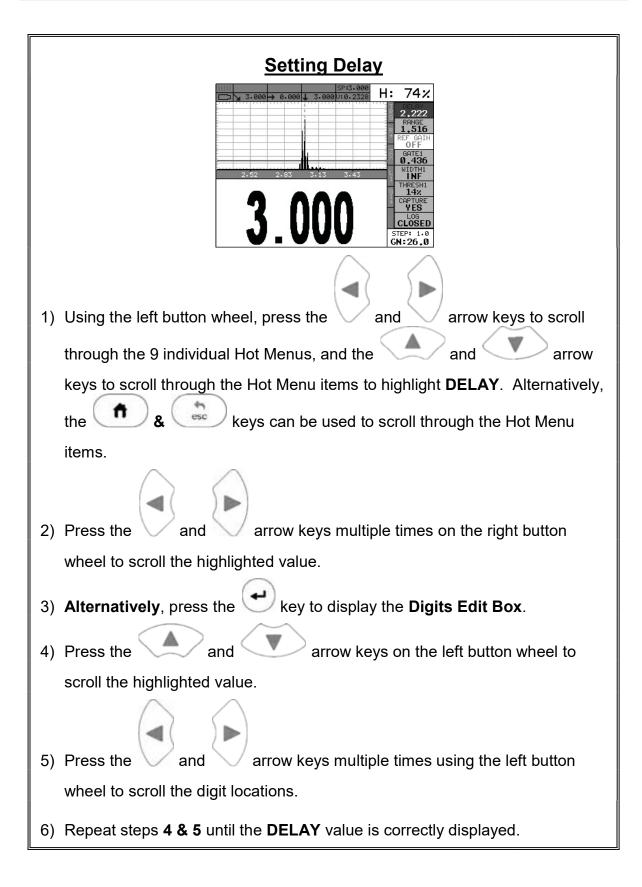
This section will cover the procedures for adjusting the viewable range, or area, of the display, in terms of thickness. A basic overview example for this section would be as follows: Suppose we had a 50" widescreen television set. The left side of the television screen is considered the **Delay** for all view options. The right side of the television screen is the **Range + Delay**. By adjusting the left and right side of the television screen, to control the viewable area/range, we can zoom in and out of any part of the 50" screen we'd like, and focus on only the specific areas of the screen necessary.

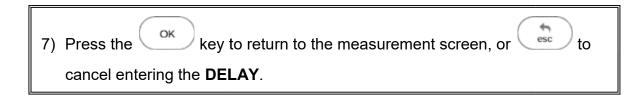
Setting Delay

The Delay represents the left side of the display, and can be adjusted to start at any thickness value within the overall range of the *FX80*.

Note: Once the delay is set, it will remain the same for the views: **RF**, **+RECT**, **-RECT**, **RECTFW**.

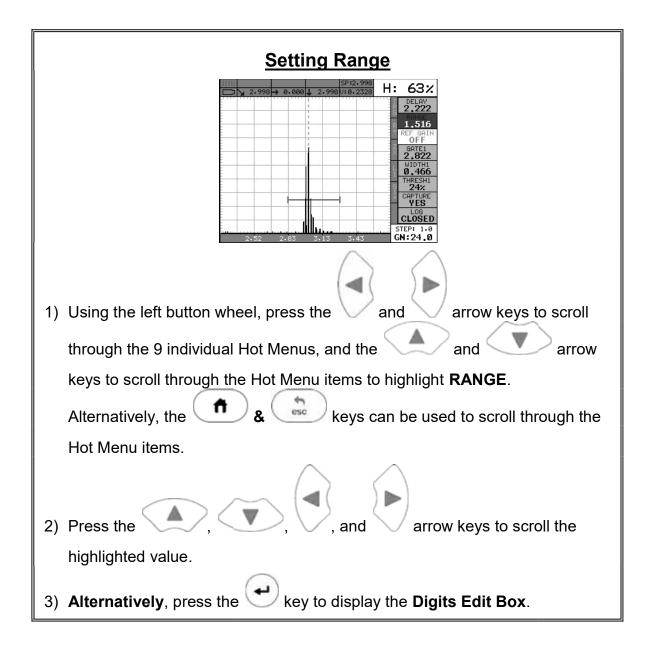
The procedures to adjust the **Delay** are outlined below:





Setting Range

The **Range** is the distance from the delay that will be viewable on the screen. It can be adjusted to any value greater than the **Delay**. The procedures to adjust the range are outlined below:



4) Press the and and arrow keys on the left button wheel to
scroll the highlighted value.
5) Press the and arrow keys multiple times using the left button
wheel to scroll the digit locations.
6) Repeat steps 4 & 5 until the RANGE value is correctly displayed.
7) Press the κ key to return to the measurement screen, or κ to
cancel entering the RANGE .

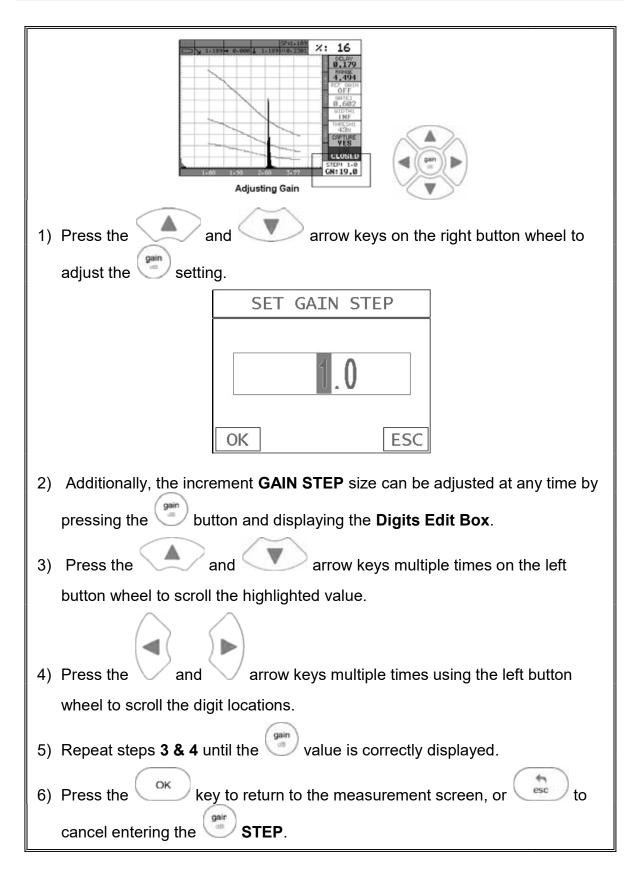
4.3 Gain

The gain feature of the **FX80** is used to adjust the signal amplitude to a predetermined reference height for the inspection process. The higher the gain the more the sound is amplified. The gain, or amplification of the return echoes, can be adjusted in the **FX80** to accommodate a variety of applications. The setting of the gain is crucial in order to obtain valid readings during the inspection process.

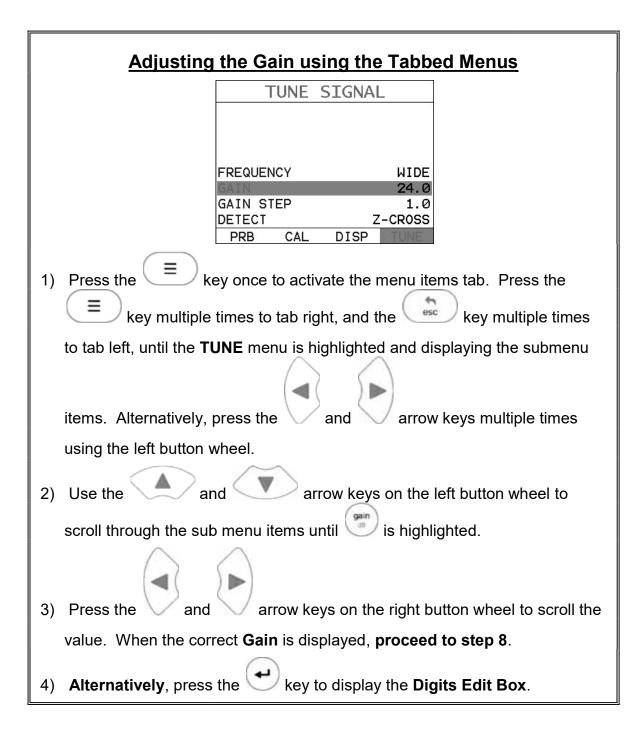
Too much gain may result in erroneous measurements, by detecting on noise rather than the actual reflector or defect. Not enough gain may result in intermittent detection. It may also result in lack of detection on internal flaws, pits, or porosity. The gain can easily be compared to the volume control of a home stereo system. If you turn it up too much, you can't hear the music clearly. If it's turned down too much, you can't hear it at all. The *FX80* commands a 110dB gain range using 3 stages of amplification. The overall range makes the FX80 extremely versatile regarding a variety of applications and material types.

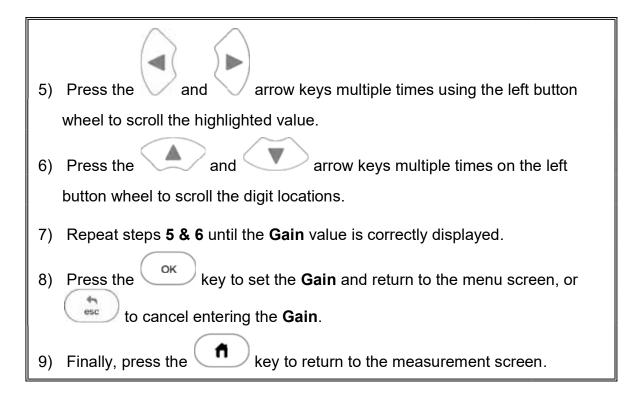
The **Gain** can be quickly adjusted at any time, as the *FX80* has dedicated buttons on the keypad for this purpose. The procedure to adjust the **Gain** are outlined below:

<u>Gain</u>



The user can also access and adjust the gain from the tabbed menus. However, this method is more tedious than making the adjustments using the **Hot Menus**. The procedure using the tabbed menus is outlined below:





4.4 Gates

The gates are an important part of any ultrasonic device, in this case a flaw detector. The primary purpose of using a flaw detector is to "detect" and estimate the "size" of of flaws according to calibrated reference standards or simulated defects. The gates play an important role in this process, as without them a detection/measurement isn't possible. The height of a gate is also a threshold, or controls the level of sensitivity. They can be adjusted to a specific reference height, based a predetermined reflector, and set to act as an alarm during the inspection process.

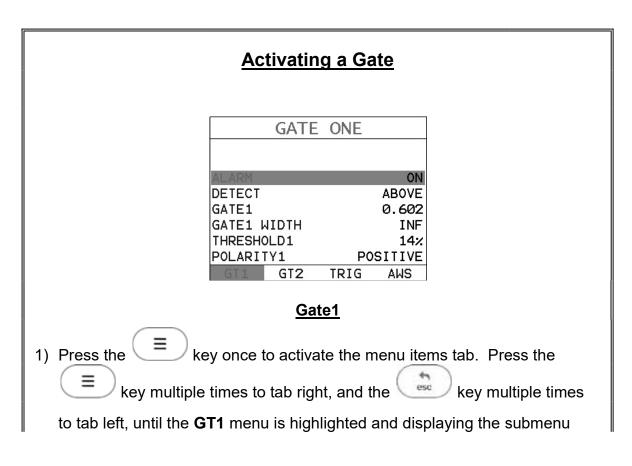
The more flexible a gate is, the better the possibilities for the user to setup an application. For example, a test block with a target size and depth is optimized on the A-Scan display with a signal amplitude at 70% full screen height. The inspector wants to know of any defects during the inspection that are greater than or equal in size to the calibrated test specimen. A gate is then enabled and set to a reference height of 70%. The width and range are adjusted to cover the range tested, and the inspection is underway.

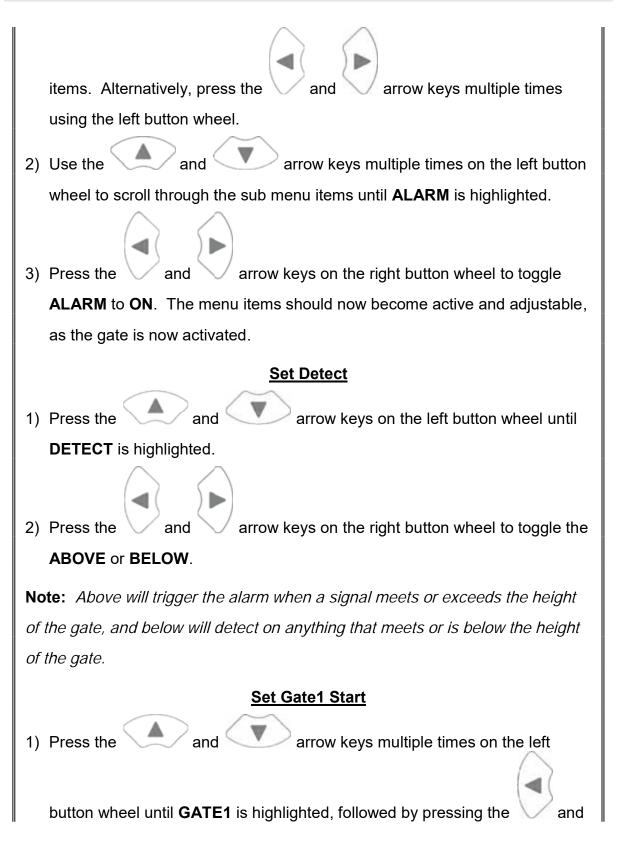
The *FX80* is equipped with 2 fully independent gates. Each gate has a start and stop or width, a threshold, a polarity switch, and a detect option. A gate can only detect on reflections that occur inside the boundaries of the gate. Anything outside of the start and range/width of the gate will be ignored. Both gates can be enabled and set for different detects, polarities, and positioned anywhere on the A-Scan display independent of one another. The following sections cover enabling and setting up gates:

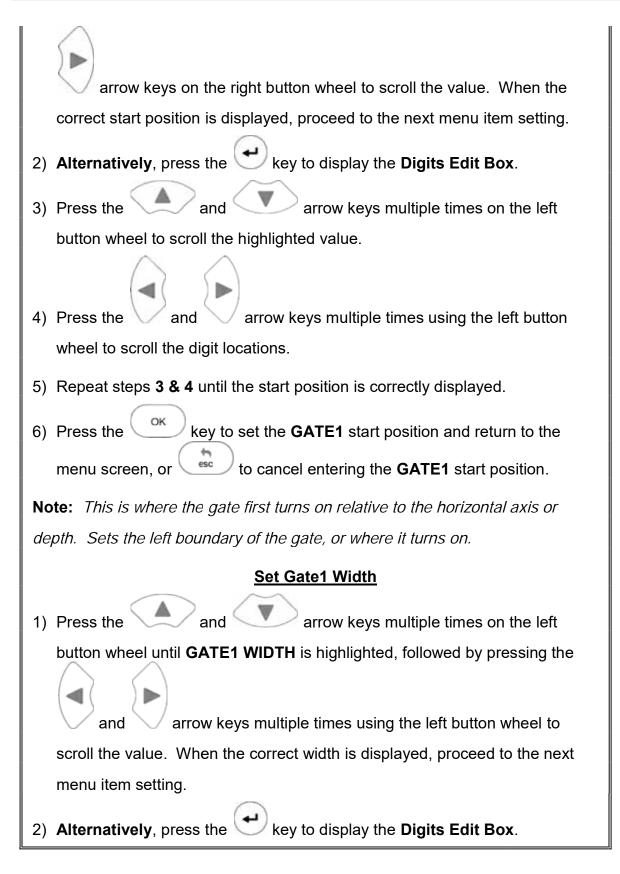
SP:2.999 H:---% H: 88% 2.011 2.011 1.819 1.819 OFF OFF 2.822 2.822 0.466 0.466 YES F YES CLOSED CLOSED GN:24.0 GN:24.0 No Gate Gate On

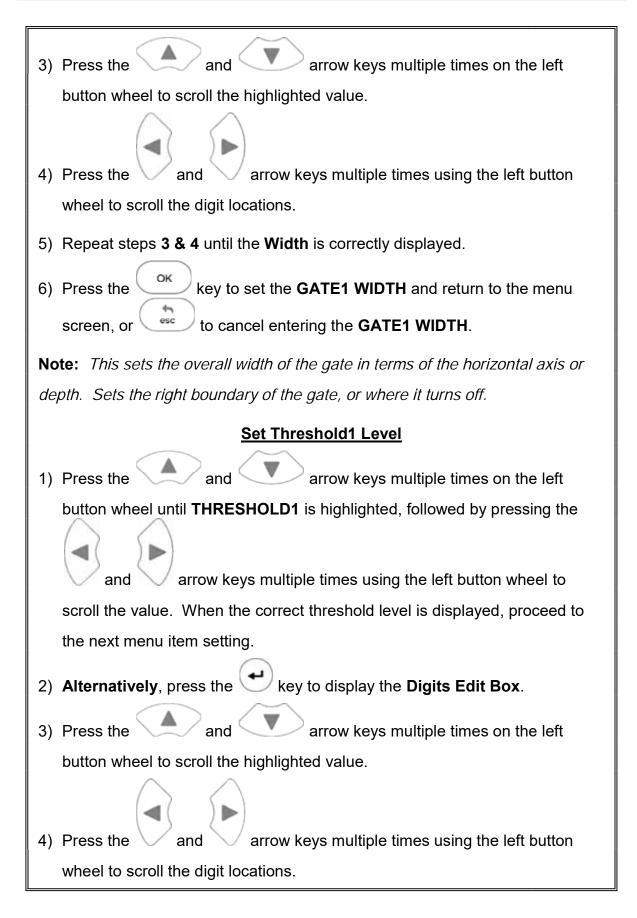
4.5 Activating and Setting Up a Gate

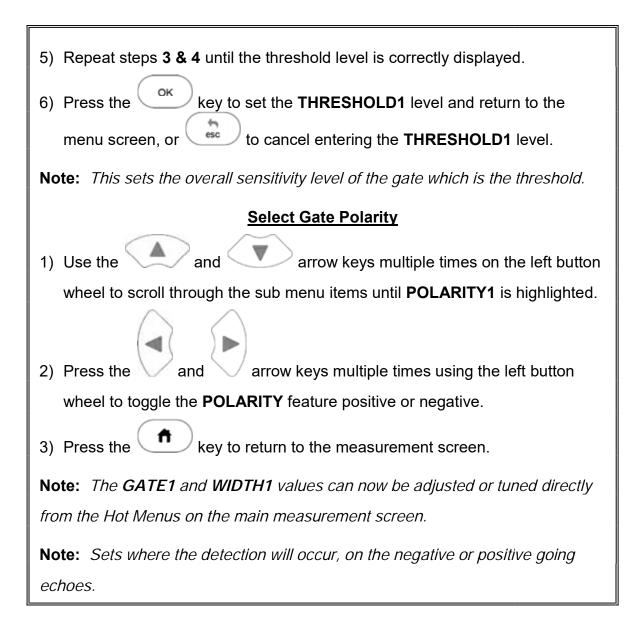
The screenshots above show a rectified waveform with and without a gate enabled. The commonly adjusted features of the gates can also be accessed using the Hot Menus. *For quick access and editing, refer to navigating the Hot Menus page 23.* The following steps outline how to enable a gate as follows:











CHAPTER FIVE CALIBRATION

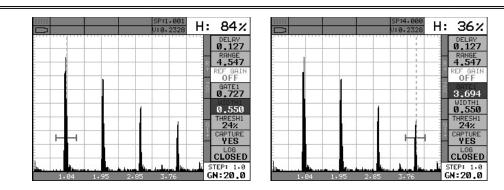
In this section we'll focus on calibrating the *FX80*. There are a number of ways to go about performing a calibration, but we'll be focusing on the simplest and most accurate method, which is performing a two point calibration. This method is very convenient, as it will automatically calculate the material velocity and zero using a minimum and maximum calibration standard of know thickness and material type. The *FX80* can certainly be manually calibrated by adjusting the velocity and zero features, but this is a tedious and redundant process overall.

The two point calibration method can be used for both straight and angle beam transducers. A number of certified calibration standards are available to address inspection code requirements, specifications, and applications. It should be noted again that the *FX80* has virtually 2 gauges built into a single gauge; a flaw detector, and a thickness gauge. Therefore, while the flaw detector option can be calibrated for straight beam contact and angle beam style transducers, the thickness gauge option contains a number of tools for using single and dual element style transducers with linearity tables and v-path correction curves. In addition, it should also be noted that the thickness gauge option has a fully functional scope with the same precision linearity as the flaw detector option. Therefore, the user should consider the current application to determine which gauge option will produce the best results. The following sections outline how to setup and calibrate your *FX80* for field use, given a specific range and material type.

5.1 Setting Up For Calibration

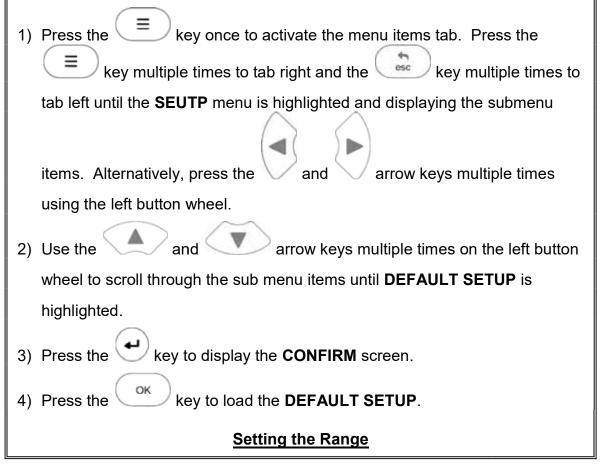
This section covers performing a two point automatic calibration using a single element straight beam contact transducer with a range from 1 to 4 inches. In order to accomplish this, a set of calibration standards covering range is required. The steps are outlined as follows:

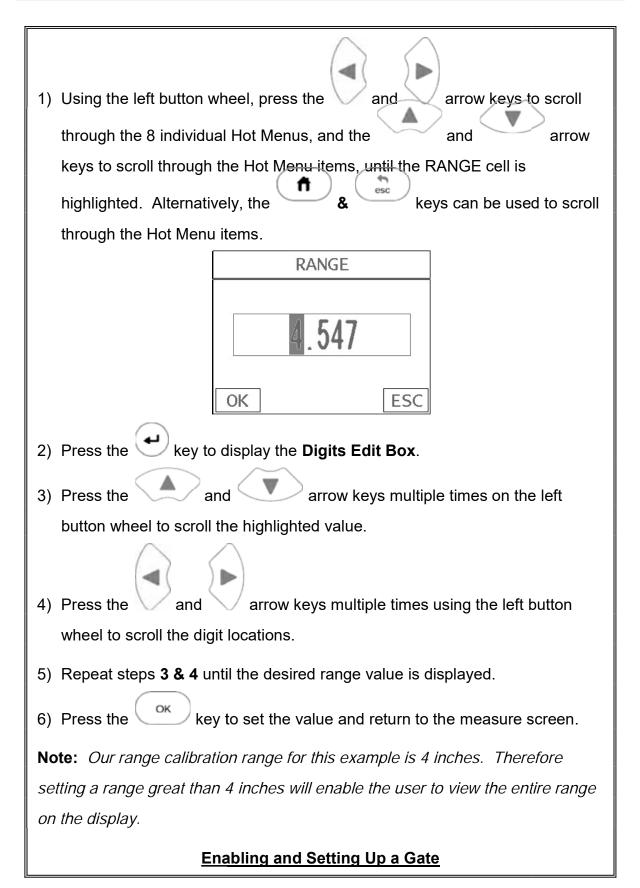
FX80 Setup



The gauge will require a few basic adjustments in order to get underway with the calibration process. For this example, in order to avoid multiple steps for setting the gauge features/options, the default setup will be loaded as a starting point. However, the user should invest the necessary time getting to know the features and options included in the *FX80*, as well as gaining a good understanding of their function:

Loading Default Setup

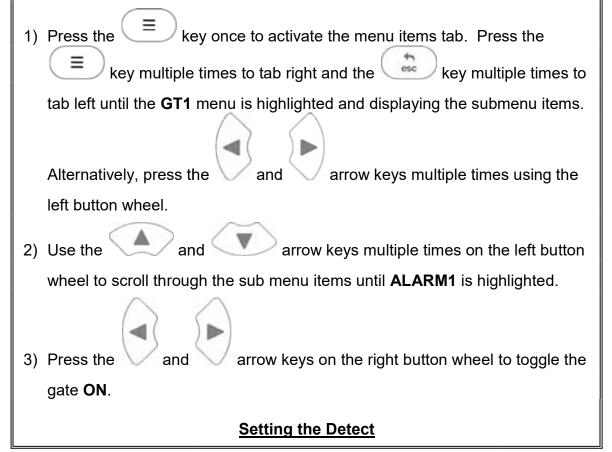


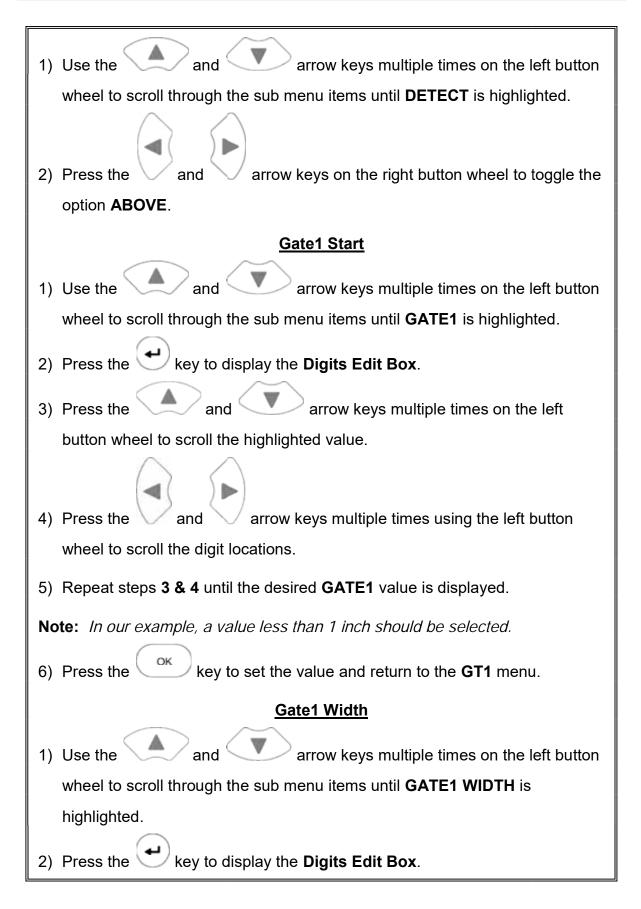


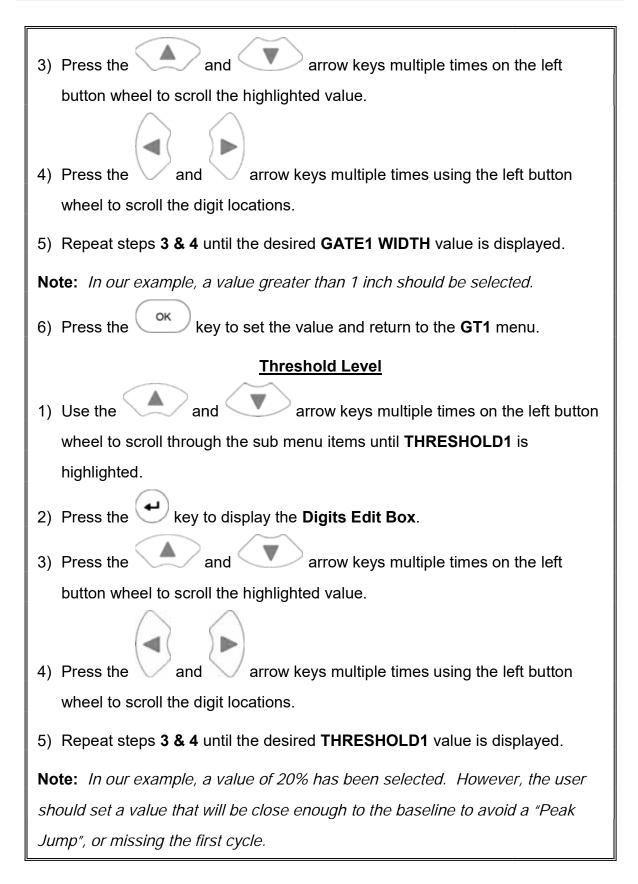
Refer to the illustrations above. In order to measure, a gate is required. The width of the gate should be small enough, in terms of its width, in order to select specific reflections to measure. The screenshot above shows a gate enabled to select the 1 inch calibration standard, and in the second the 4 inch calibration standard. *For quick access and editing, refer to navigating the Hot Menus page 23.*

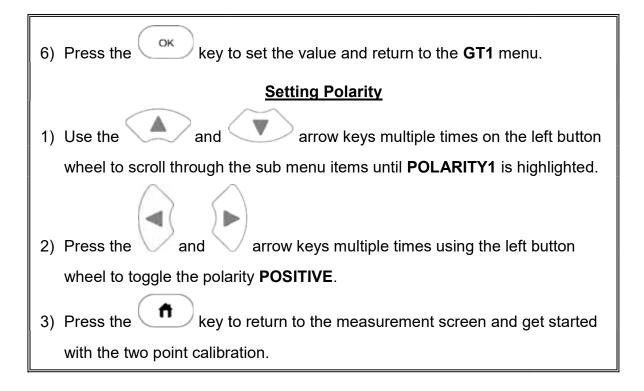
	GATE	ONE	
2			
ALARM1			ON
DETECT			ABOVE
GATE1			3.694
GATE1 WIDTH			0.550
THRESHOLD1			24%
POLARITY1		PC	SITIVE
GT1	GT2	TRIG	AWS

Activating a Gate





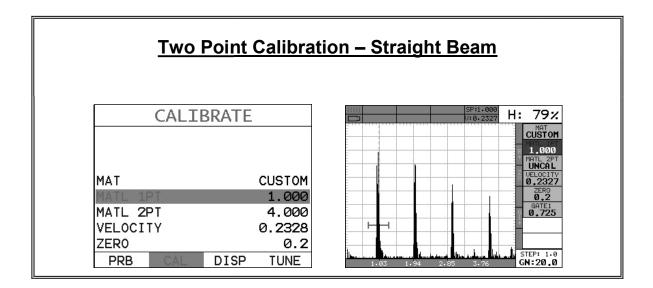




5.2 Straight Beam Calibration

Now that the *FX80* is setup with a valid range and a gate enabled, we're ready to perform a two point calibration using a single element contact style transducer, as follows:

For quick access and editing, refer to navigating the Hot Menus page 23. In the screenshot below, notice the Hot Menu representing the CAL menu is being displayed on the right side of the display.



Note: Calibration standards representing the minimum and maximum thickness of the overall inspection range intended are required. They must also be of the same material type as the intended application. For our example, we'll be using a 1 and 4 inch standard for calibration.

Coupling to the 1" Cal Standard (1st Point)

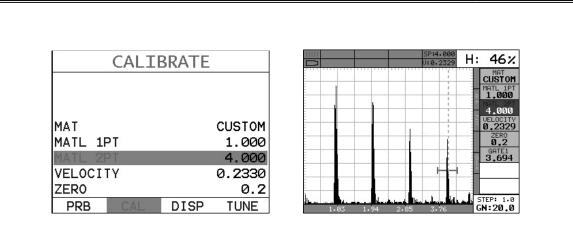
Apply a drop of couplant on the transducer and place the transducer in steady contact with the 1" calibration standard. Be sure that the reading is stable and the repeatability indicator, in the top left corner of the display, is fully lit and stable. Also, be sure there is sufficient signal amplitude in order to avoid 'peak jumping' or missing the first cycle.

Adjusting the Gate

1) Using the left button wheel, press the arrow keys to scroll and through the 9 individual Hot Menus, and the and arrow keys to scroll through the Hot Menu items, until the GATE1 cell is п esc highlighted. Alternatively, the & keys can be used to scroll through the Hot Menu items. and arrow keys on the right button wheel to move the 2) Press the gate over the waveform to be measured, as demonstrated in the screen shot above. **Note:** In order to trigger on a signal, the waveform must be inside the boundaries of the gate.

Calibrating the First Point

1) Press the E key once to activate the menu items tab. Press the			
\equiv key multiple times to tab right and the key multiple times to			
tab left until the CAL menu is highlighted and displaying the submenu items,			
as shown in the screenshot above. Alternatively, press the \checkmark and \checkmark			
arrow keys multiple times using the left button wheel.			
2) Use the and and arrow keys multiple times on the left button			
wheel to scroll through the sub menu items until MATL 1PT is highlighted.			
MATL 1PT			
1.000			
OK ESC			
3) Press the extreme to display the Digits Edit Box .			
4) Press the and and arrow keys multiple times on the left			
button wheel to scroll the highlighted value.			
5) Press the and arrow keys multiple times using the left button			
 Press the variable and variable arrow keys multiple times using the left button wheel to scroll the digit locations. 			
6) Repeat steps 4 & 5 until the known thickness value is correctly displayed.			
7) Press the $\overset{o\kappa}{\checkmark}$ key to calculate the velocity and return to the menu			
screen, or 💭 to cancel the one point calibration.			
8) Finally, press the key to return to the Measurement screen.			



Apply a drop of couplant on the transducer and place the transducer in steady contact with the 4" calibration standard. Be sure that the reading is stable and the repeatability indicator, in the top left corner of the display, is fully lit and stable. Also, be sure there is sufficient signal amplitude in order to avoid 'peak jumping' or missing the first cycle.

Adjusting the Gate

Π key once to activate the measure menu items. Press the 1) Press the п key multiple times to move right and the esc key multiple times to move left, until the **GATE1** cell is highlighted. Alternatively, press the arrow keys multiple times using the left button wheel. and arrow keys on the right button wheel to move the 2) Press the and gate over the waveform to be measured, as demonstrated in the screen shot above. **Note:** In order to trigger on a signal, the waveform must be inside the

Calibrating the Second Point

boundaries of the gate.

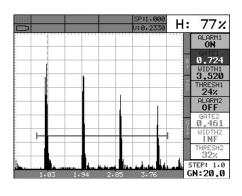
1) Press the key multiple times to tab right and the key multiple times to tab right and the key multiple times to			
tab left until the CAL menu is highlighted and displaying the submenu items, as shown in the screenshot above. Alternatively, press the and			
arrow keys multiple times using the left button wheel.			
2) Use the and and arrow keys multiple times on the left button			
wheel to scroll through the sub menu items until MATL 2PT is highlighted.			
MATL 2PT			
4.000			
OK ESC			
3) Press the every to display the Digits Edit Box .			
4) Press the and and arrow keys multiple times on the left			
button wheel to scroll the highlighted value.			
5) Press the V and V arrow keys multiple times using the left button			
wheel to scroll the digit locations.			
6) Repeat steps 4 & 5 until the known thickness value is correctly displayed.			
7) Press the $\overset{o\kappa}{\checkmark}$ key to calculate the velocity and return to the menu			
screen, or 💭 to cancel the one point calibration.			

[CALIBRATE			
	MAT			CUSTOM
	MATL 1	эт		1.000
	MATL 2	ΡŢ		4.000
	VELOCI:	TΥ		0.2330
	ZERO			0.2
	PRB	CAL	DISP	TUNE

Note: A velocity and zero value will be calculated and displayed in the fields a shown above.

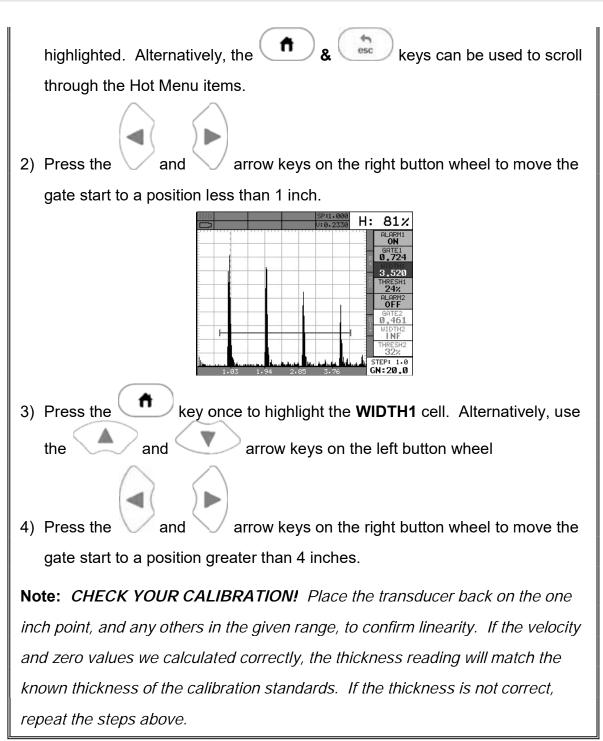
8) Finally, press the *key* to return to the measurement screen.

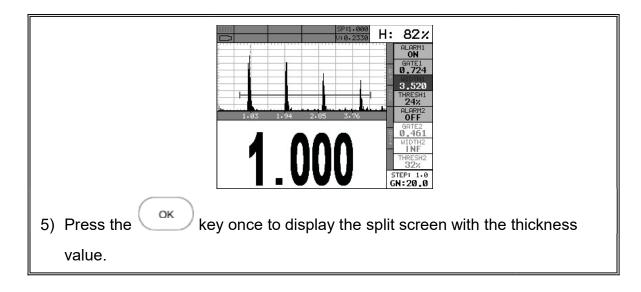
In order to trigger on anything that's detected in the calibrated range, the boundaries of the gate must be adjusted to include the entire range. **Caution:** in both z-cross & flank detection settings, the first signal to cross the gate will be triggered on. However, if the **peak** detection setting has been enabled, the signal with the most amplitude will be detected.



Adjusting the Gate to Calibrated Range

Using the left button wheel, press the and arrow keys to scroll through the 9 individual Hot Menus, and the and arrow keys to scroll through the Hot Menu items until the GATE1 cell is





5.3 Angle Beam Calibration

In the first example we demonstrated how to perform a two point calibration using a single element straight beam contact transducer. With the exception of a handful of additional comments, calibration using an angle beam transducer is virtually identical in the scope of the overall step by step process. To avoid copying the procedures from the previous section, we'll focus only on the additional comments. Refer to section 5.1 and 5.2, regarding the procedures to setup and calibrate the *FX80*. The following are a list of additional items to consider when using an angle beam transducer, as follows:

Calibration Standards:

There are a number of calibration block options available in a variety of common material types, and according to specific code requirements. The user should consider the application, codes applicable, and purchase the necessary calibration standards.

Shear versus Longitudinal Velocity:

Unlike the previous straight beam calibration, which uses a longitudinal wave, an angle beam transducer uses a shear wave. The following is a brief review of the waves:

- Longitudinal
 - o Particle motion is parallel to the direction of wave travel.
 - o Travels in solids, liquids, and gasses.
 - Fastest mode of vibration.
- Shear
 - o Particle motion is perpendicular to the direction of wave travel.
 - o Travels only in solids.

- o Is approximately $\frac{1}{2}$ the velocity of longitudinal waves.
- Has a shorter wavelength than a longitudinal at the same frequency.

Therefore, a two point calibration using an angle beam transducer will result in a velocity approximately $\frac{1}{2}$ the speed of the velocity calculated from the straight beam calibration in the previous section.

Gain and Amplitude Ratio:

During an angle beam calibration the overall amplitude height of the waveform is critical for "peaking up". Therefore the maximum amplitude of the waveform must be visible on the display in order to correctly position the transducer on the calibration standard. The user should select a screen height and gain level that will enable the entire waveform to be visible on the display.

Peaking Up the Signal Amplitude:

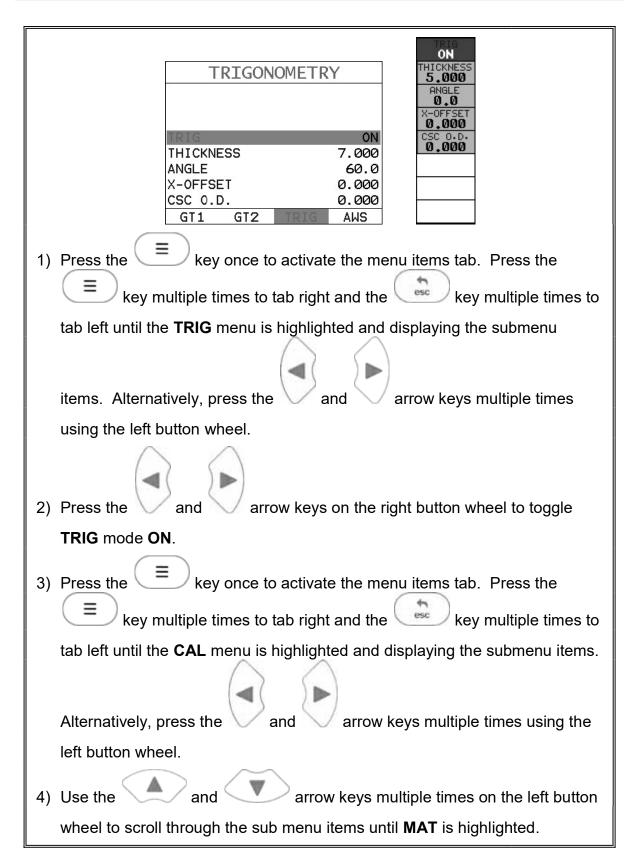
During an angle beam calibration, it's important to peak up the overall amplitude of the waveform to its maximum potential. The primary purpose is to be sure the transducer is positioned properly on the calibration standard, that's producing return echoes at different distances. **For example:** If the operator is using a DSC block to calibrate the velocity and zero, a DSC block will produce echoes at 1 & 5, or 3 & 7 inches. The operator then positions the transducer on an index point, moves the transducer in both directions forward and backward, rotates it side to side, and watches the signal amplitude to find the maximum potential. At the maximum potential, the transducer is correctly positioned to measure both multiple echoes at the correct distances, and ready to proceed with the calibration.

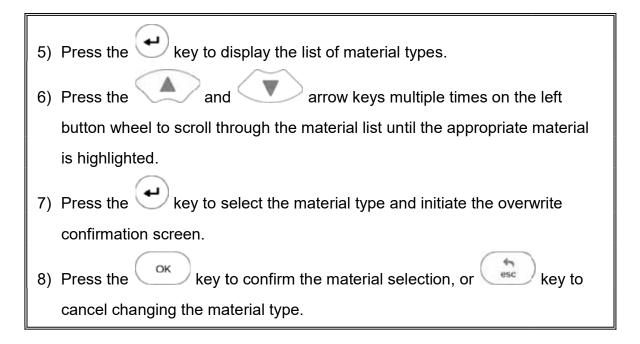
Selecting the Material Type:

The user can also select a material type directly from a table built into the *FX80* with shear wave values. This would only get the user close, in terms of velocity, to the calibration standards material type. In order to display the material chart with shear wave values, the **TRIG** mode must be enabled. The following outlines the steps to enable the shear wave velocity table and select a material type from the chart:

For quick access and editing, refer to navigating the Hot Menus page 23.

Selecting the Material Type





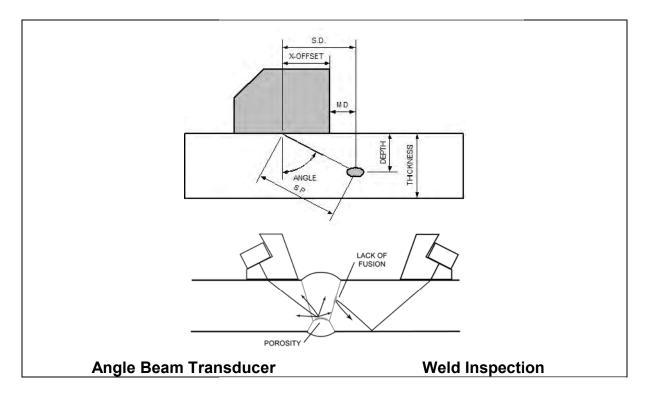
CHAPTER SIX TRIGONOMETRY MODE

6.1 Introduction to TRIG

Trig mode is most commonly used for inspecting welded joints using an angle beam transducer. Based on the location, orientation, and geometry of the weld, a straight beam transducer is typically not suitable for inspection. As a result, a transducer emitting sound at a given angle will allow the operator to position the transducer away from the actual weld, and "skip" into the weld at a given angle. Therefore, in order to determine the location of a defect, given a specific angle, the trigonometry mode is used. This section will cover the steps to setup and utilize trigonometry mode.

6.2 Additional Comments

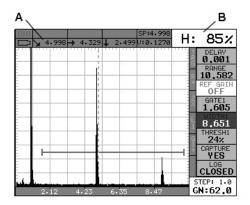
Prior to proceeding on to the next section outlining how to enable and setup the **TRIG** mode, a few additional items should be clarified:



Refer to the Angle Beam	Transducer diagram above:
	rianeaaeer alagram aberer

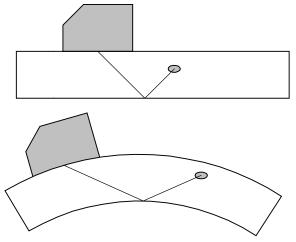
SP – Sound Path	X-Offset – Front of wedge less Index
Angle – Transducer Angle	SD – Surface Distance
Thickness – Material Thickness	Depth – Depth of flaw from surface

Screenshot Trig mode:



When **TRIG** mode is enabled, the calculated measurements will be displayed below the waveform display area at (A), and the signal amplitude as a percentage of full screen height at (B).

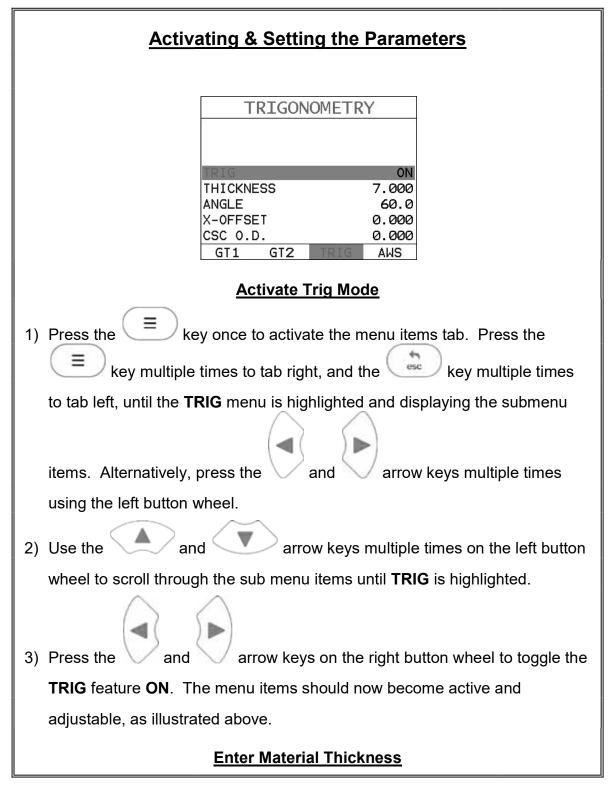
Curved Surface Correction:



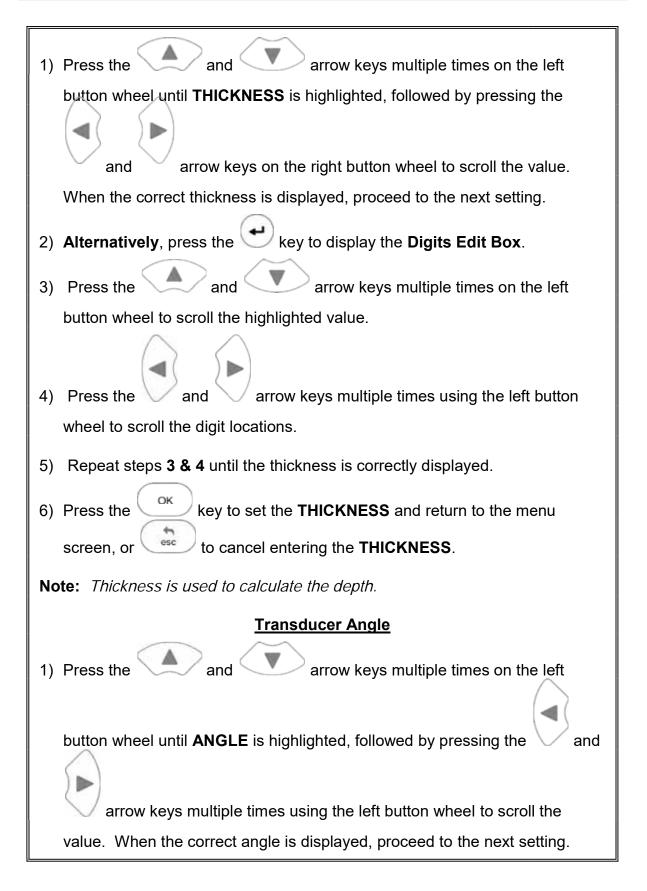
The *FX80* will also compensate for convex curved surfaces of longitudinally welded pipes. A curved surface will produce a greater sound path than a flat surface will, using a transducer with a given angle. The user should consider the angle used on curved surfaces, with respect to the material thickness, in order to be sure a reflection will occur from the opposite surface of the test material. In order to utilize the curved surface compensation, the outside diameter must be entered into the *FX80*.

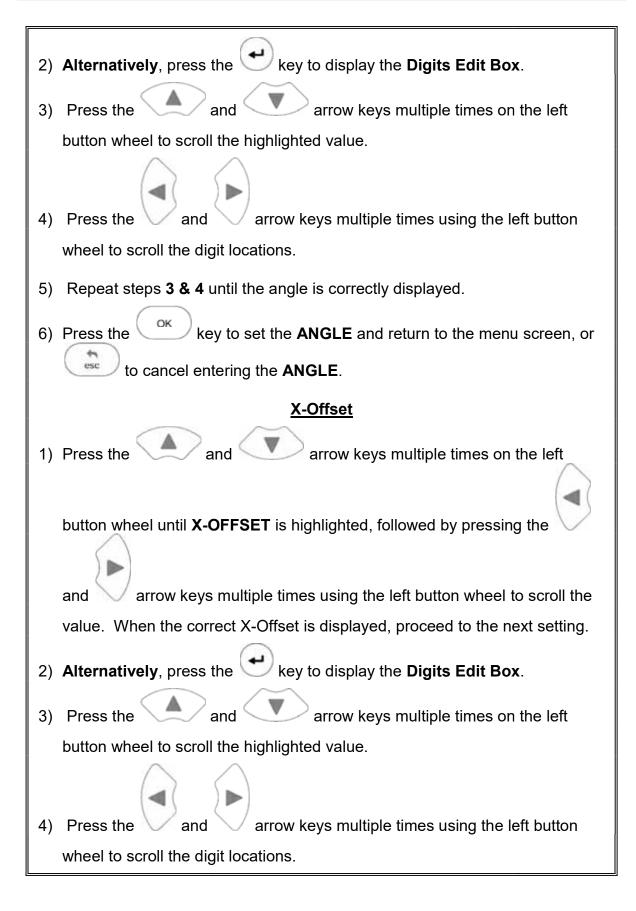
6.3 Setup Trigonometry Mode

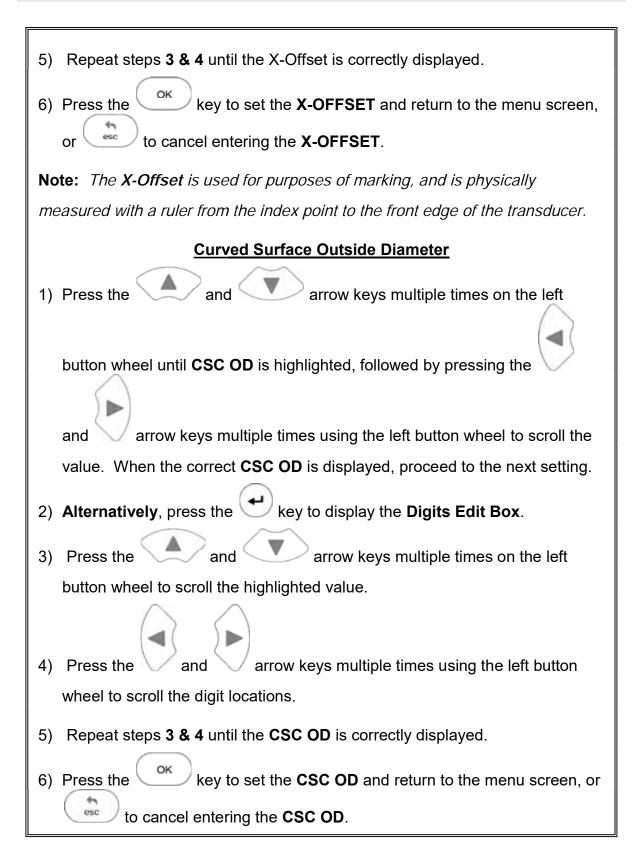
This section provides a step by step procedure to enable and setup the **TRIG** mode. **Note:** A two point calibration should be done prior to proceeding. Refer to Chapter Five for the calibration procedures.



For quick access and editing, refer to navigating the Hot Menus page 23.







Note: The *CSC OD* value is only used for curved surfaces of longitudinally welded pipes.

CHAPTER SEVEN AWS – WELD INSPECTION

7.1 Introduction to AWS

AWS provides a toolkit for evaluating defects according to the American Welding Society D1.1 welding code. The code offers inspectors a method to classify discontinuities by calculating an Indication Rating (IR) using ultrasonics. This toolkit can be used in conjunction with **TRIG** mode, outlined in the previous chapter, to simultaneously display the sound path (SP), surface distance (SD), and depth (D). The following sections provide an outline for using the **AWS** feature.

7.2 Additional Comments

Since the *FX80* is a gain controlled instrument, the following formula applies:

$$A - B - C = D$$

Where:

A = Discontinuity Indication Rating (DI)

B = Reference Indication Level (IL)

C = Attenuation Factor (AF); or 2(SP - 1)

SP = sound path in inches (2dB loss per inch of material thickness)

D = Indication Rating (IR)

Note: all values are in dB.

Calibration Standards & Calibration:

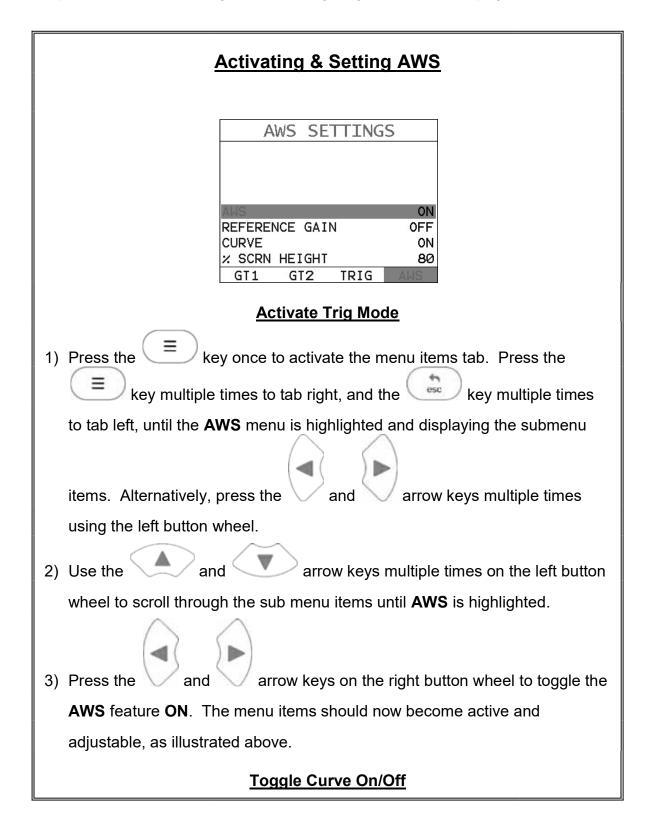
In order to use the **AWS** feature, the operator must have calibration standards made with the same size reflector at different distances within the testing range. The standards should also be made of the same material type as the material to be inspected.

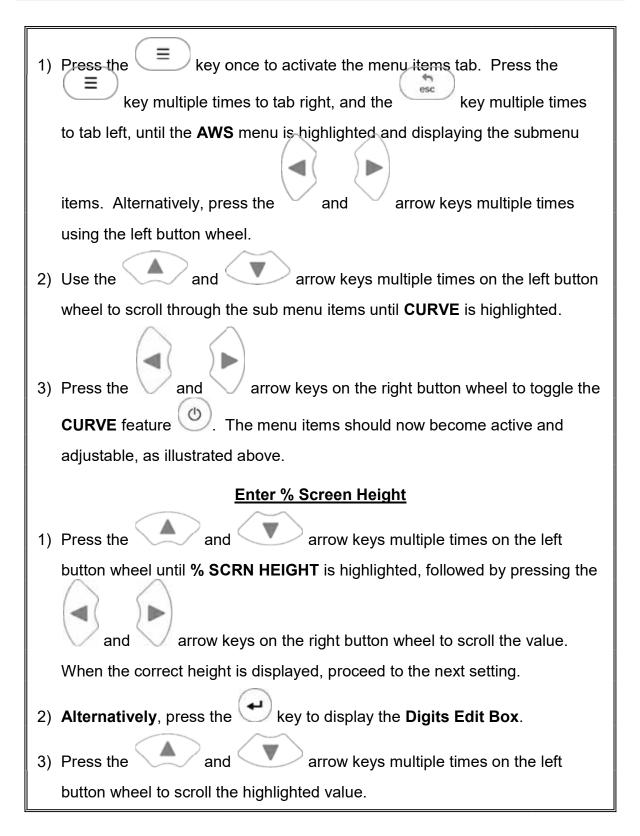
AWS D1.1 Standard:

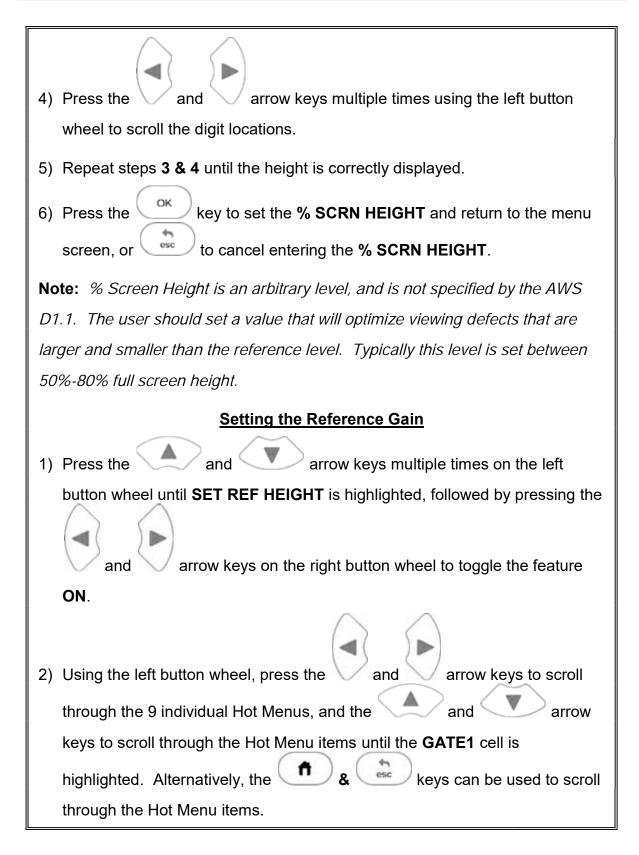
There are specific transducers that are required by the D1.1 standard. The frequency specified by the standard is 2-2.5MHz. The user should refer to the standard for further information.

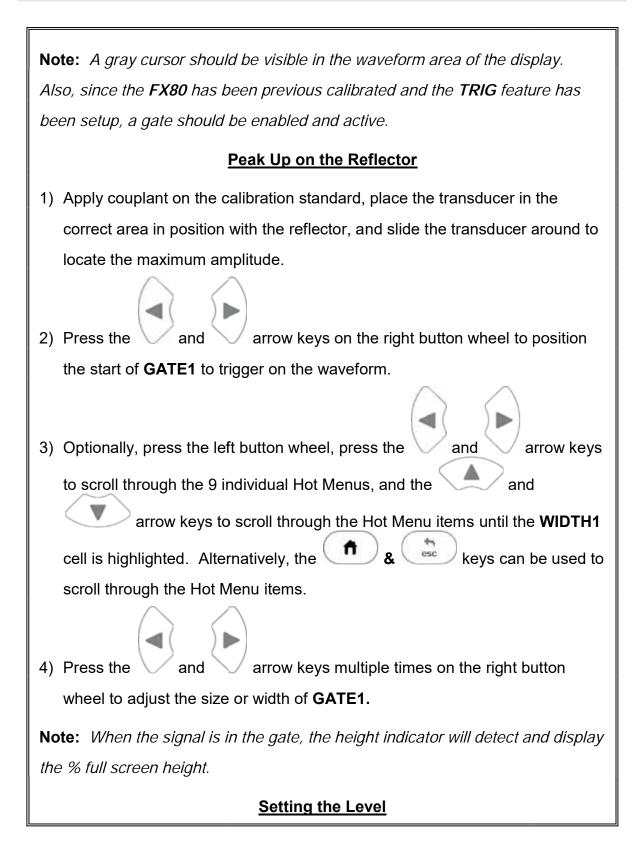
7.3 Setup AWS

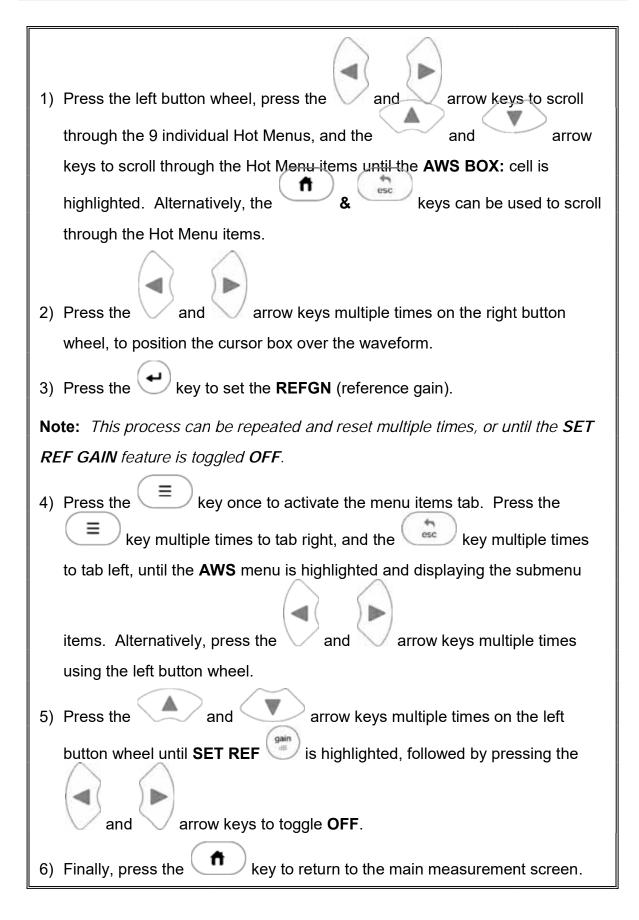
This section provides a step by step procedure to enable and setup the **AWS** feature. **Note:** A two point calibration should be done prior to proceeding. Refer to **Chapter Five** for the calibration procedures. The **TRIG** mode will also be used for weld inspection, and should additionally be setup prior to enabling the **AWS** feature. Refer to **Chapter Six** for instructions on setting up **TRIG** mode. For quick access and editing, refer to navigating the Hot Menus page 23.











CHAPTER EIGHT DISTANCE AMPLITUDE CORRECTION (DAC)

8.1 Introduction to DAC

A **DAC** curve is a gate with a variable threshold to compensate for a given reflector type and size measured at different depths. Unlike a standard gate, which typically has a fixed threshold level regardless of the depth, the **DAC** curve is more representative of the reflector size at different depths. In order to generate a **DAC** curve, calibration standards must made with the same material being inspected, the representative reflector size, and over a given thickness range. The **DAC** curve is then used as an alarm to inform the user about the size of any given reflector at any depth during the inspection process.

Once the **DAC** curve has been established, the user can display; -2dB, -6dB, -10dB, -12dB, -6/-12dB, -6/-14dB, DAC or GATE at any time. The initial **DAC** curve generated is always displayed in conjunction with any of the above **CURVE** options. Additionally, the alarm can be set to **TRIGGER** on any of the curve options displayed. Therefore, if the -6/-12dB curve option has been selected, the user can toggle the **TRIGGER** options: GATE, DAC, -6dB, or -12dB.

Note: Based on the screen resolution of the **FX80**, the dynamic range of the **DAC** is approximately 18dB. As a result, inspection of any materials that attenuate more than 18dB over the inspection range, the **DAC** feature should not be used, and **TCG** (Time Corrected Gain) should optionally be considered.

8.2 Additional Comments

Prior to proceeding onto the next section to create a **DAC** curve, a few additional items will help with the users selection process in the menu items:

- Up to 16 points can be used to generate a **DAC** curve.
- 3 or more points must be used in order to draw a **DAC** curve.
- All the **DAC** curve or gate combinations only detect when the amplitude of the signal is 'at' or 'above' the selected trigger option.
- Any of the **DAC** curves or gate displayed, can be set as the trigger alarm option.
- The measure (meas) options are as follows:

<u>dB</u> –

 $\underline{\text{MDAC}}$ – At the **DAC** curve represents 100%. Any signal generating an amplitude below the **DAC** curve is less than 100%, and any above greater than 100%.

 $\frac{\%FSH}{M}$ – The top of the waveform display represents 100% full screen height. Any waveform amplitudes generated greater than 100% full

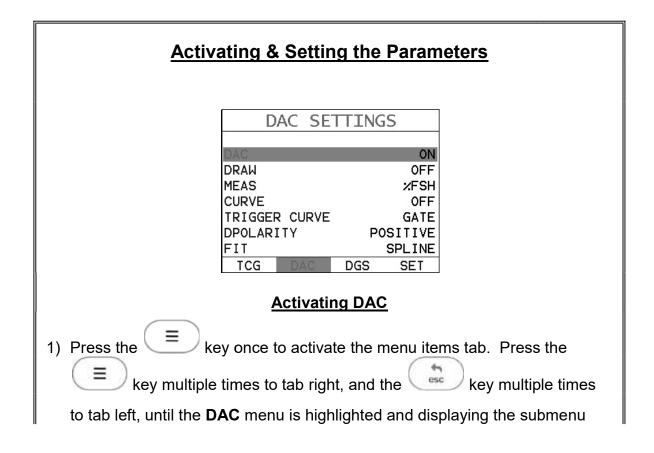
screen height will not be displayed. 100% is the greatest value that can be displayed.

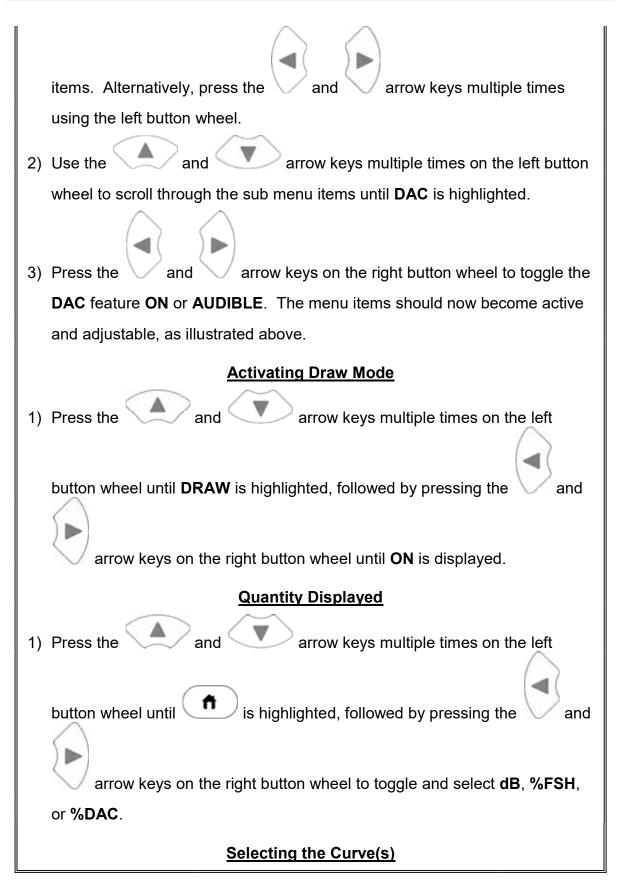
Note: The **MEAS** option selected is overridden with %FSH while the **DAC** curve is in **DRAW** mode. Once the **DRAW** mode is turned off, the select **MEAS** option will be displayed.

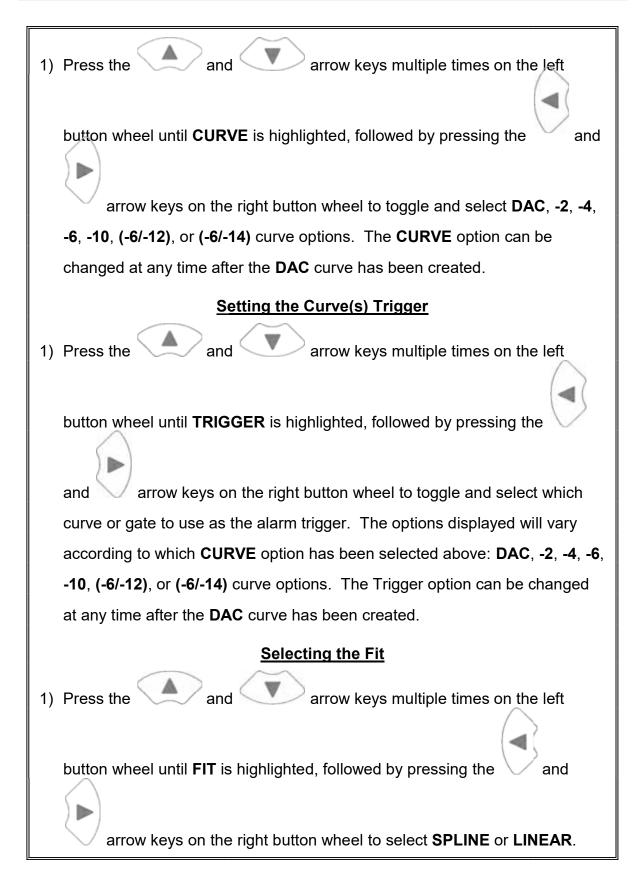
- The **MEAS**, **CURVE**, and **TRIGGER** options can be changed at any time once the **DAC** curve has been created.
- In order to move the highlighted cursor over a waveform to use as a point in generating the DAC curve, the "DAC BOX:" hot menu item in the main measurement screen must be highlighted.

8.3 Creating a DAC Curve

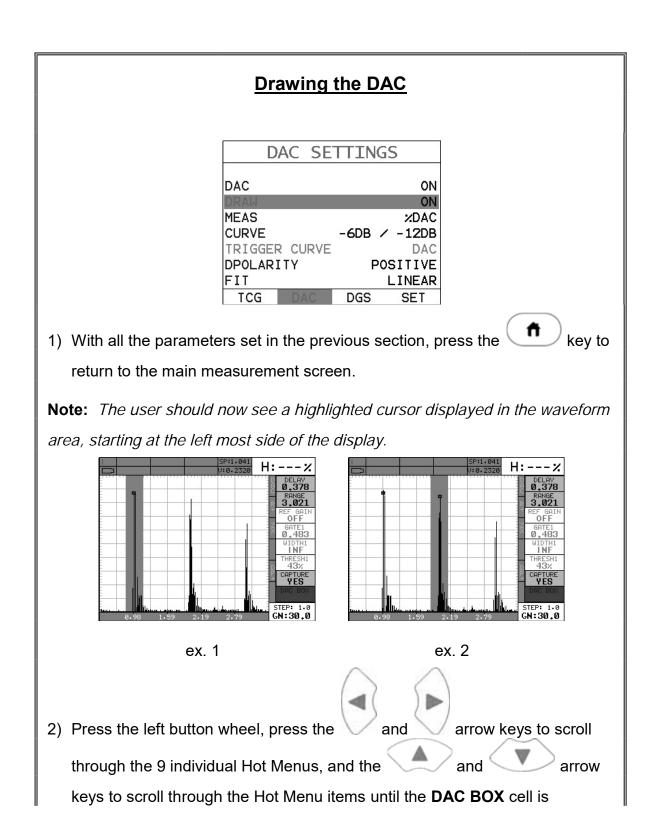
This section provides a step by step procedure to create a **DAC** curve. **Note:** A two point calibration should be done prior to proceeding. Refer to Chapter Five for the calibration procedures. Also, if the **TRIG** function will be used, it should be setup prior to proceeding. Refer to **Chapter Six** for the setup procedure.





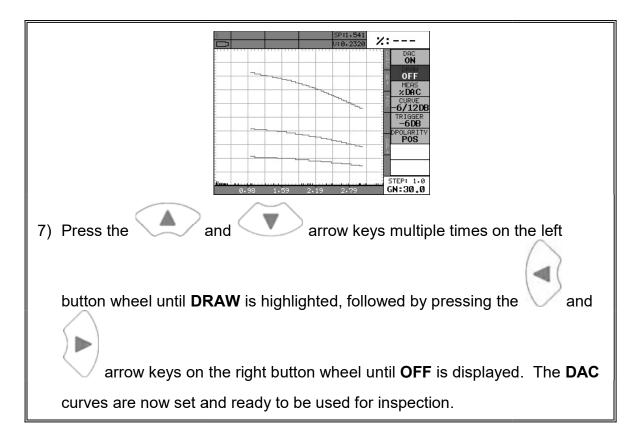


2) Proceed to the next section – Drawing the **DAC**.



highlighted. Now that the **DAC BOX** cell is highlighted, the cursor can be controlled by moving the and arrow keys on the right button wheel.

- 3) Couple the transducer to the first calibration standard, and peak up on the reflector, adjusting the gain to keep the signal height within the boundaries of the waveform display area, and at a suitable height to allow for attenuation at greater depths in the overall range to be tested.
- 4) Press the and arrow keys on the right button wheel to move the cursor over the waveform to be used as the first point in the DAC curve, and press the key to set the first point. Illustrated in ex.1 above.
- Repeat steps 3 & 4 to set multiple points as is necessary. Illustrated in ex.2 above.
- **Note:** The **DAC** curve will be displayed after 3 points have been set/recorded, and will continue to be redrawn/updated for each additional point added, with a maximum of 16 points allowed.
- 6) Press the key once to activate the menu items tab. Press the key multiple times to tab right, and the to tab left, until the **DAC** menu is highlighted and displaying the submenu items. Alternatively, press the using the left button wheel.



CHAPTER NINE TIME CORRECTED GAIN (TCG)

9.1 Introduction to TCG

The **TCG** feature increases gain as distance increases, in order to achieve an overall level of sensitivity for the same reflector at different distances. It is very similar to the **DAC** feature noted in a previous chapter. However, while a **DAC** curve plots points at given amplitudes and distances, generating a variable threshold, the **TCG** feature increases the gain at various distances to adjust the signal amplitude to a predetermined level of full screen height. Therefore, the amplitude of all signals at various distances will be displayed at the same reference level.

Note: One of the advantages of the **TCG** feature over the **DAC** option is the dynamic range. The **TCG** feature has a maximum dynamic range of 50dB, while the **DAC** option is approximately 18dB. Therefore the **TCG** feature is a better solution for any materials that attenuate more than 18dB over the inspection range, and should be considered.

9.2 Additional Comments

Prior to proceeding onto the next section to create a **TCG** curve, a few additional items will help with the user selection process in the menu items:

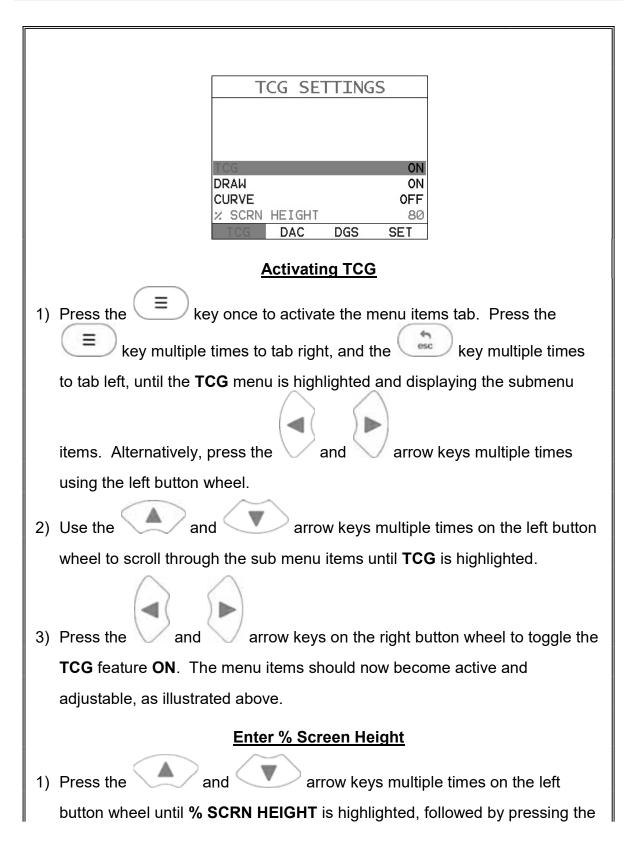
- Up to 16 points can be used to generate a **TCG** curve.
- 3 or more points must be used in order to draw a **TCG** curve.
- The gain will be adjusted at each point to display the signal amplitude at a predetermined reference level.
- In order to move the highlighted cursor over a waveform to use as a point in generating the **TCG** curve, the **"TCG BOX:**" hot menu item in the main measurement screen must be highlighted.

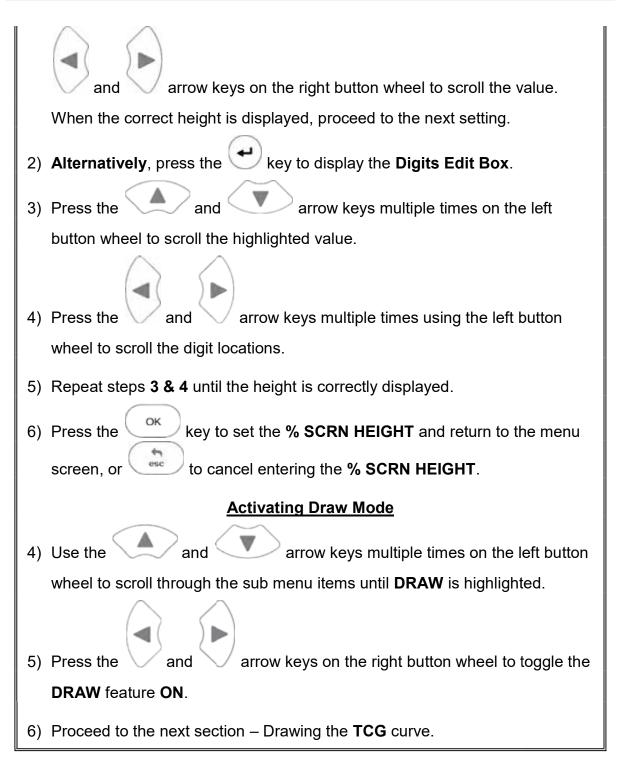
9.3 Creating a TCG Curve

This section provides a step by step procedure to create a **TCG** curve. **Note:** A two point calibration should be done prior to proceeding. Refer to **Chapter Five** for the calibration procedures. Also, if the **TRIG** function will be used, it should be setup prior to proceeding. Refer to **Chapter Six** for the setup procedure.

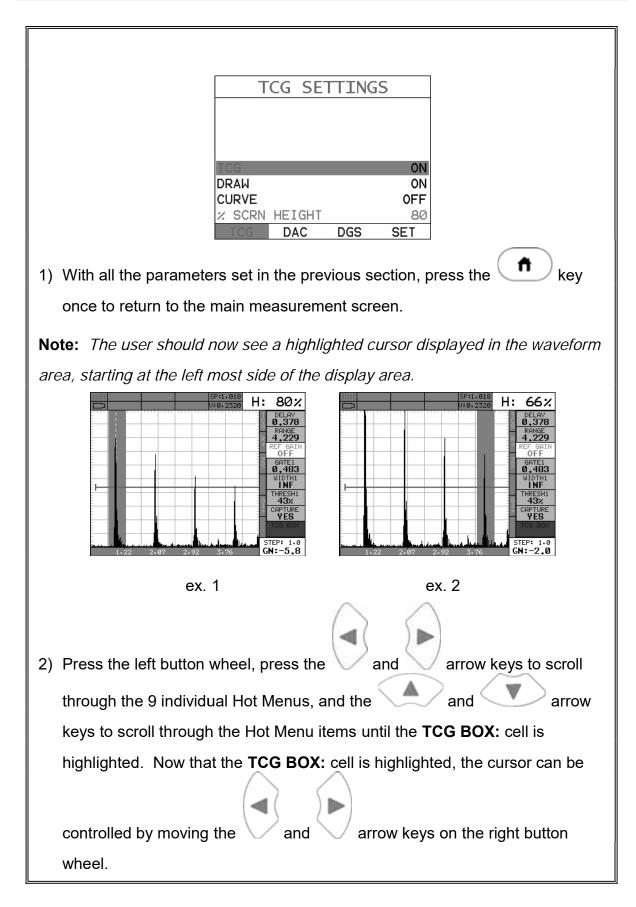
For quick access and editing, refer to navigating the Hot Menus page 23.

Setting TCG Parameters

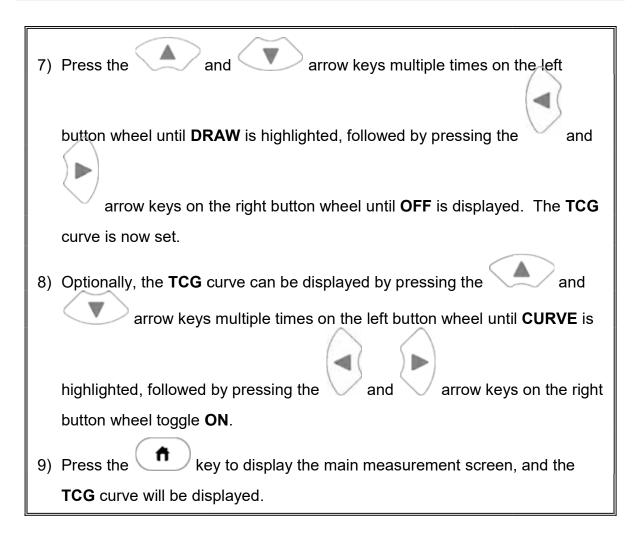




Drawing the TCG



3) Couple the transducer to the first calibration standard, and peak up on the reflector to achieve maximum signal amplitude. arrow keys on the right button wheel to move the 4) Press the and cursor over the waveform to be used as the first point in the TCG curve, and key to set the first point. Illustrated in ex.1 above. press the 5) Repeat steps 3 & 4 to set multiple points as is necessary. Illustrated in ex.2 above. Note: You must set 3 points to draw a TCG curve, and a total of 16 points can be set. Any point can be cleared by pressing the clr key when DRAW is active. = key once to activate the menu items tab. Press the 6) Press the Ξ esc key multiple times to tab right, and the key multiple times to tab left, until the **TCG** menu is highlighted and displaying the submenu items. Alternatively, press the and arrow keys multiple times using the left button wheel. 82% н: 0N OFF OFF STEP: 1.0 GN:0.0

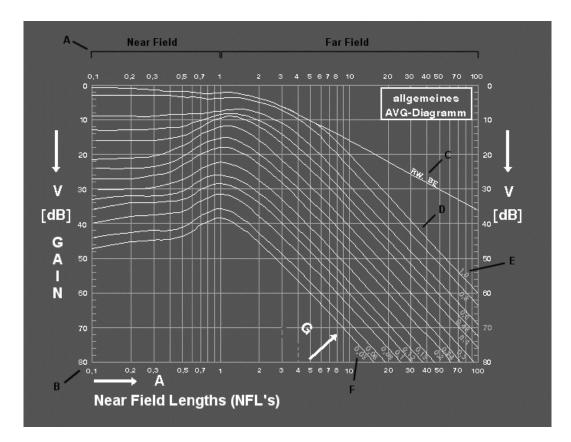


CHAPTER TEN DISTANCE, GAIN, SIZE (DGS)

10.1 Introduction to DGS (AVG)

The **DGS** (Distance, Gain, Size) method was introduced in 1958 as a way to standardize the process of evaluating and sizing defects, also referred to by the German acronym **AVG**. This method uses a combined empirical and mathematical model to eliminate the need for a large range of reference standards, generally required when using the **DAC** or **TCG** methods. **DGS** can be thought of as a mathematically derived **DAC** curve, and used as an alternative replacement for **DAC**.

The concept of the **DGS** method is to compare the amplitude/gain of similar reflectors at different distances and sizes, to mathematically approximate the size of the defect using the effective probe diameter, frequency and near field length (NFL). The reference to 'similar reflectors' assumes that the orientation of the reflector is the same for all sizes, which is unrealistic to assume during actual field testing. The diagram below illustrates the mathematically derived set of curves used for **DGS**:



Considerations:

- Should only be used with single element probes.
- The effective diameter must be estimated for standard transducers not certified for **DGS**.
- Center frequency clarity is required. Highly damped transducers can sometimes produce a broadband frequency range, and should not be used.

10.2 DGS Diagram

In order to get familiar with the **DGS** diagram, let's take a look at some of the general concepts. The near and far fields are referenced at point **(A)**. In the near field the wave front is not as uniform or consistent as the far field. As a result, the evaluation of flaws/defects are optimized in the far field when the wave front becomes uniform. Evaluating defects less than .7 NFL's is marginal at best.

The **DGS** diagram uses a logarithmic scale for both the Gain (dB) y axis, and near field length (NFL) distance at **(B)**. The curve at **(C)** is the back wall reflector. It's important to note that when the distance is doubled, the sound energy decreases by 1/2 (-6dB). However, a defect/reflector that's less than or equal to the effective diameter of the transducer, doubling the distance decreases the sound energy by 1/4 (-12dB), at **(D)**.

The curve at **(E)** represents a defect that is equal to 100% the effective diameter of the transducer, while 5% the effective diameter at **(F)**. As an example for using this diagram to determine a reflector size, consider the following: If I set my gauge for 80% screen height on a back wall reflector at 5 NFL's, and found a defect also at 5 NFL's, but at 80% ($1/10^{th} = 20dB$), the ERS would be 30% of the effective diameter.

10.3 Estimating Effective Diameter

There are a number of transducers that are specially documented as *DGS/AVG* transducers. What this typically infers is that the effective diameter, near field length, and center frequency have been determined and documented on the transducer certificate. If **DGS/AVG** transducers are being used, the values for effective diameter and frequency can simply be entered into the *FX80*. However, if a standard transducer will be used and has a standard transducer certificate, the effective diameter must be estimated in order to determine the near field length (NFL).

Calculating NFL

$$N = \frac{D_{EFF-\lambda^2}^2}{(4\lambda)}$$

Where: N = Near Field Length DEFF = Effective Diameter λ = Wave Length (velocity/frequency)

In order to approximate the effective diameter, the shape of the crystal must be taken into account. Transducers are either round or square/rectangular in shape, and can be approximated as follows:

Round Crystal (DEFF)

$$D_{EFF} = (Dia.)(.97)$$

Where:

DEFF = Effective Diameter

Dia. = Diameter of the crystal

0.97 = Fixed ratio

Square/Rectangle (DEFF)

$$K = 0.6935 \left(\frac{B}{A}\right)^3 - 0.3753 \left(\frac{B}{A}\right)^2 + 0.0661 \left(\frac{B}{A}\right) + 0.9863$$

Where:

K = Aspect RatioA = Largest DimensionB = Smallest Dimension

$$D_{EFF} = 0.97 \left(\sqrt{K}\right)(A)$$

Where: D_{EFF} = Effective Diameter K = Aspect Ratio

A = Largest Dimension 0.97 = Fixed Ratio

Calculated results can also be compared to the following table:

B/A	K
1.0	1.37
0.9	1.25
0.8	1.15
0.7	1.09
0.6	1.04
0.5	1.01
0.4	1.00
0.3	0.99
0.2	0.99
0.1	0.99

10.4 Parameter Definitions DGS(AVG)

This section outlines the parameters in the DGS/AVG toolbox, and provides a brief definition of each parameter:

DISTANCE GA	IN	DISTANCE GAIN
DGS	ON	EFF PROBE DIAMETER 0.000
REFERENCE GAIN	OFF	PROBE FREQUENCY 0.00
TRIGGER CURVE	DAC	CURVE SIZE (ERS) 0.000
EFF PROBE DIAMETER	0.000	ATTENUATION OFF
PROBE FREQUENCY	0.00	DELAY VELOCITY OFF
CURVE SIZE (ERS)	0.000	REFERENCE TYPE BACK WALL
ATTENUATION	0FF	REFERENCE SIZE N/A
<more></more>		<more></more>
TCG DAC DGS	SET	TCG DAC DGS SET

DGS: Activate the DGS on/off.

<u>Reference Gain:</u> Activated to set the reference gain using a given reflector from a calibration standard.

Dakota NDT

<u>Trigger Curve</u>: Enables the user to set the detection curve to either **DGS** or **GATE**. This will be the curve used to trigger the alarms and display the effective reflector size (ERS) during the inspection process.

Effective Probe Diameter: A variable used to calculate the near field length of a given transducer, and determine the defect size. The effective diameter will be noted on the transducer calibration certificate for a standard DGS transducer. However, this can be estimated using the formulas outlined in section 10.3.

<u>Probe Frequency:</u> Refers to the center frequency of the transducer being used, and used in the calculation of the near field length.

<u>Curve Size (ERS)</u>: Used to select which curve will be used, based on the reflector size, from the DGS(AVG) chart in section 10.1. If the value entered is not an exact curve value represented in the diagram, the *FX80* will compare and interpolate between the two closest curves, and mathematically derive a curve for that value.

<u>Attenuation</u>: Used to additionally compensate other factors leading to the loss of sound/energy. Refer to section 10.5 for more information on the attenuation parameters. If all the attenuation values are set to zero, the attenuation feature will display off.

Delay Velocity: The longitudinal velocity of the delay line, most commonly used with angle beam style probes, but also used with 90 degree compression probes. It's important to note that in order for this to be accurate, the 'probe zero' must be accurate. This is easily accomplished performing a two point calibration (auto cal).

<u>Reference Type:</u> This option enables the user to select the type of reflector that will be used during calibration and setup. The options are Back Wall, Flat Bottom Hole (FBH), or Side Drilled Hole (SDH).

<u>Reference Size:</u> Assuming the reference type selected is either FBH or SDH, the user will be required to enter the size of the reference reflector.

10.5 Attenuation Parameters

The attenuation section is setup to accommodate additional factors that can affect the accuracy of the amplitude or sound energy, considering different application scenarios. The following parameters are outline below:

DGS ATTENUAT	ION
5072	
DVK	0.0
MATERIAL LOSS	0.0
REFERENCE LOSS	0.0
TRANS LOSS	0.0
and an and a second sec	

DVK (Curvature Correction): If a V1/K1 or V2/K2 (A2/A4, IIW/Kidney) calibration standard is used as a reference reflector, the curved surface offers additional focus

normally resulting in greater signal output. **DVK** is a correction to the gain, in order to simulate the amplitude generated from a flat back wall. This will typically result in an overall gain increase.

<u>Material Loss</u>: Used to correct for the attenuation (loss) of sound energy in the test material; in units of dB/in. or dB/meter. Should be considered during inspections where the sound has to travel long distances, or the material is very attenuative.

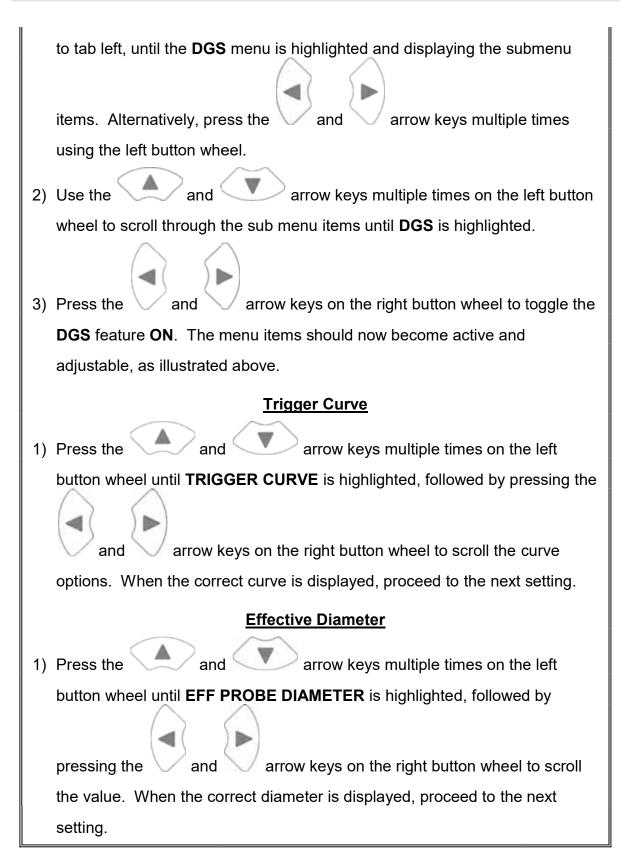
<u>Reference Loss</u>: Used to correct for the attenuation (loss) of sound energy in the calibration/reference standard; in units of dB/in. or dB/meter.

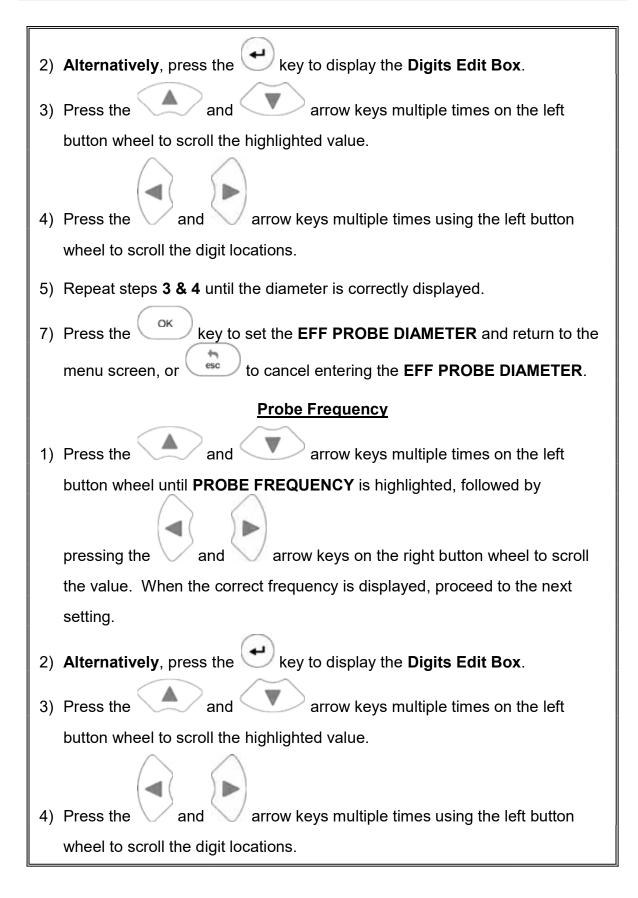
Transfer Loss: Correction factor to account for the loss of sound energy from surface condition/roughness or inadequate coupling between the transducer and test specimen. The surface condition of calibration/reference standards and actual material being tested in the field will typically vary. This is generally approximated based on the inspectors experience in the field. Units are dB/in., or dB/meter.

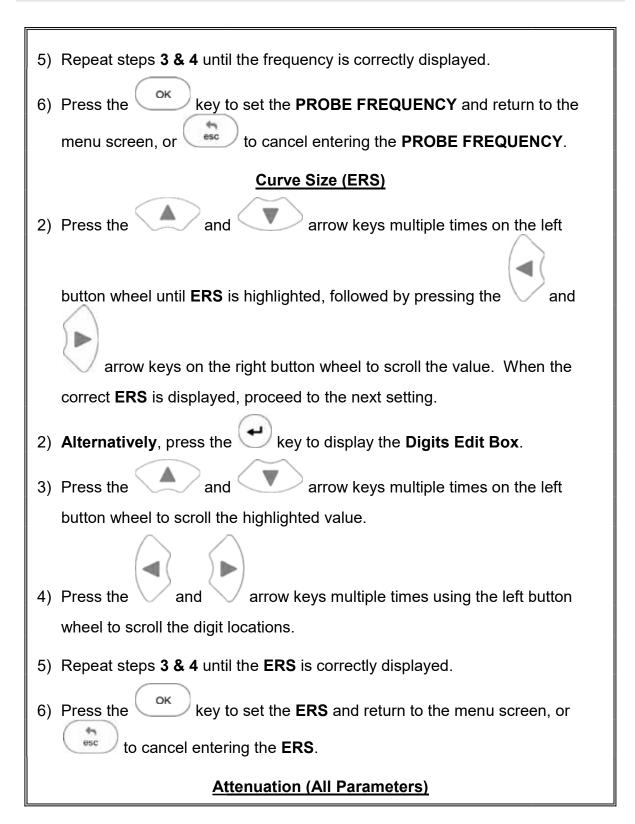
10.6 Creating a DGS Curve

This section provides a step by step procedure to create a **TCG** curve. **Note:** *a two* point calibration should be done prior to proceeding. Refer to **Chapter Five** for the calibration procedures. Also, if the **TRIG** function will be used, it should be setup prior to proceeding. Refer to **Chapter Six** for the setup procedure.

Setting DGS Parameters TCG SETTINGS ON DRAW ON CURVE **OFF** SCRN HEIGHT 80 DAC DGS SET Activating DGS kev once to activate the menu items tab. Press the 1) Press the _ esc key multiple times to tab right, and the key multiple times





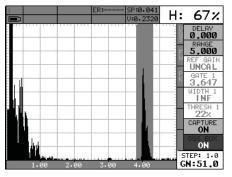


1)	Press the and and arrow keys multiple times on the left
	button wheel until ATTENUATION is highlighted, followed by pressing the
	key on the left button wheel to enter the ATTENUATION sub menu.
2)	Press the and arrow keys multiple times on the left
2)	button wheel to scroll the correct attenuation parameter is highlighted.
	button wheel to solor the concet attendation parameter is highlighted.
3)	Press the A and A arrow keys multiple times on the left
	button wheel until the desire attenuation parameter is highlighted, followed
	by pressing the V and V arrow keys on the right button wheel to
	scroll the value. When the correct value is displayed, proceed to the next
	parameter.
4)	Alternatively, press the even to display the Digits Edit Box.
5)	Press the and and arrow keys multiple times on the left
	button wheel to scroll the highlighted value.
	\bigcirc \bigcirc
C)	Dress the and arrow keys multiple times using the left butter
6)	Press the V and V arrow keys multiple times using the left button
	wheel to scroll the digit locations.
7)	Repeat steps 5 & 6 until the parameter value is correctly displayed.
8)	Press the ok key to set the value and return to the ATTENUATION
	sub menu screen, or locancel entering the parameter value.

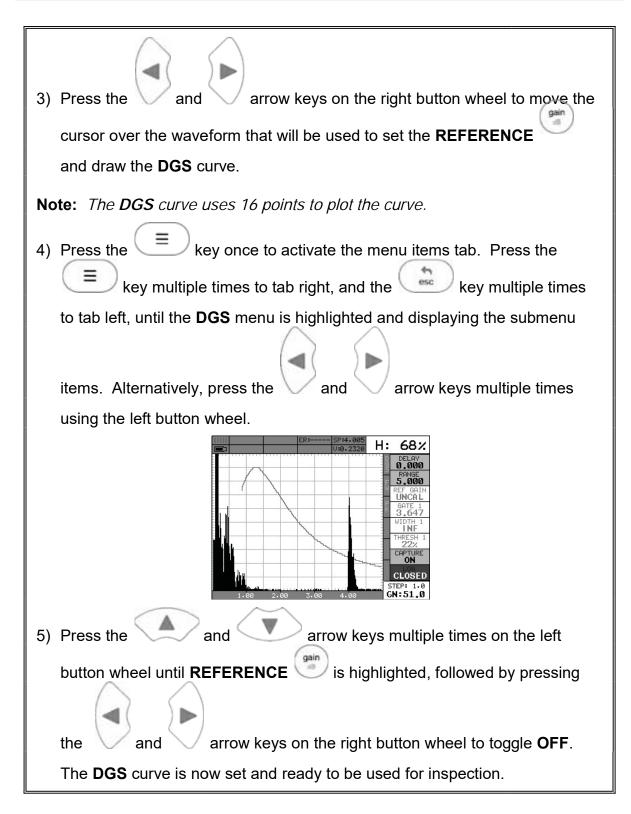
Drawing the DGS Curve

DISTANCE	GATN
DGS	ON
REFERENCE GAIN	ON
TRIGGER CURVE	DGS
EFF PROBE DIAME	
PROBE FREQUENCY	5.00
CURVE SIZE (ERS) 0.100
ATTENUATION	ON
<more></more>	
TCG DAC	DGS SET
1) Press the arrow	w keys multiple times on the left
button wheel until REFERENCE	s highlighted, followed by pressing
the 💚 and 💛 arrow keys on the i	right button wheel to toggle on. With
all the parameters set in the previous set	
return to the main measurement screen	l.

Note: The user should now see a highlighted cursor displayed in the waveform area, starting at the left most side of the display. Also note that the **DGS BOX** will be highlighted in the hot menus on the right of the display.



2) Couple the transducer to the first calibration standard, and peak up on the reflector, adjusting the gain to keep the signal height within the boundaries of the waveform display area, and at a suitable height to allow for attenuation at greater depths in the overall range to be tested.



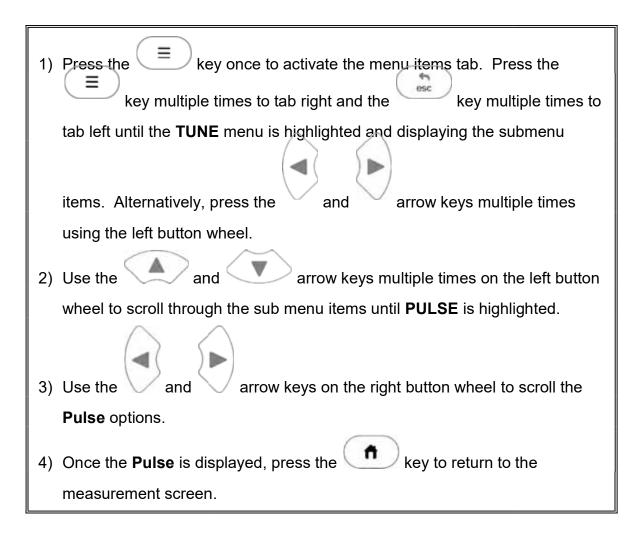
CHAPTER ELEVEN ADDITIONAL FEATURES OF THE FX80

11.1 Pulse Width

The *FX80* has a square wave pulser with adjustable pulse width option. Pulse width, refers to the duration of time the pulser is left on. This time results in increased energy sent into the test material. There are three width options (**SPIKE**, **THIN**, and **WIDE**). The **SPIKE** setting may be desirable for high resolution and general applications to decrease the overall noise. When additional energy is needed, more penetration, the **THIN** and **WIDE** options may be necessary. The standard setting is **THIN**.

The *FX80+* is equipped with a "Tone Burst" style pulser, and supplies a constant amplitude pulse to the transducer for a set amount of time, which is adjustable. The key advantage using this type of pulser is that the frequency of the generated pulse can be tuned to the frequency of the transducer, the bursts can be adjusted/optimized, a clean narrow band ultrasonic wave produced, and exceptional output at a given voltage. Therefore, the output of a general square wave pulser at 400V is approximately 12dB less than a tuned 400V tone burst style pulser. The options for the *FX80+* pulse width settings are; **Spike, Thin, Wide, HV Spike, HV Thin, HV Wide, TB 10MHz, TB 5MHz, TB 2MHz, and TB 1MHz**. Depending on the setting selected, the pulser voltage options will include the applicable settings/options (i.e. if Thin is selected, the max output voltage option is 200V. However if HV Thin is selected, the max output voltage option is 400V – HV or high voltage, etc.). Once the pulse width option has been selected, refer to the pulser voltage menu option to adjust the desired voltage. The procedure to change the pulse width is outlined below:

Selecting th	e Pulse Widtl	<u>n</u>
SETUR	PROBE	
TYPE PULSE	SINGLE	
MAX PRF DAMPING PULS VOLT	250 600 200	
PRB CAL	DISP TUNE]



11.2 Pulse Repetition Frequency (PRF)

The *FX80* is equipped an adjustable pulse repetition rate, with adjustable settings of 8, 16, 32, 66, 125, 250, and 333Hz. The primary purpose is to control how fast the pulser is firing. The repetition rate is tied into the alarm LEDS. Therefore, when scanning at higher speeds, a higher repetition rate will make the alarm trigger more responsive. It's important to note that since the screen has a maximum refresh rate of 60Hz, or draws at 60 times a second, any **PRF** settings over this maximum will not be visible on the display. In fact, the human eye has a response rate of less than 60Hz.

The **PRF** setting will automatically be overridden according to the range set by the user. Long range settings will slow the **PRF** down automatically. Slower **PRF** settings will save on battery life. Therefore, if your current application doesn't call for fast scanning speeds, you can save battery life by selecting a slower **PRF**. The procedure to change the **MAX PRF** setting is outlined below:

	Setting the	Max PRF	
	SETUP	PROBE]
	TYPE PULSE	SINGLE THIN	
	MAX PRF DAMPING	2000 600	
	PULS VOLT	200 DISP TUNE	
	TRO CAL	DISP TONE	
1) Press the $=$ ke	ey once to activa	te the menu ite	ems tab. Press the
(≡) key multiple	times to tab righ	nt and the 🥼	key multiple times to
tab left until the PRB	menu is highligl	nted and displa	ying the submenu items.
Alternatively, press t	ne 🗸 and 🔪	arrow keys	multiple times using the
left button wheel.	\sim		
2) Use the 🔺 an	d 💌 arro	w keys multiple	e times on the left button
wheel to scroll throug	gh the sub menu	items until MA	X PRF is highlighted.
3) Use the and	 arrow keys (on the right but	ton wheel to scroll the
PRF options.			
4) Once the desired PR	F is displayed, p	press the $(\uparrow$	key to return to the
measurement screer	1.		

11.3 Damping

The *FX80* has an adjustable damping feature, enabling the user to select from a variety of settings according the transducer frequency and overall output. The range of the damping feature is 50-1500 ohms. The available steps are 50, 75, 100, 300, 600 and 1500 ohms. Lower frequency transducers require less damping because

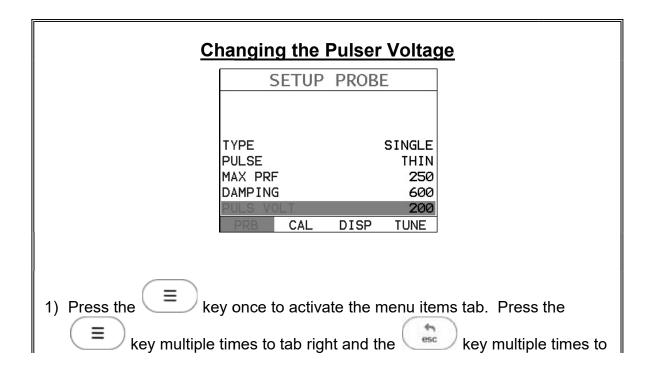
they typically have higher impedance and distort. The reverse is true for higher frequency transducers. Nevertheless, trial and error with this feature will enable you to find the optimal signal response and setting for your transducer. The procedure to change the **DAMPING** is outlined below:

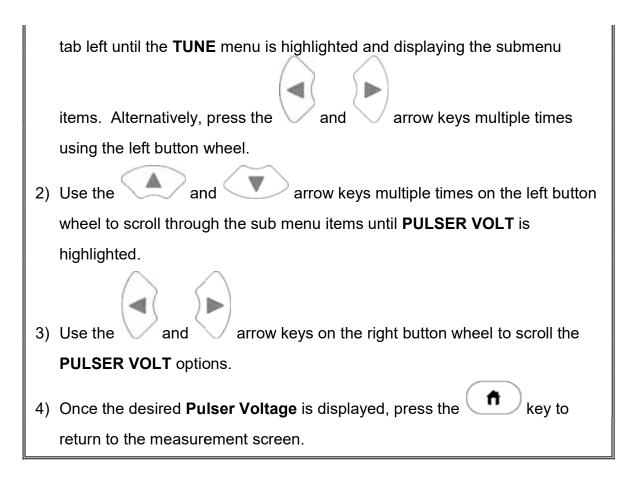
F				
	Selecting th	ne Dam	ping	
	SETUP	SETUP PROBE		
			<i>8</i> 5	
	TYPE PULSE MAX PRF DAMPING PULS VOLT	S	SINGLE THIN 2000 600 200	
	PRB CAL	DISP	TUNE	
	key once to activa e times to tab righ		4	ms tab. Press the key multiple times to
tab left until the PR	B menu is highligl	hted and	display	ving the submenu items.
Alternatively, press	the and		kovo n	nultiple times using the
		anow	кеузп	
left button wheel.	\sim			
2) Use the	nd v arro	w keys r	nultiple	times on the left button
wheel to scroll throu	igh the sub menu	items ur	ntil DAN	IPING is highlighted.
3) Use the 💚 and	✓ arrow keys of a strong keys of a s	on the rig	ght butt	on wheel to scroll the
DAMPING options.				
4) Once the desired D	AMPING is displa	ayed, pre	ss the	h key to return to
the measurement s	creen.			

11.4 Pulser Voltage

The *FX80* has a 200 volt square wave pulser that can be adjusted for specific applications and transducers. The Pulser Volt feature offers a 50 volt cut/boost option to the user. The standard setting is 200 volts. This enables the *FX80* to offer greater penetration for difficult material types, or increased resolution on noisy materials.

The *FX80+* is equipped with a "Tone Burst" style pulser, and supplies a constant amplitude pulse to the transducer for a set amount of time, which is adjustable. The key advantage using this type of pulser is that the frequency of the generated pulse can be tuned to the frequency of the transducer, the bursts can be adjusted/optimized, a clean narrow band ultrasonic wave produced, and exceptional output at a given voltage. Therefore, the output of a general square wave pulser at 400V is approximately 12dB less than a tuned 400V tone burst style pulser. The options for the *FX80+* pulse width settings are; Spike, Thin, Wide, HV Spike, HV Thin, HV Wide, TB 10MHz, TB 5MHz, TB 2MHz, and TB 1MHz. Depending on the setting selected, the pulser voltage options will include the applicable settings/options (i.e. if Thin is selected, the max output voltage option is 200V. However if HV Thin is selected, the max output voltage option is 400V – HV or high voltage, etc.). **Note:** *The Pulser Voltage menu option is used in conjunction with the Pulse Width menu option. Refer to the Pulse Width menu options to select the desired voltages intended.* The procedure to change the pulser voltage is outlined below:





11.5 Material Velocity Charts

The *FX80* has two material velocity charts built into the gauge with both longitudinal and shear material velocities. It should be noted that in order to display the chart containing the shear wave velocities the **TRIG** mode must be activated, as we've assumed an angle beam transducer will be used for the inspection process. The procedure is listed below:

Selecting a Ba	asic Material Ty	ype
CAL	IBRATE	
MATL 1PT	STEEL (1020) UNCAL	
MATL 2PT VELOCITY	UNCAL 0.2320	
ZERO PRB CAL	0.00 DISP TUNE	

1) Press the \equiv key once to activate the menu items tab. Press the key multiple times to tab right and the key multiple times to			
tab left until the CAL menu is highlighted and displaying the submenu items.			
Alternatively, press the \checkmark and \checkmark arrow keys multiple times using the			
left button wheel.			
2) Use the and arrow keys multiple times on the left button			
wheel to scroll through the sub menu items until MAT is highlighted.			
MATL TYPE			
25.QUARTZ GLASS 0.2260 26.RUBBER, YULCAN 0.0910 27.SILVER 0.1420			
29.STEEL (1020) 0.2320 29.STEEL (4340) 0.2330 30.STEEL, STAIN. 0.2230 31.TEFLON 0.0540 32.TIN 0.1310 33.TITANIUM 0.2400 34.TUNGSTEN 0.2040 35.URANIUM 0.1330 36.WATER 0.0580			
3) Press the every to display the list of material types.			
4) Press the and and arrow keys multiple times on the left			
button wheel to scroll through the material list until the appropriate material			
is highlighted.			
5) Press the every to overwrite the material type and display the menu			
items with the new material type selected.			
6) Finally, press the			
begin taking readings.			

11.6 Material Velocity

The *FX80* has a built in feature to manually adjust the material velocity to a known value in the calibration section of the *FX80*. It should be noted that this does not calculate the zero value like the two point calibration option does. Therefore, if the material velocity is changed you should check the calibration. The procedures for adjusting the velocity are outlined below:

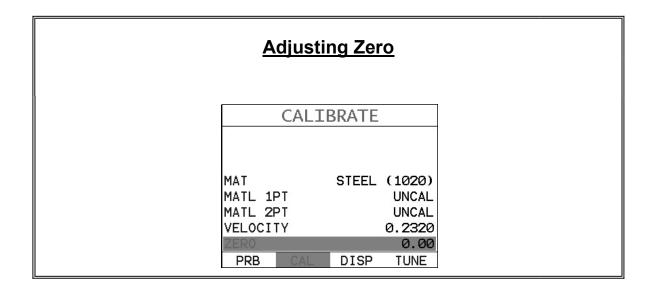
For quick access and editing, refer to navigating the Hot Menus page 23.

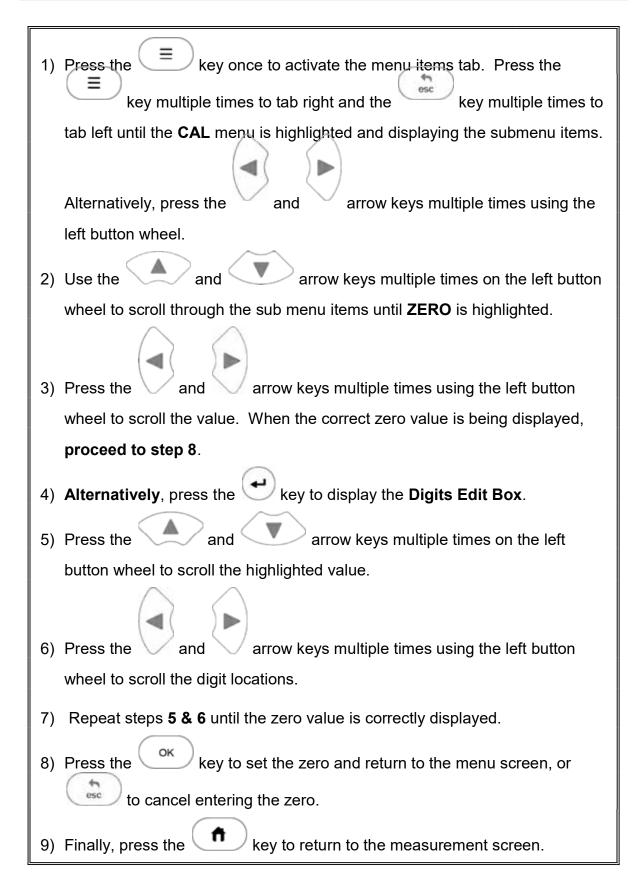
	Adjusting Veloc	city
	CALIBRATE	
	MAT STEEL MATL 1PT MATL 2PT VELOCITY ZERO PRB CAL DISP	(1020) UNCAL UNCAL 0.2320 0.00 TUNE
	ey once to activate the n times to tab right and th	menu items tab. Press the the key multiple times to
tab left until the CAL	menu is highlighted and	d displaying the submenu items.
Alternatively, press t	he and he arrow	w keys multiple times using the
left button wheel.		
2) Use the ar	nd 💌 arrow keys	s multiple times on the left button
wheel to scroll throug	gh the sub menu items ι	until VELOCITY is highlighted.
3) Press the \checkmark and	arrow keys on the	e right button wheel to scroll the
value. When the co	rect velocity value is bei	eing displayed, proceed to step
8.		

4) Alternatively, press the every key to display the Digits Edit Box.
4) Alternativery, press the V key to display the Digits Euli Box.
5) Press the and and arrow keys multiple times on the left
button wheel to scroll the highlighted value.
6) Press the \checkmark and \checkmark arrow keys multiple times using the left button
wheel to scroll the digit locations.
7) Repeat steps 5 & 6 until the velocity value is correctly displayed.
 8) Press the oκ key to set the velocity and return to the menu screen, or to cancel entering the velocity.
9) Finally, press the

11.7 Zero

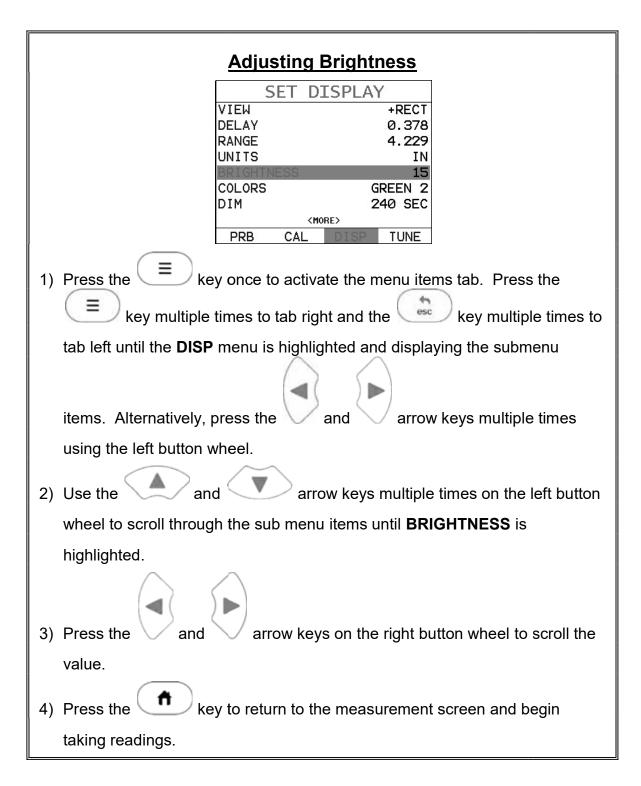
The *FX80* has a feature to manually adjust the electronic zero. This feature used in conjunction with manually adjusting the velocity, are the primary features necessary to perform a 'crude' manual screen calibration. The procedure for adjusting the zero is listed below:





11.8 Brightness

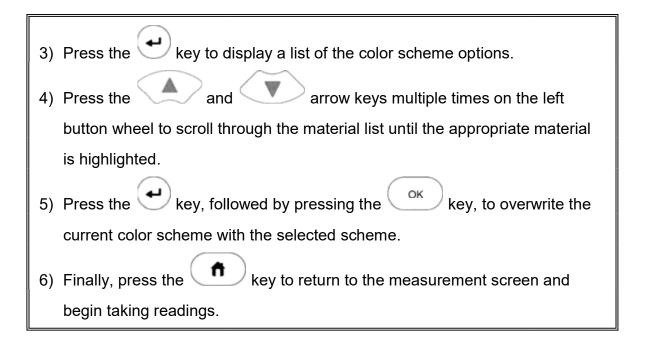
The *FX80* is equipped with a brightness feature to adjust the display visibility and optimize battery life. It has an arbitrary scale with values from 1-20, with 20 representing the brightest setting. The procedures for adjusting the brightness are outlined below:



11.9 Color Scheme

The *FX80* has a variety of display color options to select from. These will change the look and feel of the according to the users preference. The procedures for changing the **VIEW**, are outlined below:

Selecting a Color Scheme
SET DISPLAY VIEW +RECT DELAY 0.378 RANGE 4.229 UNITS IN BRIGHTNESS 15 COLORS GREEN 2 DIM 240 SEC (MORE> PRB CAL DISP TUNE
 Press the key once to activate the menu items tab. Press the key multiple times to tab right and the key multiple times to
tab left until the DISP menu is highlighted and displaying the submenu items. Alternatively, press the and arrow keys multiple times
using the left button wheel.
2) Use the and and arrow keys multiple times on the left button
wheel to scroll through the sub menu items until VIEW is highlighted.
SELECT COLOR 1. GREEN 1 2. GREEN 2 3. RED 1 4. RED 2 5. BLUE 1 6. BLUE 2 7. ORANGE 1 8. ORANGE 2 9. MALLARD 10. GRAYSCALE 11. BLACK/WHITE

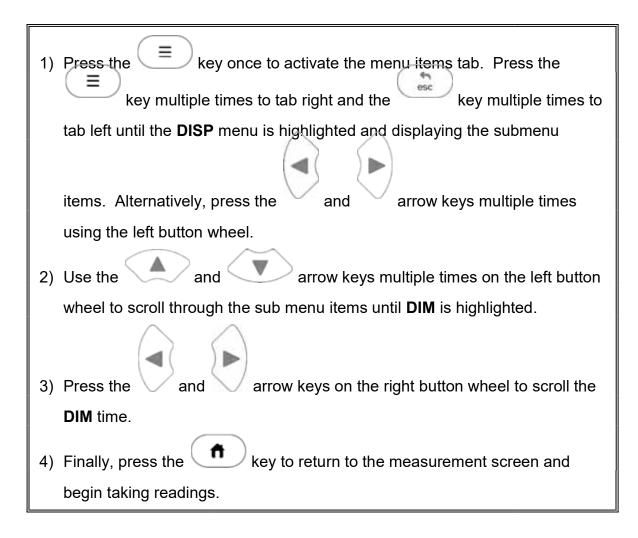


11.10 DIM

The *FX80* has a built-in **DIM** feature to manage power more effectively. This feature has adjustable time durations, until the power of the display is dimmed and current draw reduced. The timer is constantly reset while the user is making measurements, and is only activated when the gauge is idle for the duration of time the **DIM** value is set for. This feature does not override the preset 5 min idle power off feature in any way. However, if the gauge is turned on, set for a DIM of 120sec, and then left idle for 5 minutes, the *FX80* will dim in 2 minutes, then power off in 5 minutes. The procedures for adjusting the **DIM** time are outlined below:

For quick access and editing, refer to navigating the Hot Menus page 23.

<u>S</u>	etting a	a DIM time
	SET D	DISPLAY
VIEW		+RECT
DELA	/	0.378
RANGE		4.229
UNITS	3	IN
BRIG	ITNESS	15
COLOF	RS	GREEN 2
DIM		240 SEC
	<	MORE>
PRB	CAL	DISP TUNE



11.11 Graphics Option (look & feel)

The *FX80* includes a couple of cosmetic features for user preference when viewing the waveform. These features only serve as cosmetic items, and do not change the functionality of the *FX80* in any way.

RECT Wave:

The rectified wave feature, is only functional when using **RECT** wave view, and provides the user the following display options:

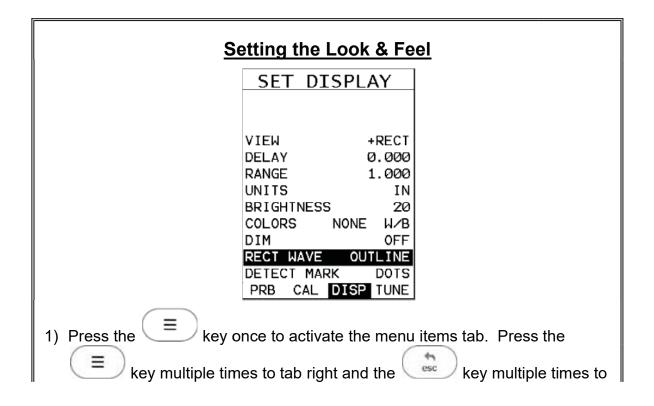
Outline – Draws the unfilled outline of the waveform.

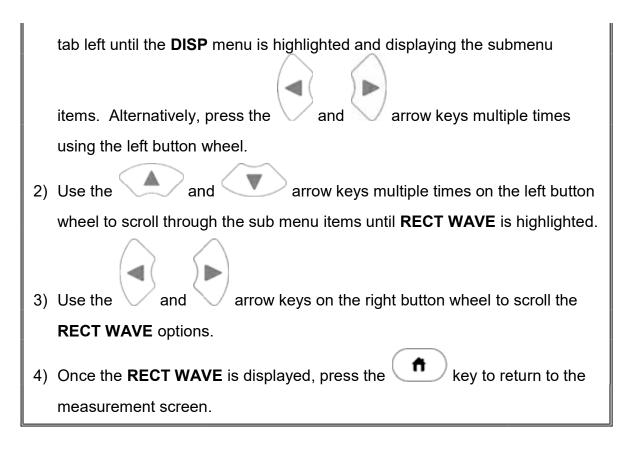
SET	DISPLAY	SP:1.018 ↓:0.2320 H: 77 ×
DELAY	0.378	
RANGE	4.229	RANGE 0.302
UNITS	IN	
BRIGHTNESS	15	GATE1 0.483 WIDTH1
COLORS	GREEN 2	
DIM	240 SEC	
RECT WAVE	OUTLINE	
	<more></more>	
PRB CAL	DISP TUNE	0.92 0.98 1.04 1.10 GN:22.0

Filled – Draws a filled version of the waveform.

SET DIS	SPLAY		SP:1.018 U:0.2320	H: 76%
DELAY	0.863			0.863
RANGE	0.302			RANGE 0.302
UNITS	IN			REF GAIN OFF
BRIGHTNESS	15			GATE1 0.483
COLORS	GREEN 2			WIDTH1
DIM	240 SEC			THRESH1
RECT WAVE	FILLED			
< MORE	>			
PRB CAL	DISP TUNE	0.92 (3.98 1.04 1.10	STEP: 1.0 GN:22.0

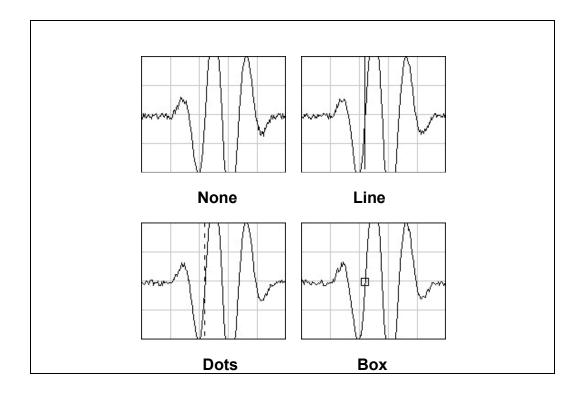
The procedure to select the look and feel option is outlined below:





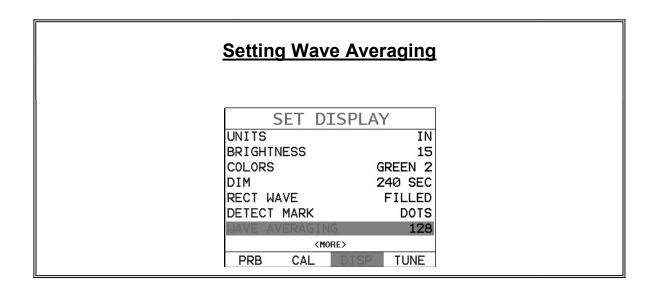
11.12 Detect Mark

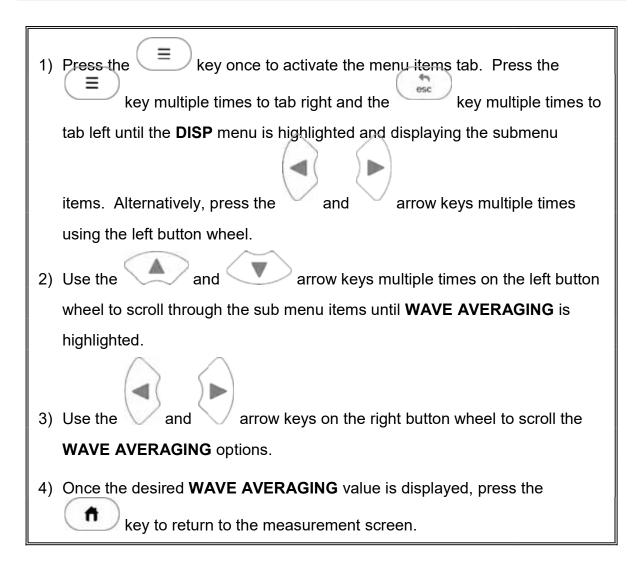
Another look and feel option of the *FX80* is the **DETECT MARK** feature. The detect mark give the user the option to select: **none**, **line**, **dots**, or **box**. Depending on the select made, an indication will be displayed on the waveform, showing where the detection is occurring. It should be noted that the "box" option will only be visible in **RF** view. The following screenshots illustrate the above selection options:



11.13 Wave Averaging

The *FX-81* has a wave averaging feature to improve the resolution or clarity of the waveform by averaging multiple shots/bangs and eliminating random noise. This feature is 'not' recommended for high speed scanning, as it slows down the screen redraw speed based on the number of averaging shots/bangs selected (OFF, 2, 4, 8, 16, 32, 64, 128). The procedure to change the averaging is outlined below:





11.14 Persistence

The *FX-81* has a persistence feature that is specifically used when connected to a multiple channel multiplexor and in Rectified display setting. The display is cleared based on the option selected, representing the overall number of bangs, to control the screen jitter. The setting options are (OFF, 15, 60, 240).

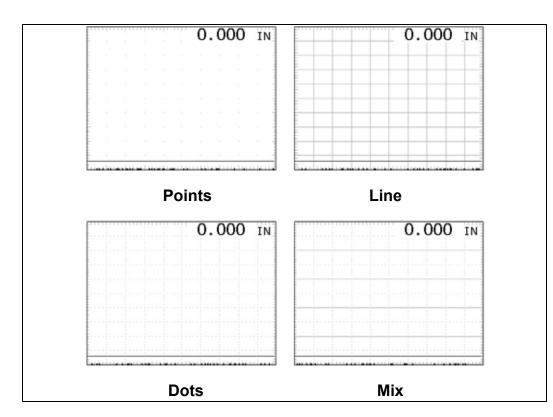
The procedures for selecting persistence are outlined below:

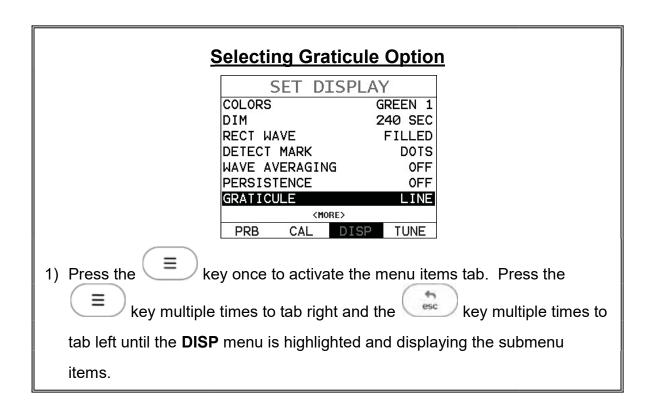
Persistence

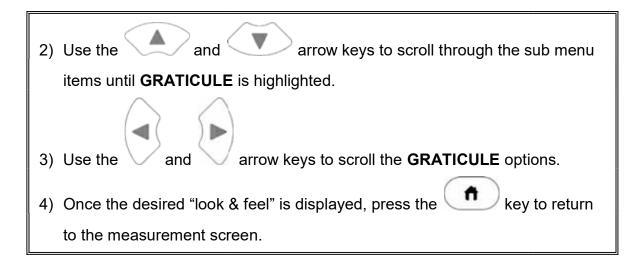
	SET DIS	PLAY	
	COLORS	GREEN 1	
	DIM	240 SEC	
	RECT WAVE	FILLED	
	DETECT MARK	DOTS	
	WAVE AVERAGING	OFF	
	PERSISTENCE	OFF	
	GRATICULE	LINE	
	<more></more>		
	PRB CAL	ISP TUNE	
1) Press the 🔳 ke	ey once to activate	the menu items	s tab. Press the
key multiple	times to tab right a	and the esc	key multiple times to
tab left until the DISF	• menu is hiahliaht	ed and displavir	na the submenu
	Å	\wedge	5
items. Alternatively,	press the 💛 an	d 💛 arrow k	eys multiple times
using the left button	wheel.		
2) Use the ar	nd varrow	keys multiple tir	mes using the left
·			
button wheel to scrol	I through the sub n	nenu items until	PERSISTENCE is
highlighted.			
3) Use the and	arrow keys m	ultiple times on t	he right button wheel
,	•	•	
to toggle PERSISTE	NCE (Off, 15, 60, 2	240).	
4) Press the 🔶 ke	ey to return to the r	neasurement so	creen.

11.15 Graticule (A-Scan Background)

The graticule markers in the background of the A-Scan waveform area provide measurement references for depth/thickness versus amplitude. There are multiple options for the user to select an A-Scan background grid/segments to satisfy their graphics preference or 'look and feel'. The procedure to select one of the options is outline below:



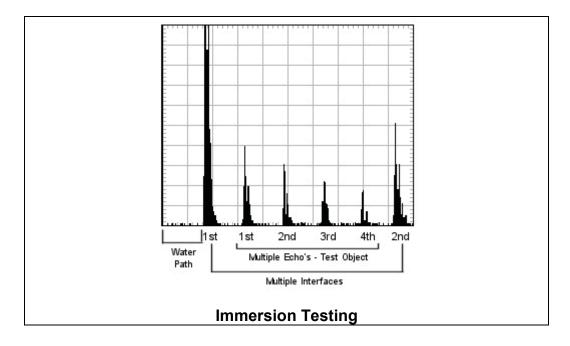




11.16 Auto Interface Gate – Immersion Testing (IM)

Immersion testing generally consists of a tank of water with the test object and transducers submerged in the tank with the transducer focused on the object, or using a "bubbler" with a constant water source and path. This procedure is advantageous in achieving a constant coupling during the scanning process, unlike standard manual contact scanning methods, and provides better control over amplitude fluctuations while attempting to estimate the size of a given reflector/flaw.

The *FX-81* is equipped with an additional gate to detect/trigger on the water path interface during the immersion inspection process. The start position, width and threshold of the gate can be configured for the interface echo to allow for deviations in the water path distance due to the surface condition, position and unwanted interface detections from the test object. The **IM** measure mode is similar to the standard interface-echo (I-E) mode generally found in precision thickness gauges to account for the length of the acrylic delay line material, when using a delay line style transducer.



Considerations:

- There is a significant difference between sound traveling in water versus steel, for example. The longitudinal velocity of sound traveling through water is approximately 0.058 in/µs, while 0.2320 in/µs in steel. Since the *FX80+* has been setup and calibrated for a steel test object, this would find the water path interface at approximately 4", considering an actual 1" water path, or 4 times the depth/distance on the calibrated display.
- It is recommended that the water path be greater than 25% of the thickness of the test object, and that the water path is long enough to keep the flaw evaluation process beyond the "near zone" and entirely in the "far zone" where sound has achieved the most uniform wave front (near zone will be contained in the water path).
- Additionally, any movements of the transducer or test object that change the water path distance are then compounded by a factor of 4x. Therefore, a mechanical fixture or carriage is typically used on the top side of the tank in order to maintain the positioning of the transducer to the test object.
- Changes in the targets angle and water path distance will reduce the amplitude/output, and should be considered during the evaluation of a flaw. Obviously, the optimal evaluation would be a perfectly fixed transducer position with a perfectly parallel reflector and water path distance.

The procedures for enabling and adjusting the IM measurement mode are outlined below:

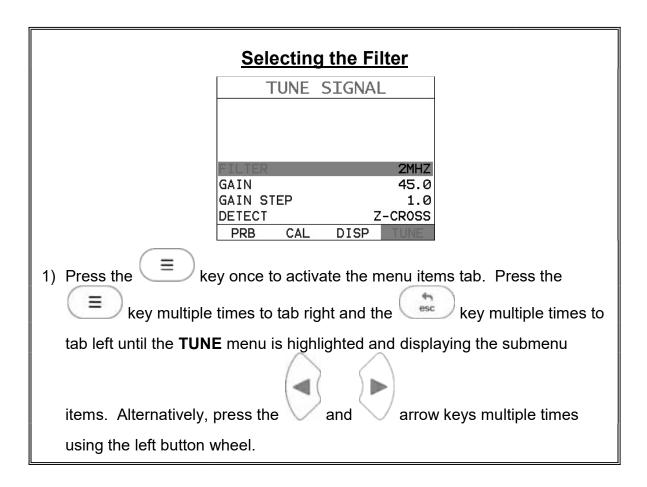
Activating the (IM) Mode	
TUNE SIGNAL	
FILTER 5MHZ	
GAIN 85.0	
GAIN STEP 1.0 DETECT Z-CROSS	
PRB CAL DISP TUNE	
1) Press the key once to activate the menu items tab. Press the	
\equiv key multiple times to tab right and the \equiv key multiple times t	D
tab left until the TUNE menu is highlighted and displaying the submenu	
items. Alternatively, press the \bigvee and \bigvee arrow keys multiple times	
using the left button wheel.	
2) Use the and arrow keys multiple times on the left butto	ו
wheel to scroll through the sub menu items until MEASURE MODE is	
highlighted.	
3) Use the \checkmark and \checkmark arrow keys on the right button wheel to toggle the	
MEASURE MODE.	
4) Once the desired MEASURE MODE is displayed , press the U key to)
return to the measurement screen.	

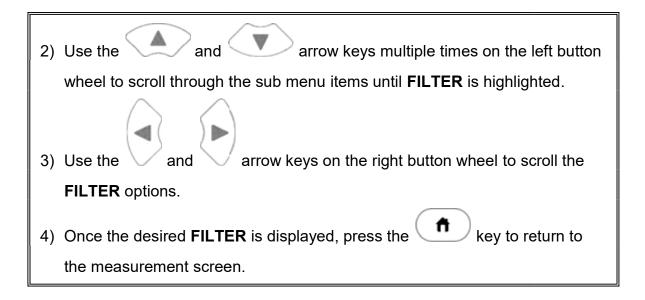
Note: Two gates will be enabled and can be adjusted using the Hot or Tabbed Gate menu items. Refer to section 4.4 to adjust and configure the postion of the gates.

11.17 Filters (Wide & Narrow Bands)

The *FX80* includes a wide band filter with a range of **1.8MHz** to **19MHz**, as well as narrow band filters at **1MHz**, **2MHz**, **5MHz** and **10MHz**. The *FX80+* has two additional narrow band filter at **0.5MHz** and **15MHz**. The wide band option is responsive to all signals within the given frequency range. However, narrow band filters eliminate signals outside of the target filter frequency, and focus on the output of the transducer at the specified frequency. The procedure to change the **FILTER** is outlined below:

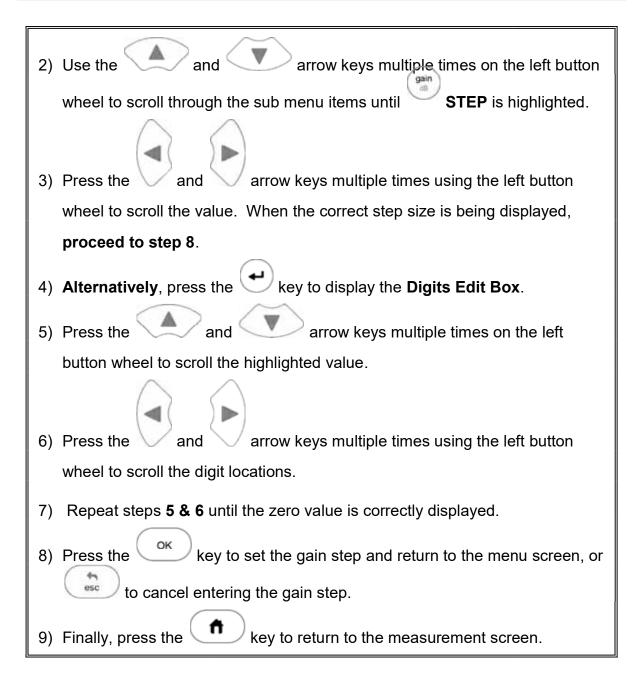
For quick access and editing, refer to navigating the Hot Menus page 23.





11.18 Gain Step Size

Adjusting Gain Step Size TUNE SIGNAL
FILTER 2MHZ GAIN 45.0 GAIN STEP 1.0 DETECT Z-CROSS PRB CAL DISP TUNE
1) Press the key once to activate the menu items tab. Press the key multiple times to tab right and the key multiple times to
tab left until the TUNE menu is highlighted and displaying the submenu
items. Alternatively, press the \checkmark and \checkmark arrow keys multiple times using the left button wheel.



11.19 Detect Modes

The *FX80* has three selectable modes of detection: Z-Cross, Flank, and Peak. The following diagram illustrates the difference between the options:

Refer to the diagrams above. The current polarity is positive, as shown by the position of the gate above the baseline:

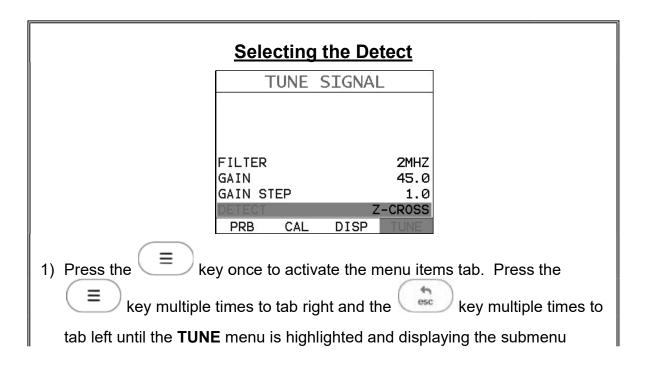
<u>Z-Cross</u>: The detection occurs as the first positive half cycle crosses the baseline and goes negative.

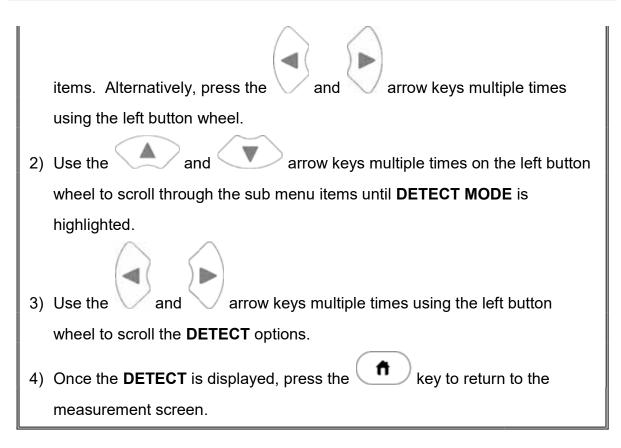
Flank: The detection occurs as the first half cycle left edge rises and breaks the threshold.

Peak: The detection occurs at the highest peak in the gate.

The procedure to select the **DETECT MODE** is outlined below:

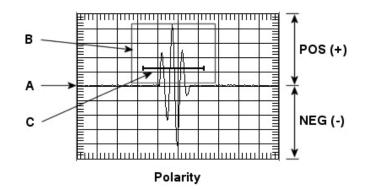
For quick access and editing, refer to navigating the Hot Menus page 23.





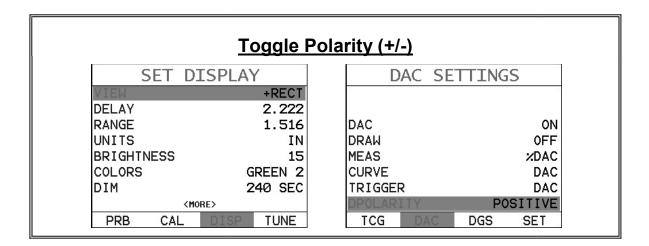
11.20 Polarity

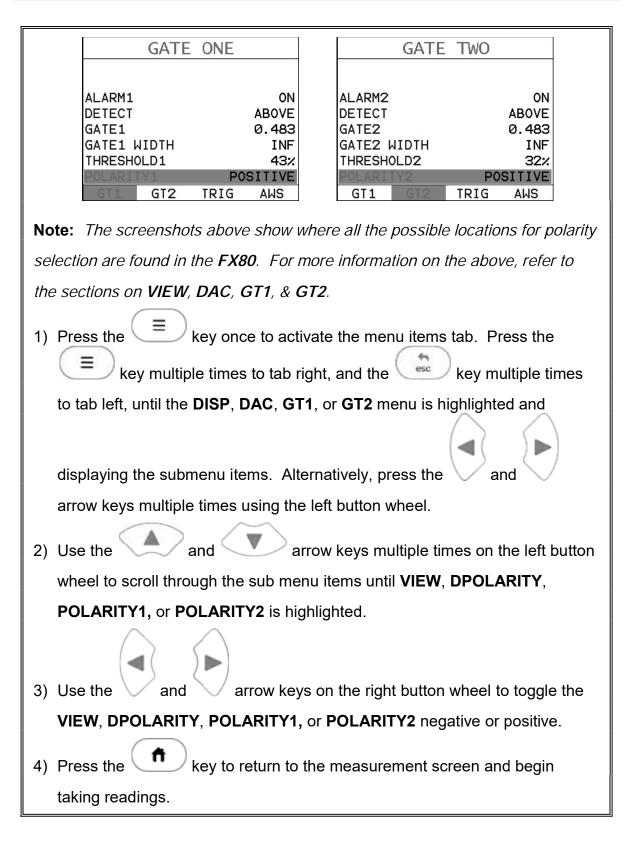
The *FX80* has a number of features and views that offer selectable polarity. The important thing to note is the polarity view is entirely different than the polarity selection of a gate. If a polarity view of **+RECT** is selected, only the positive portion of the waveform will be shown on the screen. If a positive polarity is then selected for **GT1**, not only will the gate be displayed on the screen, it will only detect on the positive going cycles of the waveform. Polarity is selectable according to the **VIEW**, **GT1**, **GT2**, and **DAC**. Again, view corresponds only to what portion of the waveform is displayed, positive or negative, and the other three options are primarily associated with where the detect occurs. Finally, if the view is set to **RF**, the entire waveform cycle will be displayed, both positive and negative. Refer to the diagram below:



The diagram above is an **RF** view, showing both the positive and negative going cycles for purposes of explanation. Notice the +/- positions in the diagram. The positive phase is everything above the horizontal center line, and the negative everything below the center line. The baseline is found at position (**A**), and considered zero dB. If **+RECT** was selected as the view, only the positive portion of the waveform would be displayed. Equally, if the gate polarity was set to positive, as in the diagram at (**C**), it would also appear on the display. However, if it was set to negative, would not appear on the display. In the example above, the gate is set to positive and will detect on the positive going waveform cycles shown in the box (**B**).

For quick access and editing, refer to navigating the Hot Menus page 23.





11.21 Compare

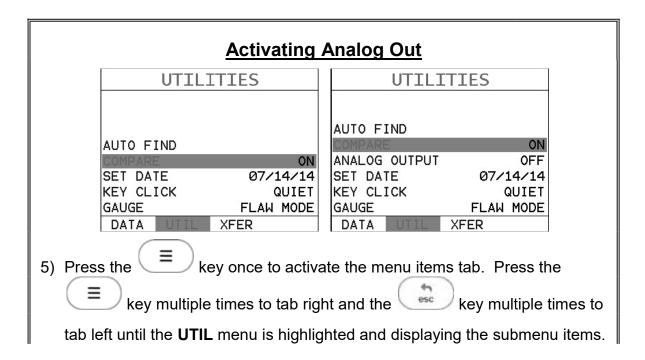
The compare feature enables an operator the ability to locate and establish a reference waveform from a flaw in an existing or manufactured sample and send it to the background on the display in a color other than the active waveform color. The reference waveform will remain in the background for the duration of inspection process, or until cleared. This feature can be useful when inspecting for a common flaw in a specific object, location, and position. The procedures for activating and using the compare feature are outlined below:

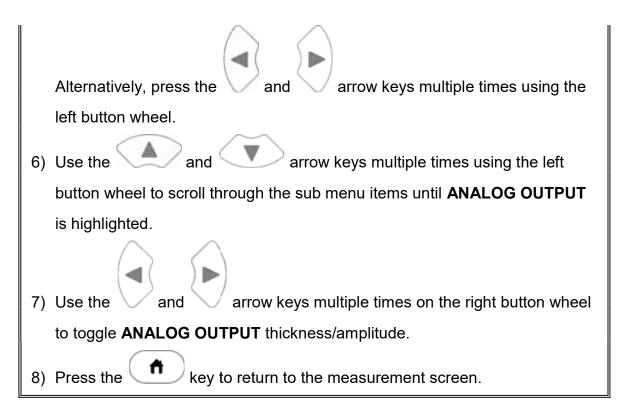
	Acti	vating and	Usi	ng Compar	<u>e</u>	
	UTILIT	IES		UTILI	TIES	
	AUTO FIND		AU.	O FIND	ON	
	COMPARE	ON	1222	LOG OUTPUT	OFF	
	SET DATE KEY CLICK	07/14/14 QUIET		DATE CLICK	07/14/14 QUIET	
	GAUGE	FLAW MODE	GAU		FLAW MODE XFER	
	DATA		07	TA UTIL	AFER	
1) Pres	<u>s</u> the (≡ key	once to activa	ate th	ne menu items	s tab. Press th	е
		mes to tab rigl	at ar	d the esc	kov multiple t	imoo to
		0			key multiple t	
tab le	eft until the UTIL n	nenu is highlig	hteo	and displayir	ng the submen	u items.
Alter	Alternatively, press the \bigvee and \bigvee arrow keys multiple times using the					ng the
left b	utton wheel.					
2) Use the and and arrow keys multiple times using the left						
butto	button wheel to scroll through the sub menu items until COMPARE is			5		
highl	ighted.					
3) Use	the 🗸 and 🔪	arrow keys	mult	iple times on t	the right buttor	n wheel
to to	to toggle COMPARE on/off. Note: The COMPARE feature now overrides				orrides	
the	key and it	s functions wh	ile a	ctivated.		

4) Press the key to return to the measurement screen.
5) Acquire the waveform of the sample flaw on the display, and press the key to freeze and send it into the background on the display in
another color. Pressing the reak key a second time to will clear the
waveform.
6) Finally, repeat steps 1 – 3 to disable the COMPARE feature.

11.22 Analog Output

The *FX-81* is also equipped with an analog outputs to send a 0-10 volt electrical signal to an external device to control a system process to respond in a different manner considering the voltage measured. The outputs are updated at the same rate as the PRF (pulse repetition frequency) setting. There is 100 ohm output impedance which will vary the voltage slightly and should therefore be calibrated to the device connected. The output options are amplitude or distance. Refer to the Top & Bottom end caps or connections on page 24 for further info on the pins used on the Lemo 1 5 pin connector. The procedures for activating and selecting amplitude or distance are outlined below:

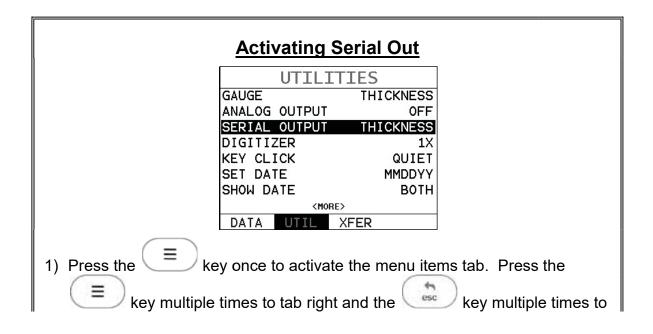


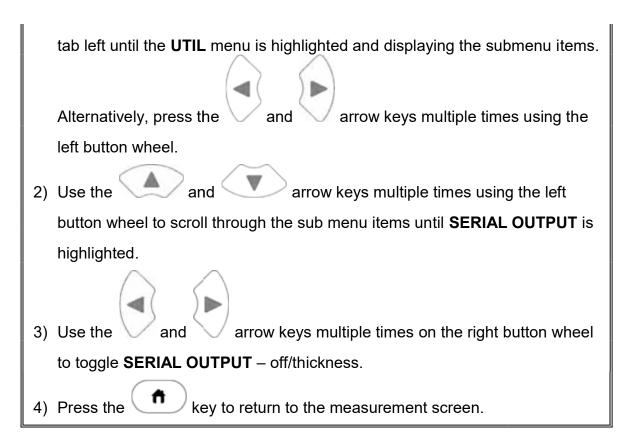


11.23 Serial Output

The *FX-81* is also equipped with a serial output that continuously sends the measurements to serial output port at a baud rate of 9600.

The procedure for activating the serial output are outlined below:





11.24 Digitizer

The *FX-81* is equipped with a selectable digitizer for additional resolution options. The 1x setting has the fastest update rate and lowest resolution, while the 4x option has 4 times the resolution and the slowest update rate.

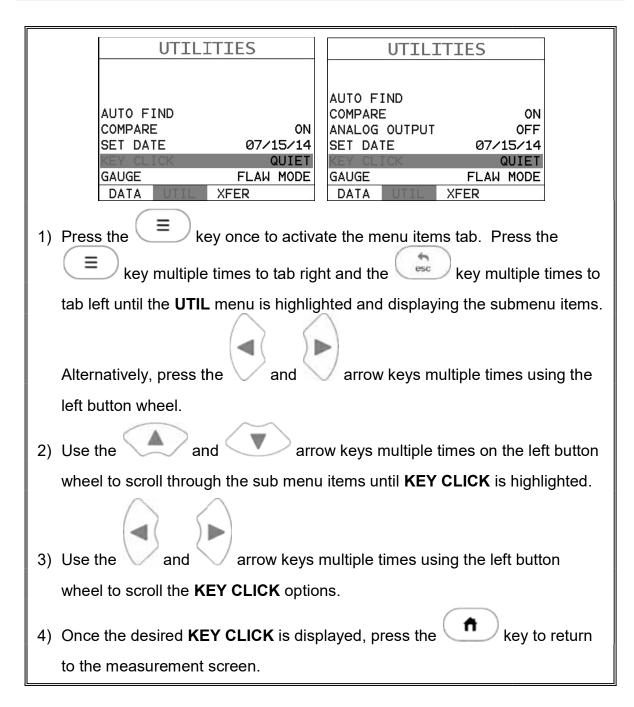
The procedure for selecting the digitizer setting is outlined below:



		TTEC]
	UTILI	OFF	-
	ANALOG OUTPUT	OFF	
	SERIAL OUTPUT	OFF	
	DIGITIZER	1X	
	SET DATE	MMDDYY	
	SHOW DATE	BOTH	
	KEY CLICK	QUIET	
	GAUGE	FLAW MODE	-
	DATA UTIL	XFER	
1) Press the 🔳	key once to activa	te the menu ite	ms tab. Press the
(≡) key multipl	e times to tab righ	it and the 🛄	key multiple times to
tab left until the UT	I menu is highlig	nted and displa	ying the submenu items.
		•	
Alternatively, press	the 🗸 and 🗸	arrow keys r	multiple times using the
left button wheel.			
2) Use the	ind v arro	w keys multiple	e times using the left
button wheel to scre	oll through the sub	o menu items u	ntil DIGITIZER is
highlighted.			
3) Use the and	arrow keys r	nultiple times c	on the right button wheel
,			0
to toggle the DIGIT	ZER (1X, 2X, 4X).		
4) Press the	key to return to the	e measurement	t screen.

11.25 Key Click

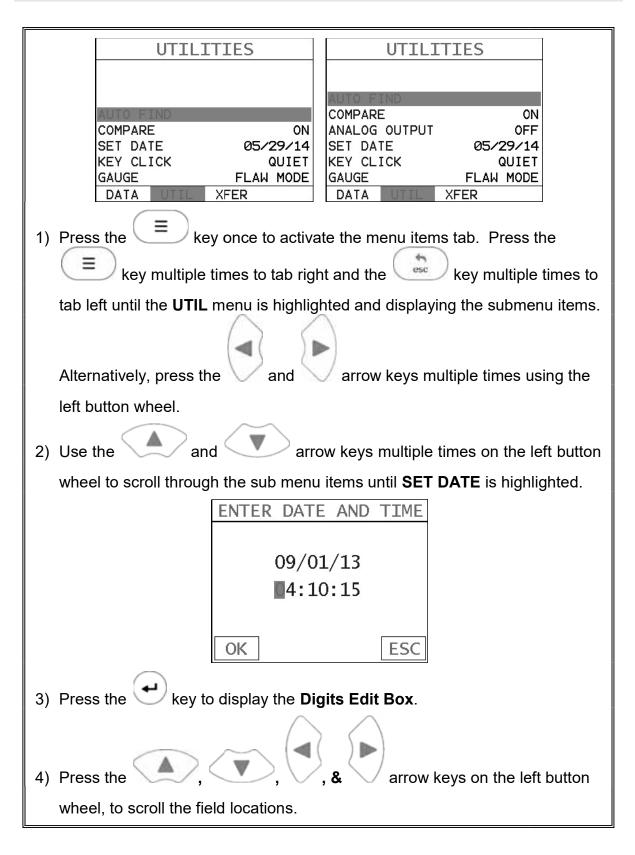
Selecting the Detect

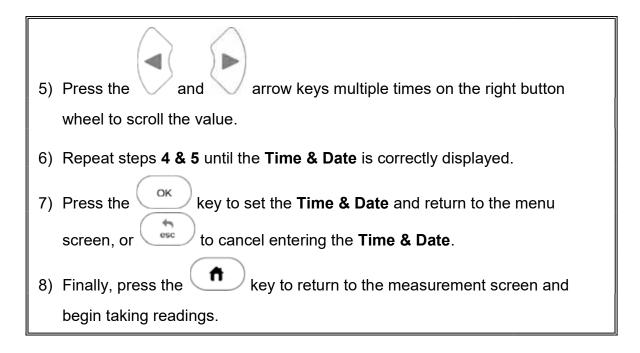


11.26 Date & Time

The *FX80* is equipped with an internal clock to time and date stamp the log, setup and screen capture files for reporting/documentation purposes. The procedures for setting the time and date are outlined below:



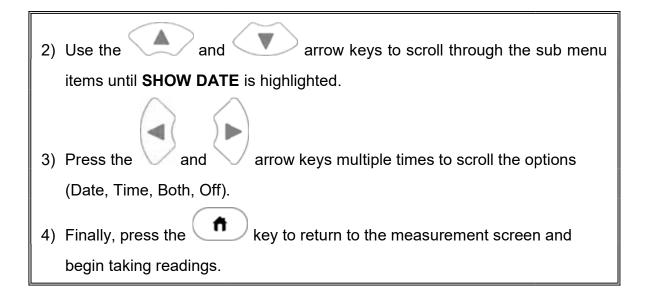




11.27 Show Date & Time

The *FX80* can be configured to show the date & time in the active A-Scan window as needed or preferred (off/date/time/both). The procedure for activating and displaying the above options are outlined below:

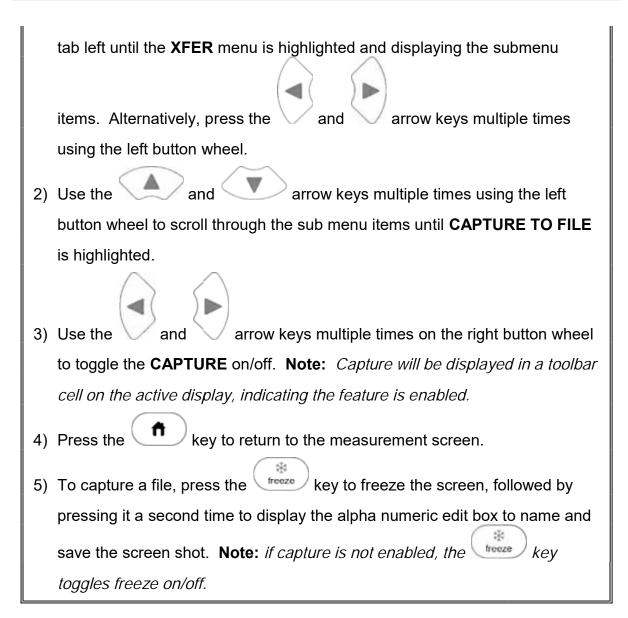
	Live Time &	& Date	
Γ	UTILIT	IES	
G	GAUGE	THICKNESS	
A	NALOG OUTPUT	OFF	
S	SERIAL OUTPUT	OFF	
	DIGITIZER	1X	
	KEY CLICK	QUIET	
-	SET DATE	MMDDYY	
	SHOW DATE	BOTH	
	<more></more>		
	DATA UTIL X	FER	
=	once to activate imes to tab right a	4	ms tab. Press the key multiple times to
tab left until the UTIL n	nenu is highlighte	d and display	ying the submenu items.



11.28 Freeze & Capture

The *FX80* freeze feature enables a user to immediately freeze what's currently being displayed on the screen for further review or analysis. The freeze feature used in conjunction with the capture feature enables a user to save the entire screen shot directly to a **.tif** (tagged image) file format that can be opened using any graphics viewer. With the storage capacity of the *FX80*, and additional external SD card reader, the user can store as many screens shots as needed. It should also be mentioned that this feature is immediately activated on boot up, therefore all the menus items, list boxes and edit screens can also be captured for presentation or training purposes. The procedure to freeze and capture the display is outlined below:

Capturing So	creen Shots	
DATA TR	RANSFER	
COPY SETUPS COPY DATA COPY SCREENS UPGRADE GAUGE CAPTURE TO FIN STORAGE ABOUT	LE YES INTERNAL DEV 0.03G	
DATA UTIL	XFER	
ey once to activa times to tab righ	-	ms tab. Press the key multiple times to



11.29 Capture Viewer

The capture viewer enables a user to view any of the saved screen captures on the SD card, using the *FX80*. This is handy if a PC isn't available, but the user has a need to review the screen shots captured.

The procedure to capture the last screen displayed is outlined below:

Capturing Screen Shots

	DATA TRANSFER
	BACKUP SETUPS COPY DATA
	COPY SCREENS UPGRADE GAUGE
	CAPTURE TO FILE ON
	CAPTURE VIEWER STORAGE INTERNAL
	ABOUT DEV 3.04K
	DATA UTIL XFER
1)	Press the \bigcirc key once to activate the menu items tab. Press the
	key multiple times to tab right and the key multiple times to
	tab left until the XFER menu is highlighted and displaying the submenu
	items. Alternatively, press the \bigvee and \bigvee arrow keys multiple times
	using the left button wheel.
2)	Use the and and arrow keys multiple times using the left
	button wheel to scroll through the sub menu items until CAPTURE VIEWER
	is highlighted.
	IMAGES
	1. 200.TIF 2. 201.TIF
	3. MAXII#1 .TIF 4. MAXII#2.TIF
	5. 202.TIF 6. 203.TIF
	7. 204.TIF 8. 205.TIF
	9. 210.TIF 10. 207.TIF
	11. 208.TIF 12. 211.TIF
3)	Press the vertex to display the list of images (.tif) currently stored on the
	internal or external SD card.
4)	Use the Arrow keys multiple times using the left
	button wheel to scroll through the list of images until the desired image is
	highlighted.

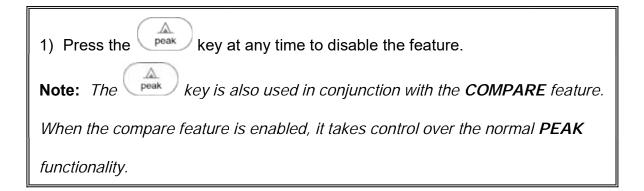
5) Press the explanation by the highlighted image, and the key to
close the image and return to the list of images.
 6) Repeat steps 4-5 as needed. 7) Finally, press the key to close the VIEWER and return the
7) Finally, press the T key to close the VIEWER and return the
measurement screen.

11.30 Peak Hold

The *FX80* includes a peak hold feature that draws and saves the maximum waveform amplitude on the screen. This allows an inspector to move the transducer in all directions, in an effort to "peak up" on a signal, and locate the maximum amplitude.

The following procure outlines the steps to activate and use the $\begin{pmatrix} A \\ P^{oak} \end{pmatrix}$ hold feature:

Activating Peak			
(A peak			
1) Press the key located in the upper left corner of the keypad to			
activate the feature.			
2) Press the key again at any time to toggle this feature OFF.			
Clearing Current Wave Draw			
Note: At any point during a PEAK scan the operator may opt to clear the wave			
drawing and start over.			
1) Press the key at any time to clear the currently displayed waveform,			
and continue the scanning process.			
Disabling PEAK			



11.31 Freeze Waveform

The *FX80* also includes a **FREEZE** mode that allows an operator the ability to freeze a the current waveform being display on the screen at anytime. Once the operator freezes the waveform, the transducer can be removed from the test material. The following procure outlines the steps to activate and use the FREEZE feature:

Activating Freeze
Note: Assuming the operator currently has a waveform on the display that
they'd like to freeze and have a closer look.
1) Press the several key located in the upper left corner of the keypad to
activate the feature.
2) Press the key again at any time to toggle this feature OFF.
Note: If the CAPTURE feature has been activated, pressing the key a
second time will capture the screenshot, and display the File Edit Box
enabling the user to name the captured file. The screen shot will be
captured as a "tagged interface format" (.tif), which can be opened directly
with any graphics file viewer.

CHAPTER TWELVE DATA STORAGE – SETUP, EDIT, & VIEW FILES

12.1 Introduction to Grid and Sequential file formats

The *FX80* is equipped with two data file format options, **GRID LOG** and **SEQ LOG**. The **GRID** file format is very similar to a spreadsheet format found in popular software programs like Excel. A **GRID** is simply a table of readings. A location in a grid is specified by giving a row and column coordinate. The rows are numbered from 1 to 999 and the columns are labeled from A to ZZ (999 Rows & 52 Columns). The sequential file format can be viewed as a file as a single column of up to 512 possible rows (readings), and a column of corresponding identifiers associated with each individual reading. The identifier can be a combination of up to 10 numeric, alpha, or special characters listed above, while the file name can consist of a combination of up to 20 of the same character set. **Note:** *The identifier cannot start or end with a special character.* Once a start and end ID are entered into the *FX80* and the log created, the *FX80* will automatically generate all the identifiers within that range.

The following character set listed below are all the allowable characters that will be used for both file formats: **GRID** & **SEQ** LOG. Any combination of these characters can be used for creating a Name and Note regardless of the selected format. The allowable characters are as follows:

Numeric characters: 0 - 9 Alpha Characters: A - ZSpecial Characters: $!' _ # space / . -()$

Multiple grids can be created and stored until the *FX80*'s memory is full. If the user attempts to store a new file in the *FX80* and the size of the file exceeds the capacity of memory, the *FX80* will respond with an error message indicating that the memory is unable to store the new file.

The *FX80* has a very large potential storage capacity, and depending on the configuration of SD card sizes versus data, setups and screen capture images, can store limitless amount of data. The *FX80* has an internal SD of 4 gigabytes, and an external slot reader that has been successfully tested with a 64 gigabyte card. Therefore, available memory will not be an issue.

In the sections that follow, the procedures for creating, using, and editing **GRID's** and **SEQ LOG's** have been combined together for the purpose of similarity in overall functionality and structure. The illustrations below are snapshots of typical **GRID** and **SEQ LOG** file formats:

Grid File Formats	

NAM	E: EX#	1		NAM	E: EXI	‡ 2	
	A	в	С		D	E	F
1				6			
2				7			
3				8			
4				9			

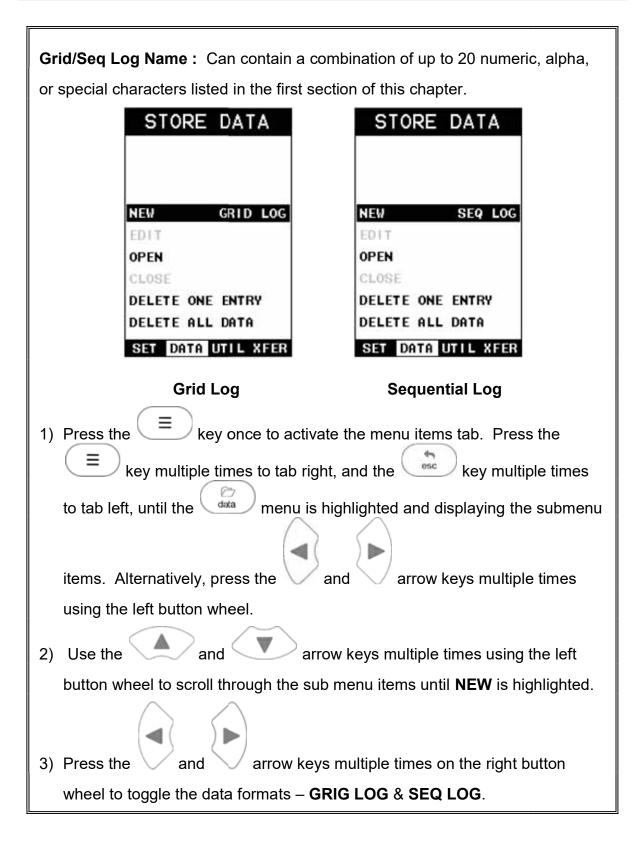
Seque	ential Log Formats
NAME: EX#1	NAME: EX#2
AA .	01
AB	02
AC	03
AD	04
AE	05
NAME: EX#3	NAME: EX#4
NAME: EX#3	BCD-4-01
3A	BCD-4-01
3A 3B	BCD-4-01 BCD-4-02

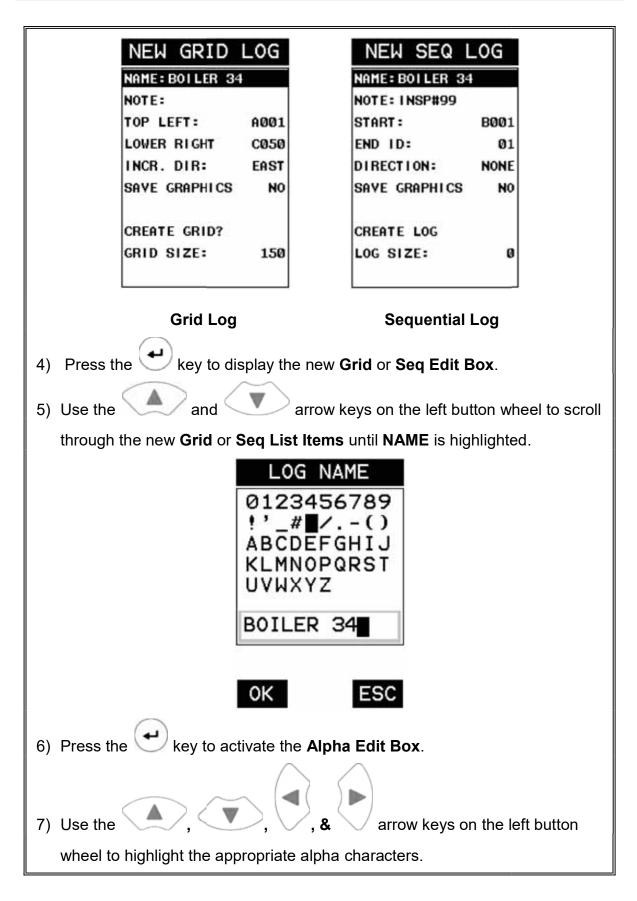
Important Note: For the duration of this chapter, all references to **GRIDS** and **SEQ LOGS** should be considered synonymous with references to **FILES**.

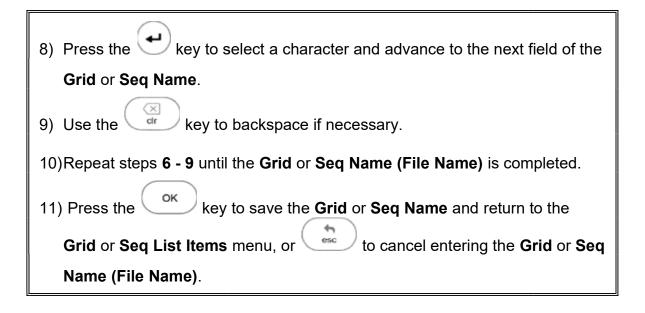
12.2 Creating a new Grid or Sequential Log (File)

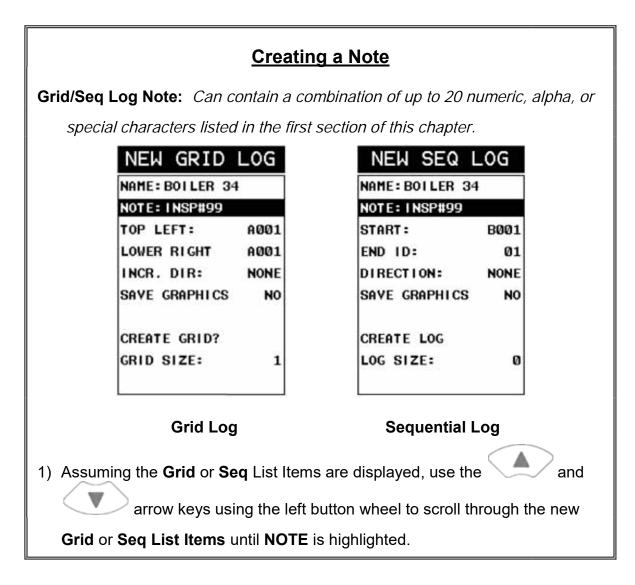
Important Note: *This entire section is a step by step guide to successfully create a grid or sequential log.* The instructions must be used in the sequential order specified, as follows:

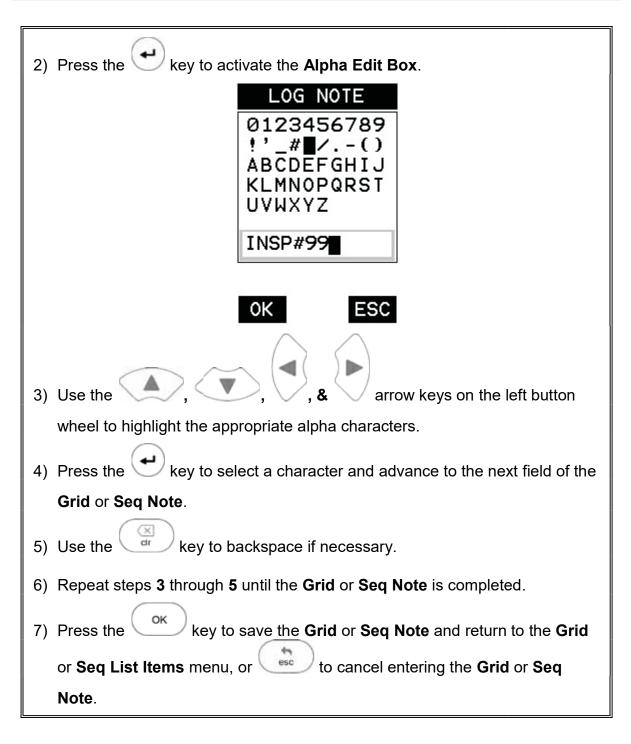
Creating a Name











Setting the Coordinates or Start & Stop ID's

Grid: A grid is defined by using coordinates to define the Top Left and theBottom Right corners of the grid. Alpha coordinates are horizontal across the

top, and numeric coordinates are vertical down the side. Therefore, to define the top left corner of the grid, there will be an (X,Y) coordinate. Where X is an alpha column location across the top and Y is a numeric row location down the side. Use the same logic when choosing the lower right corner. An individual grid can be up to 999 rows and 52 columns.

Sequential: The sequential file format can be viewed as a file as a single column of up to 512 possible rows (readings), and a column of corresponding identifiers associated with each individual reading. The identifier can be a combination of up to 10 numeric, alpha, or special characters listed above, while the file name can consist of a combination of up to 20 of the same character set. **Note:** *The identifier cannot start or end with a special character.* Once a start and end ID are entered into the *FX80* and the log created, the *FX80* will automatically generate all the identifiers within that range.

NAME: BOILER 34	i.
NOTE: INSP#99	
TOP LEFT:	A001
LOWER RIGHT	A001
INCR. DIR:	NONE
SAVE GRAPHICS	NO
CREATE GRID?	
GRID SIZE:	1

Grid Log

Setting the Top Left(Grid) or Start ID(Seq)

Sequential Log

NEW SEQ LOG

B001

NONE

01

NO

0

NAME: BOILER 34

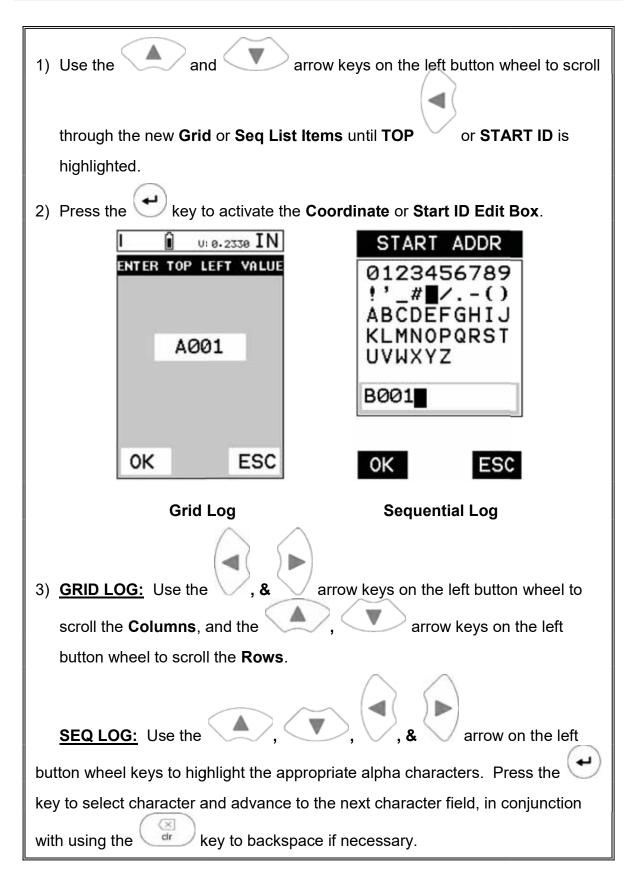
NOTE: Start:

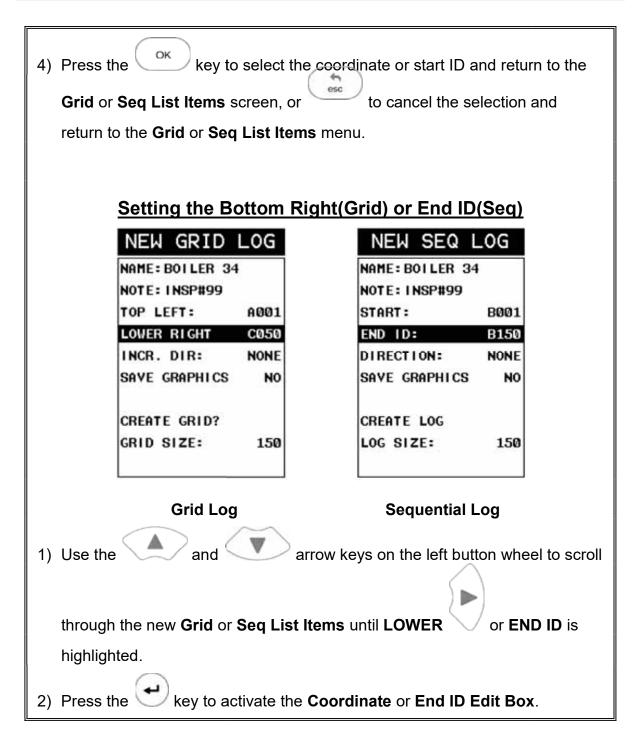
END ID:

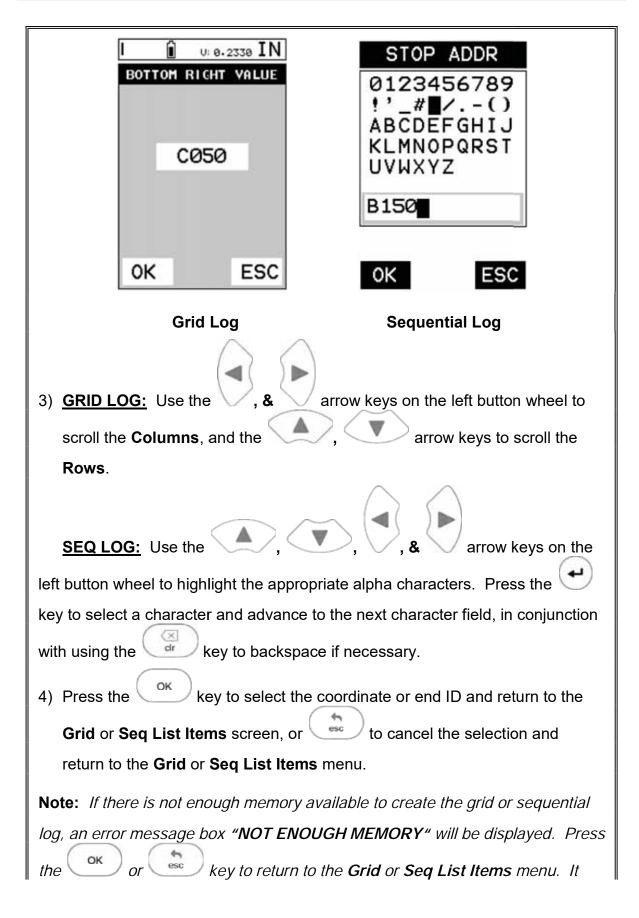
DIRECTION:

CREATE LOG

SAVE GRAPHICS



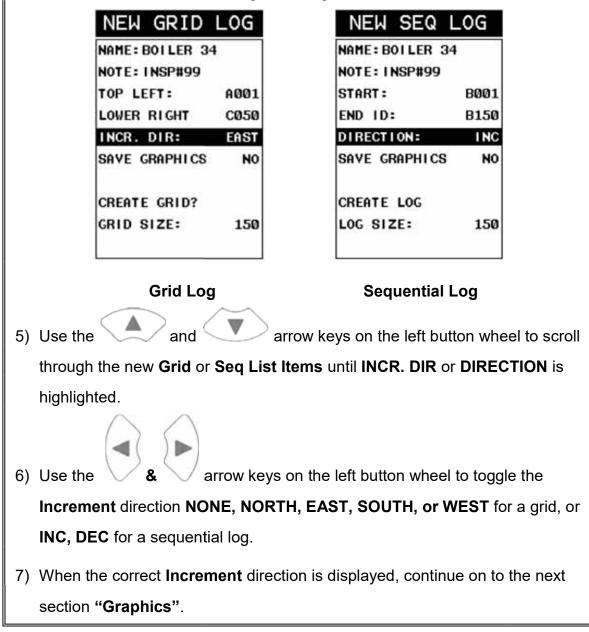


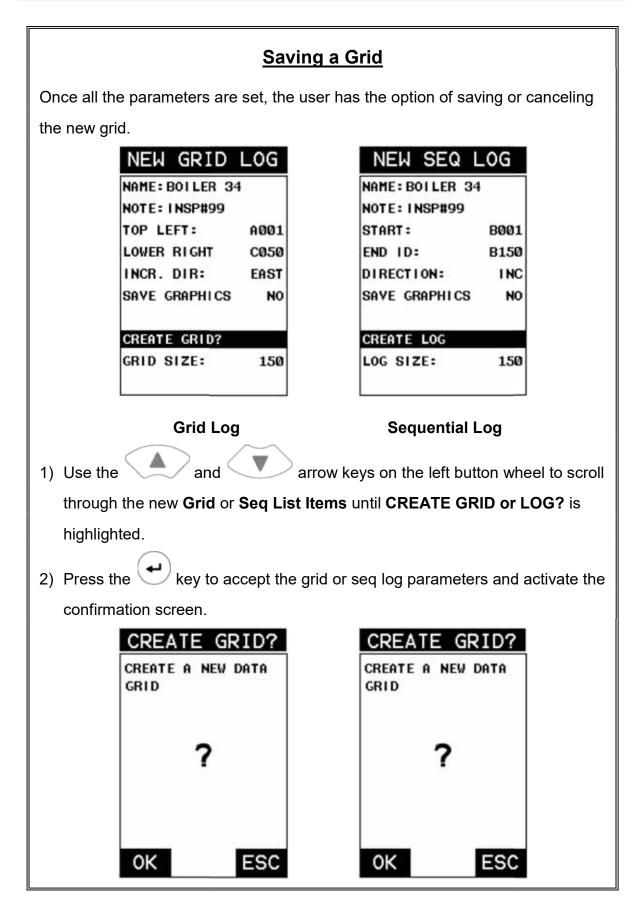


may be necessary to free some memory in the **FX80** at this time. Refer to page 154 for more information on **Deleting a File**.

Selecting the Auto Increment Direction

The **Auto Increment** feature gives the user the ability to specify which direction to advance the cursor after storing a reading.



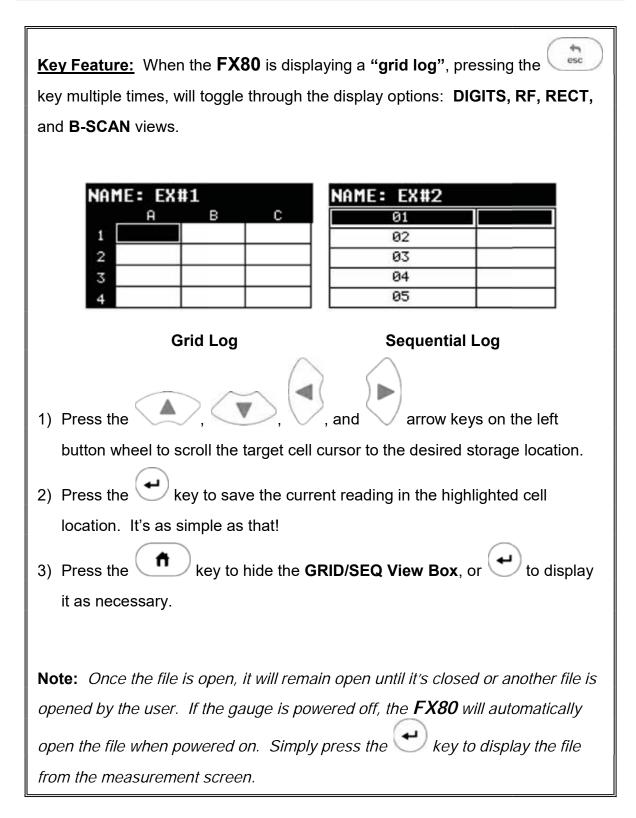


	Grid Log Seq	uential Log
3)	B) Press the οκ key to save the New Grid or S	eq Log, or the
	key to cancel the New Grid or Seq Log setup and	d return to the data
	menu.	
4)) Press the key to return to the measureme	ent screen and begin
	storing readings.	

12.3 Storing a waveform

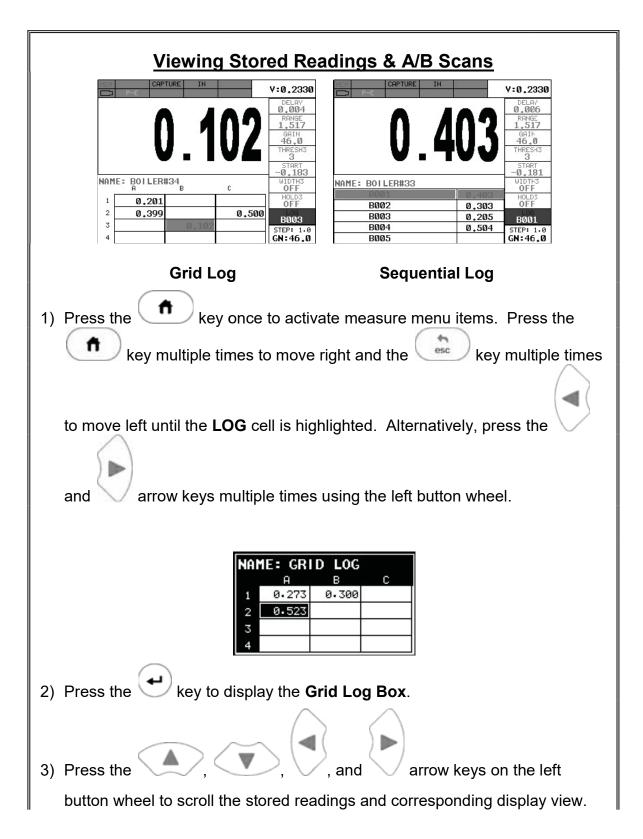
Now that a grid or sequential log has been created, it's time to make some measurements and store the readings. The following procedures outline this process:

Storing a Reading
Note: Once the gird or sequential log has been created it will automatically be
displayed following the create confirmation screen. It is located at the bottom of
the measurement screen, and can be left open for the duration of the inspection
process. This section assumes the grid or sequential log was just created.
Refer to the section on "opening a grid or seq log" if the file was created at
another time.
Key Feature: When the FX80 is displaying a "grid log", pressing the or
key will initiate an advance to row number option. Use the Left, Right,
, and arrow keys on the left button wheel to enter the row
number. Once the row number is correctly displayed, press the \bigcirc^{ok} key to
advance directly to that row number in the grid log.



12.4 Viewing stored readings

It is sometimes necessary to go back and view the stored readings and B-Scans using the *FX80* without a PC. The following procedures outline this process:

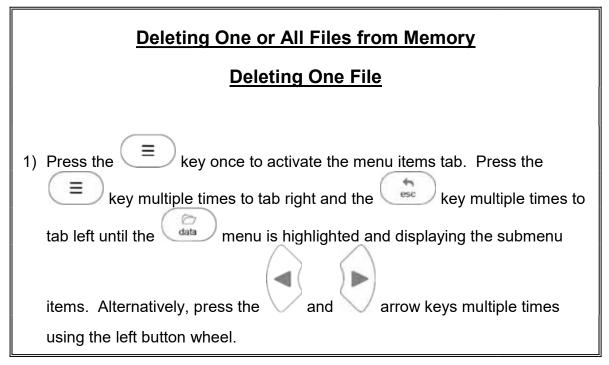


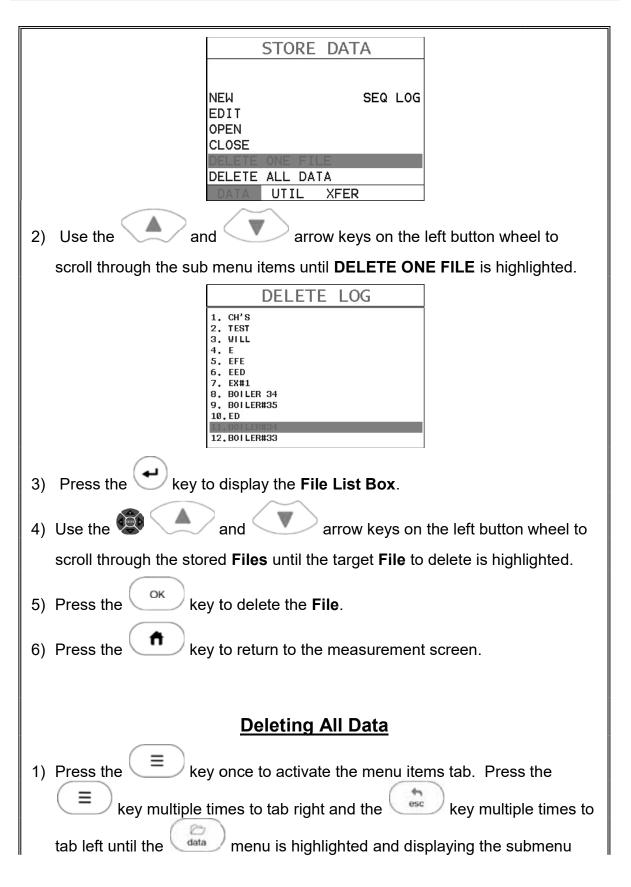
Notice as the cursor is moved to a different cell, the display will be updated with the display view saved with the reading. Readings stored in memory are indicated by displaying a **MEM** in the top left corner of the measurement screen.

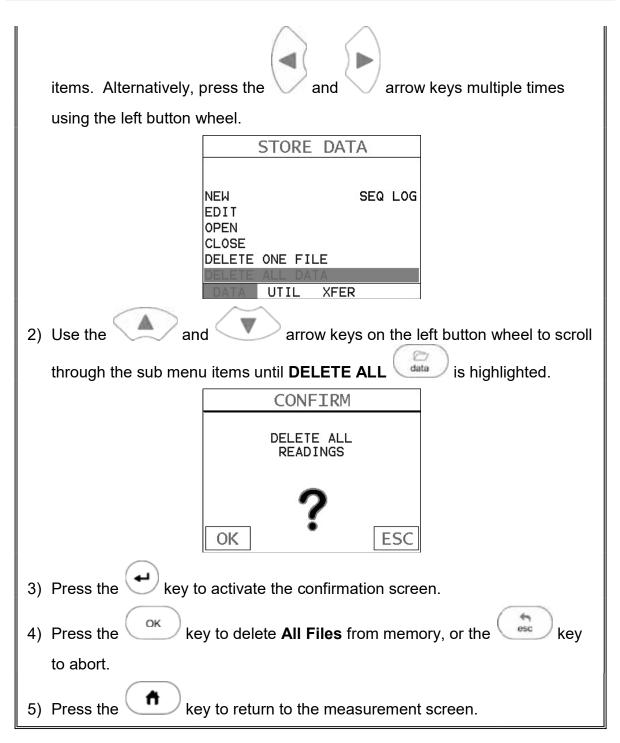
4) The user may opt to clear a specific reading and save a new one at any time. Press the key in the appropriate cell location to clear the reading, take a new measurement, and press the key to save the new reading.

5) Abort the **Grid/Seq Log View Box** by pressing the **1** key at any time.

12.5 Deleting Grids (Files)

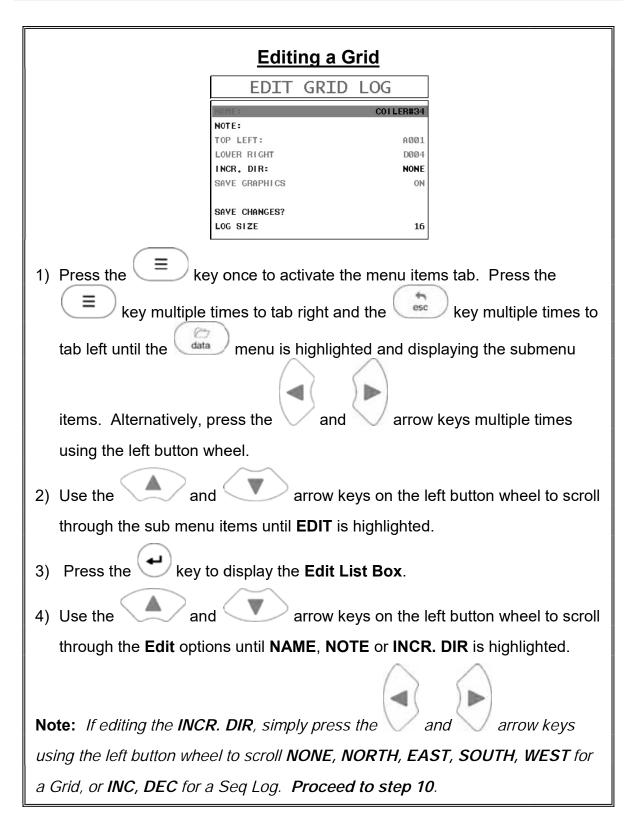


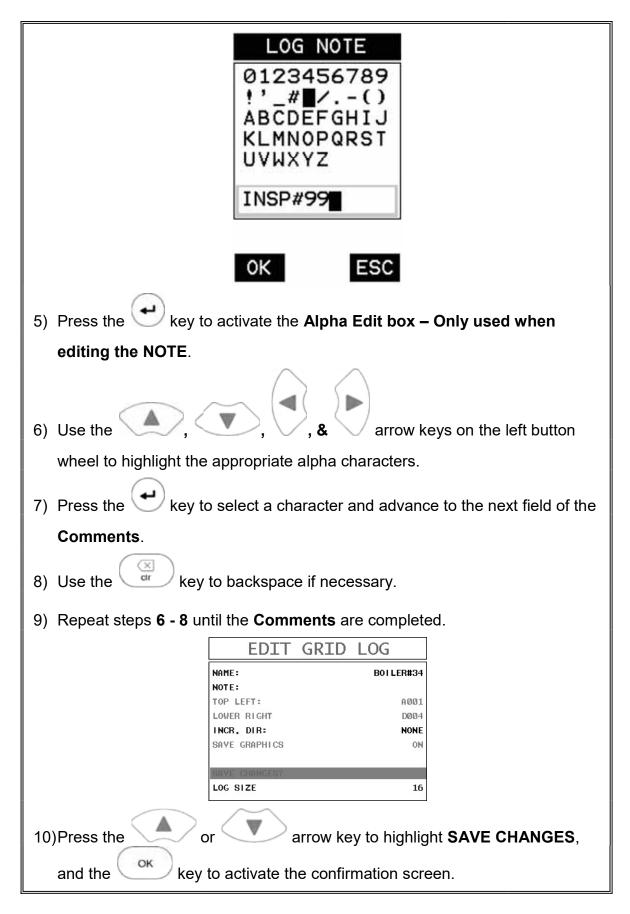


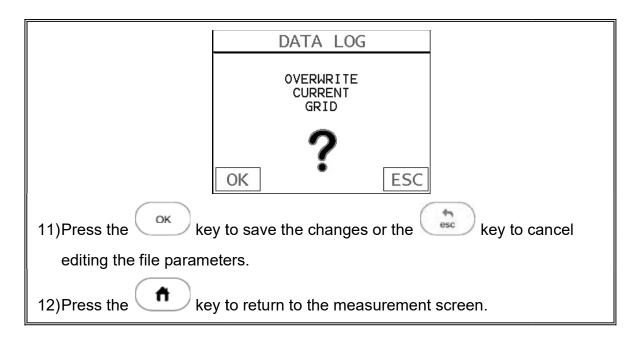


12.6 Editing a Grid (File)

Once a grid has been created and saved to memory, the user can edit the **Name**, **Comments**, or **Increment Direction** at a later time. The following procedures outline this process:

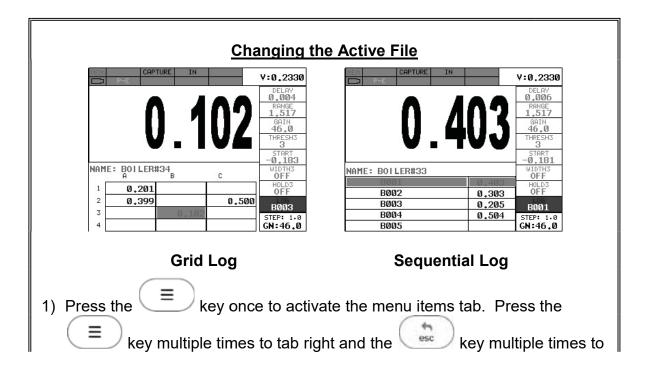


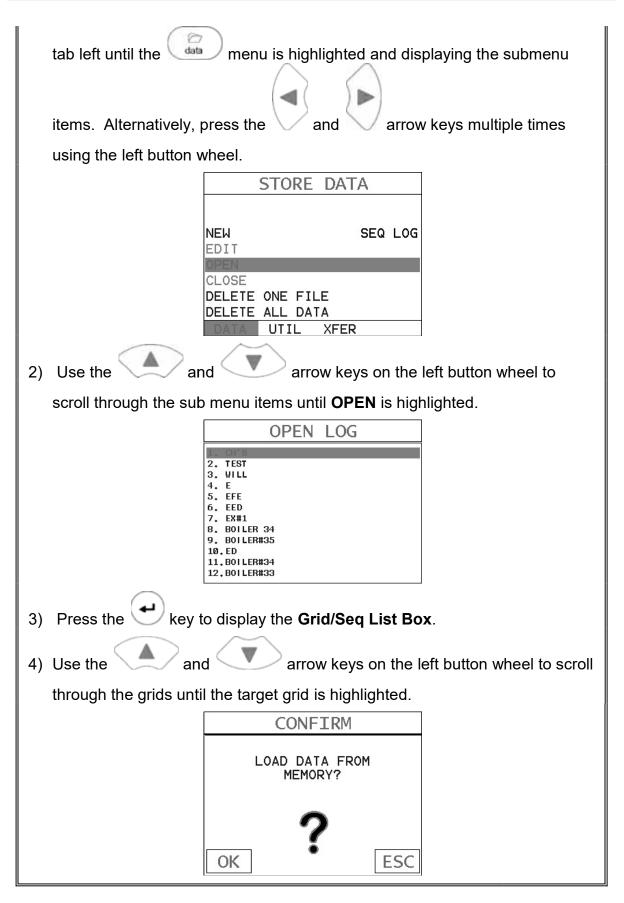


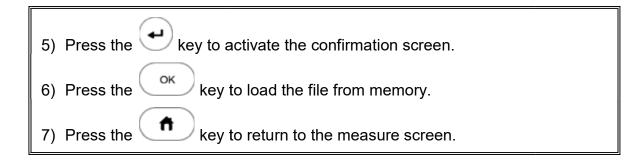


12.7 Changing the active File - Open

The user may have transferred grid/seq templates from a PC to the *FX80*, or setup grids/seq using the *FX80* at an earlier time. The name of the currently active file is always displayed at the top of the **Grid/Seq Box** in measurement mode (refer to photo below). It's not only important to recognize what file is currently active, but also be able to change the active file at any time. The following procedures outline this process:

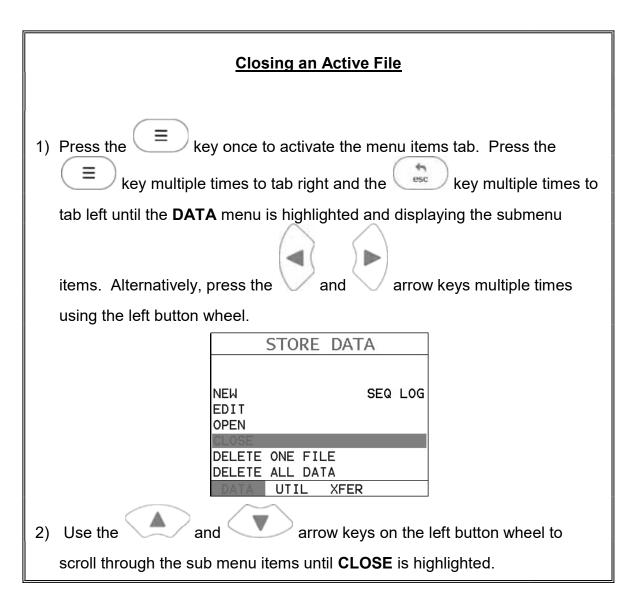






12.8 Closing an active File - Close

A user might not have a current requirement to store measurements, but a file is currently open or active and needs to be closed. The following procedures outline how to close an open or active file:



	STORE	DATA	
	NEW Edit	SEQ LOG	
	OPEN CLOSE DELETE ONE FI	LE	
	DELETE ALL DA	XFER	
3) Press the extremely key t	to close the acti	ve file. Note: /	Following the key press,
the CLOSE text will L	be grayed out in	dicating the file	has been closed and is
no longer active.			

CHAPTER THIRTEEN SETUPS – CREATE, STORE, EDIT, & RECALL

13.1 Introduction to Setups

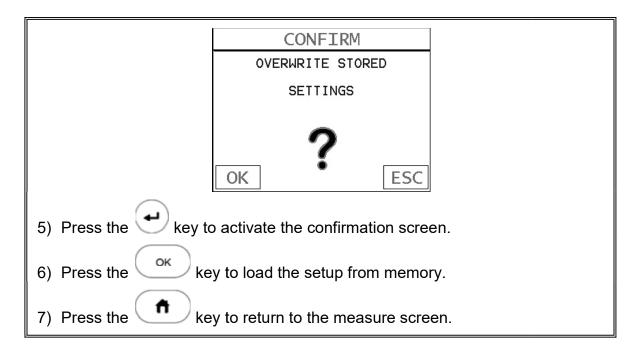
Often times, users are faced with a variety of tasks and applications that are sometimes similar, but can also be very different. Without the ability to save the individual calibrations and setups, the user would have to repeat the setup process on a regular basis for each individual application. This would become tedious rather quickly, especially considering the number of applications and potential calibration requirements for setup.

The increased number of features and parameters also adds to the overall setup time, or amount of time to set up marginal applications with perfection and understanding. Because of the additional time involved, the *FX80* has been equipped with the ability to save these setups to memory and be recalled at any time. The *FX80* can store up to **64 custom setups**. These setups can be bi-directionally transferred to and from a PC. Therefore, the user can save as many setups as necessary for all their individual applications requirements. This saves a great deal of time and knowledge for future inspections of the same job or project. This feature also eliminates error between two or more users during the setup and calibration process.

13.2 Opening a Setup

The *FX80* is loaded with a number of setups from the factory. These setups can be opened, edited, and saved to any one of **64 setup locations**. If a factory setup is written over, the user can simply reload the default factory setups at anytime using the utility software included with the *FX80*. The factory setups are general setups **Only**. However, they may serve as an excellent starting point, requiring only minor adjustments to work for custom applications. It is recommended that user customized setups be saved to an empty location, and save the factory setups for the purpose of a general starting point. The following procedures outline how to open factory and custom setups:

Opening a Setup
SETUP OPTIONS
OPEN
SAVE DELETE
DEFAULT SETUP
LANGUAGE ENGLISH GT1 GT2 GT3 SET
1) Press the E key once to activate the menu items tab. Press the
\equiv key multiple times to tab right and the key multiple times to
tab left until the SETUP menu is highlighted and displaying the submenu
items. Alternatively, press the \bigvee and \bigvee arrow keys multiple times
using the left button wheel.
2) Use the and and arrow keys on the left button wheel to
scroll through the sub menu items until OPEN is highlighted.
LOAD SETUP
1. EXAMPLE OF SETUP 2. TCG
3. 4. 5.
6. 7.
8. 9. 10.
11. 12.
 Press the extension with the setup List Box.
4) Use the and and arrow keys on the left button wheel to scroll
through the setups until the target setup is highlighted.



13.3 Saving a Setup

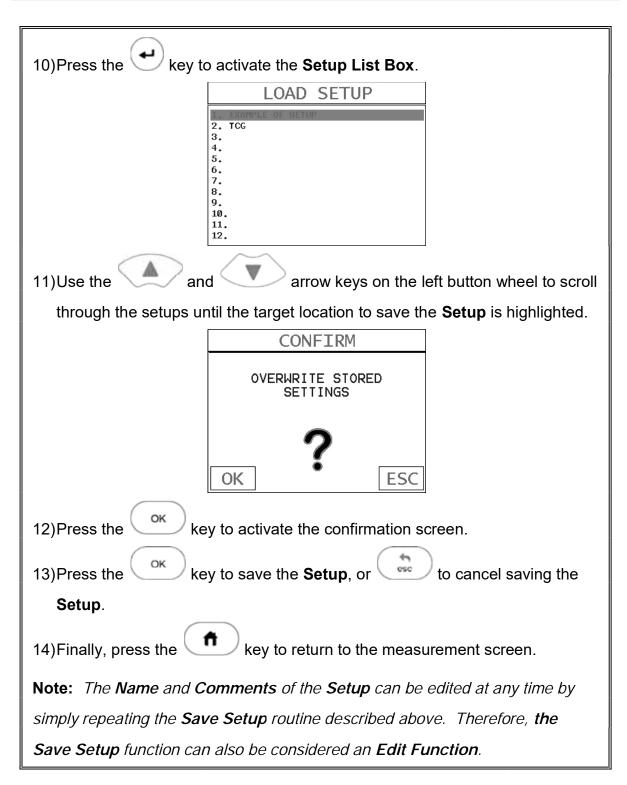
Once the *FX80* parameters and features have be adjusted for an application, the user may elect to save these setting to a specific setup location for future use. This can potentially save time and reduce error between users.

It is sometimes necessary to rename a previously saved setup, or add additional comments about a particular setup. The setup name may have been entered incorrectly, or the user needs to use the setup for a completely different project. An inspector's name or other comments about the project may also be required for additional documentation purposes. The following procedures outline the necessary steps for saving and editing a setup:

Saving a Setup	
SETUP OPTIONS	
OPEN SAVE DELETE	
DEFAULT SETUP LANGUAGE ENGLISH GT1 GT2 GT3 SET	

 Press the key once to activate the menu items tab. Press the key multiple times to tab right and the key multiple times to
tab left until the SETUP menu is highlighted and displaying the submenu
items. Alternatively, press the \bigvee and \bigvee arrow keys multiple times
using the left button wheel.
2) Use the and and arrow keys on the left button wheel to
scroll through the sub menu items until SAVE is highlighted.
SAVE SETUP SAVE SETUP
NAME: EX#1 NAME: EX#1
NOTE: NOTE: INSP#99
SAVE SETUP SAVE SETUP
3) Press the evice to display the Save Setup Parameters List Box.
4) Press the and and arrow keys on the left button wheel to
scroll the Name and Note parameters.

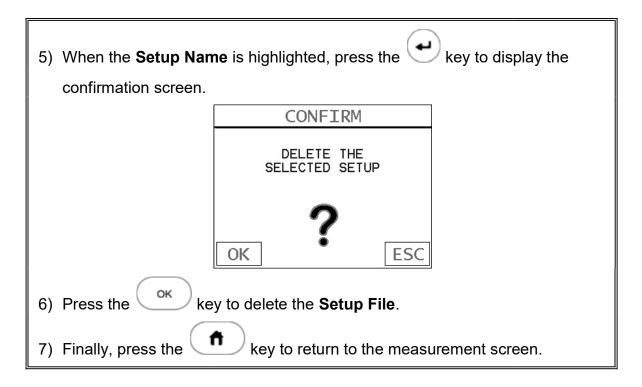
012345 !'_# ABCDEF	GHIJ QRST	SETUP 01234 !'_# ABCDE KLMNO UVWXY INSP#9	56789 /() FGHIJ PQRST Z
OK	ESC	ОК	ESC
5) When the parameter	to edit is highligh	ted, press the $igsidesigned$	🛃 key to activate the
Alpha Edit Box.			
6) Use the , wheel to scroll throug and the key .	to backspace thro	the ev to	ys on the left button o select characters, ters, until the Name or
7) Press the \bigcirc ke	y to return to the	Save Setup Pa	rameters List Box.
8) If both parameters wi	ll be edited. repe	at steps 4 – 7.	
-,	SAVE S		
	NAME: EX#1		
	NOTE: INSP#99		
	SAVE SETUP		
9) Use the and	d 💌 arrow	/ keys on the lef	t button wheel to scroll
, to and highlight SAVE		-	



13.4 Deleting a Saved Setup

This option allows a user to delete setup files that were previously saved and no longer needed. It's a simple feature to allow the user to do a bit of "house cleaning".

Deleting a Setup
SETUP OPTIONS
OPEN SAVE DELETE DEFAULT SETUP
LANGUAGE ENGLISH GT1 GT2 GT3 SET
1) Press the key once to activate the menu items tab. Press the
key multiple times to tab right and the key multiple times to
tab left until the SETUP menu is highlighted and displaying the submenu items. Alternatively, press the and and arrow keys multiple times
using the left button wheel.
2) Use the and and arrow keys on the left button wheel to
scroll through the sub menu items until DELETE is highlighted.
DELETE SETUP
1. EXAMPLE OF SETUP 2. TCG 3. 4. 5. 6. 7. 8. 9. 10. 11. 12.
3) Press the extreme to display the Setups List .
4) Press the Arrow keys on the left button wheel to
scroll to the Setup Name.



13.5 Using the Default Setup

The default setup feature was added to the *FX80* to use, as a last resort, if there are no setups stored in the gauge –factory or otherwise. The only time this might possibly occur is if the setup file in the *FX80* was somehow corrupted, and the user does not have access to a computer to re-load the factory setups back into the *FX80*. This gives the user the ability to load and modify a basic setup as follows:

Note: The default file contains no probe zero data. Therefore, a zero must be performed after loading. Also, the default setup can be loaded when using the flaw mode feature, to eliminate the probe zero delay value, and start at the initial pulse or zero.

Using the Default Setup			
	SETUP OPTIONS		
s	PPEN AVE DELETE DEFAULT SETUP		
L	ANGUAGE ENGLISH		
1) Press the key once to activate the menu items tab. Press the key multiple times to tab right and tab right			
tab left until the SETUP menu is highlighted and displaying the submenu items. Alternatively, press the and arrow keys multiple times			
using the left button wheel.			
2) the and arrow keys on the left button wheel to scroll			
through the sub menu items until DEFAULT SETUP is highlighted.			
3) Press the ev to load default DEFAULT SETUP .			
4) Finally, press the key to return to the measurement screen.			

13.6 Selecting a Language

The *FX80* is equipped with a language option. Currently, only a few languages supported. However, be sure to update your gauge firmware often, to check for language additions. The steps to select a language are outlined as follows:

	Selecting a Language			
	SETUP OPTIONS			
	OPEN			
	DELETE			
	DEFAULT SETUP			
	LANGUAGEENGLISHGT1GT2GT3SET			
1)	Press the key once to activate the menu items tab. Press the			
	\blacksquare key multiple times to tab right and the \blacksquare key multiple times to			
t	ab left until the SETUP menu is highlighted and displaying the submenu			
	items. Alternatively, press the \bigvee and \bigvee arrow keys multiple times			
l	using the left button wheel.			
2)	2) Use the and and arrow keys on the left button wheel to			
scroll through the sub menu items until LANGUAGE is highlighted.				
3)	3) Press the and arrow keys multiple times on the right button			
, I	wheel to toggle the language options.			
	Once the desired language is displayed, press the key to return to			
t	he measurement screen.			

CHAPTER FOURTEEN SOFTWARE, FILE TRANSFER, & UPGRADES

14.1 Computer System Requirements

DakView will run on many different operating systems: Windows XP, Windows 2000 Professional, Windows 2000 Server, Windows 2000, Vista, Windows 7, or Windows 8 Advanced Server operating systems running on Intel or AMD hardware.

A Pentium 166MHz or faster processor with at least 32 megabytes of physical RAM is required. You should have 40 megabytes of free disk space before attempting to install **DakView**.

USB Type1 to Type 2 Cable

If a replacement cable is needed, contact Dakota NDT (pt# N-606-0530).

14.2 Installing DakView

DakView comes on a CD-ROM with an automatic installer program. Place the CD in your computer's CD tray and close the door. Open the CD-ROM by double clicking on the My Computer ICON, then double click on the CD. Finally, double click on the **SETUP** icon to begin the installation.Refer to the help section in **DakView** software for the complete operating manual, setup, and operation.

14.3 Communicating with FX80

DakView will not directly communicate with the *FX80* series gauges. The *FX80* is equipped with USB, acting as a Thumb Drive (external storage device) when connected to a computer and powered on. Therefore, the SD memory card(s) can be opened as a drive with *directory structure, similar to the C: on your computer. The files stored on the internal SD*, or external SD reader, can be simply copied (dragged) into any folder on your PC and opened using **DakView**. The PC software will function on as a file viewer for the *FX80* series gauges.

Refer to the help section in **DakView** software for the complete operating manual, setup, and operation.

14.4 Using the XFER menu (FX80)

The **XFER** menu of the *FX80* will be used in conjunction with the **DakView** PC software. The steps below outline the procedure for accessing the **XFER** menu and basic operation as follows:

Accessing and Using the XFER Menu				
DATA TRANSFER				
CODV SETLIDS				
COPY DATA				
COPY SCREENS				
UPGRADE GAUGE CAPTURE TO FILE YES				
STORAGE EXTERNAL				
ABOUT DEV 0.05G				
DATA UTIL XFER				
1) Press the E key once to activate the menu items tab. Press the				
\blacksquare key multiple times to tab right, and the \frown key multiple times				
to tab left, until the XFER menu is highlighted and displaying the submenu				
items. Alternatively, press the \bigvee and \bigvee arrow keys multiple times				
using the left button wheel.				
2) Use the and and arrow keys on the left button wheel to scroll				
through the sub menu items until the desire option is highlighted.				
 Press the expression selected. 				

14.5 Selecting Storage Device

The *FX80* has two storage device options available. The *FX80* is shipped from the factory with a 4 gig internal SD memory card on the board itself, and additionally has an external SD card reader. The SD reader is located above the Li-lon battery pack, under the battery cover. The **STORAGE** utility simply selects which card is currently being used as the primary storage device. This storage switch is also used in conjunction with all the copy utilities found in the **XFER** menu. For example; if the

storage switch is set to internal as the primary storage device, all the copy routines will copy from the internal to the external reader, or visa versa. The procedure to set the storage device is outlined below:

Selecting Storage Device					
DATA TRANSFER	SET STORAGE TO:				
COPY SETUPS COPY DATA COPY SCREENS UPGRADE GAUGE	INTERNAL REQUIRES FULL RESTART. SAFELY REMOVE FROM PC. SHUTDOWN NOW				
CAPTURE TO FILE YES STORAGE EXTERNAL ABOUT DEV 0.03G DATA UTIL XFER	? ЕSC				
1) Press the key once to activate the menu items tab. Press the key multiple times to tab right and tab key multiple times to tab key					
tab left until the XFER menu is highlighted and displaying the submenu items. Alternatively, press the and arrow keys multiple times					
using the left button wheel.					
2) Use the and and arrow keys multiple times using the left					
button wheel to scroll through the sub menu items until STORAGE is					
highlighted.					
3) Use the and arrow keys r	nultiple times on the right button wheel				
to toggle STORAGE internal/external. Note: Capture will be displayed in a					
toolbar cell on the active display, indicating the feature is enabled.					

14.6 Copying Files (Setups, Data, & Screenshots)

The *FX80* can store a number of setup, data and screenshot files to either the internal or external SD memory cards. All the copy routines will copy files from the currently selected storage device to the other. Therefore, if the current storage device is set to 'internal', the copy routines will transfer files directly to the external device. Note: *If the FX80 is powered up without an external SD card inserted in the slot, the copy routines in the XFER menu will be inactive.* The steps below outline the procedure for copying files from one storage device to the other as follows:

Copying Files Between Storage Devices			
	DATA TRANSFER		
	COPY SETUPS COPY DATA COPY SCREENS UPGRADE GAUGE CAPTURE TO FILE YES STORAGE EXTERNAL ABOUT DEV 0.03G		
	DATA UTIL XFER		
 Press the key once to activate the menu items tab. Press the key multiple times to tab right and the key multiple times to 			
tab left until the XFER menu is highlighted and displaying the submenu			
items. Alternatively, press the \checkmark and \checkmark arrow keys multiple times			
using the left button wheel.			
2) Use the an	arrow keys on the left button wheel to scroll		
through the sub menu items until the desired COPY option is highlighted.			

SCREEN LIST				
ALL SCREENS				
BELECT A SCREENS				
) Press the ev to display the Setups/Data/Sceens List.				
) Use the Arrow keys on the left button wheel to				
highlight the desired List Box option.				
FILE LIST				
1. PIC#2				
2. PIC#3 3. PIC#4 4. PIC#5				
5) Press the either transfer ALL files, or display the Individual				
List of files.				
6) Use the Arrow keys on the left button wheel to scroll				
through the list of files and select the specific file to copy.				
7) Press the event to complete the Copy process, followed by pressing the				
key to display the List Box .				
8) Repeat steps 6 & 7 to copying additional individual files.				
9) Finally, press the \bigcirc key to return to the measurement screen.				

14.7 Upgrading the FX80

The *FX80* can be upgraded to the latest revision of firmware at any time. Simply download the latest version posted on the Dakota NDT website, copy the upgrade file to the main drive directory *FX80*, and use the upgrade utility located in the **XFER** menu. The process is very easy and convenient, allowing our users to stay current with updated feature additions and bug fixes. The procedure to upgrade your *FX80* is outlined below:

Upgrading the Firmware					
DATA TRANSFER	UPGRADE GAUGE				
COPY SETUPS COPY DATA COPY SCREENS	LOAD FILE DFX8_GAUGE TO FLASH				
CAPTURE TO FILE YES STORAGE EXTERNAL ABOUT DEV 0.03G DATA UTIL XFER	OK ESC				
1) Press the key once to activate the menu items tab. Press the key multiple times to tab right and tab key multiple times to tab key					
tab left until the XFER menu is highlighted and displaying the submenu					
items. Alternatively, press the \bigvee and \bigvee arrow keys multiple times					
using the left button wheel.					
 Press the experimentation screen, followed by pressing key to start the upgrade process. Note: The FX80 will 					
power down during the upgrade process, and restart when completed.					

APPENDIX A -VELOCITY TABLE

Material	L-Wave	L-Wave	S-Wave	S-Wave
	velocity	velocity	Velocity	Velocity
	in/µs	m/s	in/µs	in/µs
Aluminum	0.2510	6375	.1240	3130
Beryllium	0.5080	12903	.3500	8880
Brass	0.1730	4394	.0830	2120
Bronze	0.1390	3531	.0880	2235
Cadmium	0.1090	2769	.0590	1500
Columbium	0.1940	4928	.0830	2100
Copper	0.1830	4648	.0890	2260
Glass (plate)	0.2270	5766	.1350	3430
Glycerine	0.0760	1930	-	-
Gold	0.1280	3251	.0470	1194
Inconel	0.2290	5817	.1190	3020
Iron	0.2320	5893	.1270	3230
Cast Iron	0.1800	4572	.08701260	2200-3220
Lead	0.0850	2159	.0280	700
Magnesium	0.2300	5842	.1200	3050
Mercury	0.0570	1448	-	-
Molybdenum	0.2460	6248	.1320	3350
Monel	0.2110	5359	.1070	2720
Nickel	0.2220	5639	.1170	2970
Nylon	0.1060	2692	.0430	1090
Platinum	0.1560	3962	.0660	1670
Plexiglas	0.1060	2692	.0500	1270
Polystyrene	0.0920	2337	-	-
PVC	0.0940	2388	.0420	1060
Quartz glass	0.2260	5740	.0870	2210
Rubber	0.0910	2311	-	-
vulcanized				
Silver	0.1420	3607	.0360	1590
Steel (1020)	0.2320	5893	.1280	3240
Steel (4340)	0.2330	5918	.1280	3240

Steel Stainless"	0.2230	5664	.1230	3120
Teflon	0.0540	1372	.2500	6350
Tin	0.1310	3327	.0660	1670
Titanium	0.2400	6096	.1230	3120
Tungsten	0.2040	5182	.1130	2870
Uranium	0.1330	3378	.0780	1980
Water	0.0580	1473	-	-
Zinc	0.1660	4216	.0950	2410
Zirconium	0.1830	4648	.0890	2250

APPENDIX B -SETUP LIBRARY

Num	Name	Comment 1	Gn/AGC	Velocity
1	Enter Custom Name			
2				
3				
4				
5				
6				

WARRANTY INFORMATION

• Warranty Statement •

Dakota NDT warrants the *FX80* against defects in materials and workmanship for a period of two years from receipt by the end user. Additionally, Dakota NDT warrants transducers and accessories against such defects for a period of 90 days from receipt by the end user. If Dakota NDT receives notice of such defects during the warranty period, Dakota NDT will either, at its option, repair or replace products that prove to be defective.

Should Dakota NDT be unable to repair or replace the product within a reasonable amount of time, the customer's alternative exclusive remedy shall be refund of the purchase price upon return of the product.

• Exclusions •

The above warranty shall not apply to defects resulting from: improper or inadequate maintenance by the customer; unauthorized modification or misuse; or operation outside the environmental specifications for the product.

Dakota NDT makes no other warranty, either express or implied, with respect to this product. Dakota NDT specifically disclaims any implied warranties of merchantability or fitness for a particular purpose. Some states or provinces do not allow limitations on the duration of an implied warranty, so the above limitation or exclusion may not apply to you. However, any implied warranty of merchantability or fitness is limited to the five-year duration of this written warranty.

This warranty gives you specific legal rights, and you may also have other rights which may vary from state to state or province to province.

Obtaining Service During Warranty Period

If your hardware should fail during the warranty period, contact Dakota NDT and arrange for servicing of the product. Retain proof of purchase in order to obtain warranty service.

For products that require servicing, Dakota NDT may use one of the following methods:

- Repair the product
- Replace the product with a re-manufactured unit
- Replace the product with a product of equal or greater performance
- Refund the purchase price.

• After the Warranty Period •

If your hardware should fail after the warranty period, contact Dakota NDT for details of the services available, and to arrange for non-warranty service.